

Task Oriented Practice
(TOP)

SWITCHING NETWORK

4 ESTM SWITCH

Issue 6	JAN 1997
234-151-011	TPG
TITLE PAGE	000

FIND YOUR JOB IN THE LIST BELOW THEN GO TO

Acceptance NTP-002
 Automatic Power Monitor Failure – Clear TAP-129

 Circuit Pack – Replace DLP-500
 Converter (245A With 245A); Bulk – In SD-4A087-01 Frame – Replace NTP-004
 Converter (245C With 245C); Bulk – In SD-4A087-01 Frame – Replace NTP-005
 Converter (245A With 245C); Bulk – In SD-4A087-01 Frame – Replace NTP-006
 Converter (245C With 245A); Bulk – In SD-4A087-01 Frame – Replace NTP-007
 Converter; Non-Bulk – Replace DLP-511
 Capacitor; Filter – Replace DLP-524

 Demand Diagnostic Phase 9 – Perform NTP-003
 Diagnostic Failure By Analyzing Raw Data and Replacing Any Suspect Packs – Clear TAP-102
 Diagnostic Failure By Replacing Packs on TLP Suspected Faulty Equipment List – Clear TAP-101

 Fuse; Blown – SD-4A012-01 – Clear TAP-114
 Fuse; Blown – SD-4A012-02 – Clear TAP-116
 Fuse; Blown – SD-4A087-01 – Clear TAP-120

 Lamps; Power Switch – Test DLP-512
 LED; Lighted – Bulk Converter and FC554 Circuit Pack, SD-4A087-01 – Clear TAP-112
 LED; Lighted – FB152 Pack, SD-4A012-01 and SD-4A012-02 – Clear TAP-118
 LED; Lighted – Nonbulk Converter – Clear TAP-107
 LEDs; Lighted – Bulk Converter, FC554 and FC512 Circuit Packs, SD-4A087-01 – Clear TAP-127

FIND YOUR JOB IN THE LIST BELOW THEN GO TO

Maintenance Philosophy TAD-100

Power Alarm Circuits – Test DLP-505

Power Switch – Replace DLP-513

TLP Abort – Diagnostic Failure – Clear TAP-122

TLP Disk Queue Full – Diagnostic Failure – Clear TAP-108

TLP Inhibit – Diagnostic Failure – Clear TAP-110

TLP Queue Blockage – Diagnostic Failure – Clear TAP-109

TLP Searches Inhibited – Diagnostic Failure – Clear TAP-128

TLP Tape Acquisition Error – Diagnostic Failure – Clear TAP-124

TLP Tape Not Mounted – Diagnostic Failure – Clear TAP-125

TLP Tape Version X Does Not Match Version Y – Diagnostic Failure – Clear TAP-123

TTY Printout DGN:TMSP a,{CONTR b|COIPUB c|C1IPUB d} PH e STF
 ANALY:TLPFILE TMSP a,{CONTR b|COIPUB c|C1IPUB d} ABORTED TAP-122

TTY Printout DGN:TMSP a,{CONTR b|COIPUB c|C1IPUB d} PH e STF
 ANALY:TLPFILE TMSP a,{CONTR b|COIPUB c|C1IPUB d} NULL PACK TEST GENERATED TAP-102

TTY Printout DGN:TMSP a,{CONTR b|COIPUB c|C1IPUB d} PH e STF
 ANALY:TLPFILE TMSP a,{CONTR b|COIPUB c|C1IPUB d} SUMMARY DATA
 QUEUE ACCESS DENIED:DATA NOT RETAINED:CODE 001 TAP-108

TTY Printout DGN:TMSP a,{CONTR b|COIPUB c|C1IPUB d} PH e STF
 ANALY:TLPFILE TMSP a,{CONTR b|COIPUB c|C1IPUB d} SUMMARY DATA
 QUEUE ACCESS DENIED:DATA NOT RETAINED:CODE 002 TAP-109

TTY Printout DGN:TMSP a,{CONTR b|COIPUB c|C1IPUB d} PH e STF
 ANALY:TLPFILE TMSP a,{CONTR b|COIPUB c|C1IPUB d} SUMMARY DATA
 QUEUE ACCESS DENIED:DATA NOT RETAINED:CODE 004 TAP-110

Reissued	Issue 6	JAN 1997
	234-151-011	IXL
	PAGE 2 of 4	001

FIND YOUR JOB IN THE LIST BELOW THEN GO TO

TTY Printout DGN:TMSP a,{CONTR b|COIPUB c|C1IPUB d} PH e STF
 ANALY:TLPFILE TMSP a,{CONTR b|COIPUB c|C1IPUB d} SUSPECTED FAULTY EQUIPMENT
 Note column does not contain NOTE 2 TAP-101

TTY Printout DGN:TMSP a,{CONTR b|COIPUB c|C1IPUB d} PH e STF
 ANALY:TLPFILE TMSP a,{CONTR b|COIPUB c|C1IPUB d} SUSPECTED FAULTY EQUIPMENT
 Note column contains NOTE 2
 Fuse blown SD-4A012-01 TAP-114

TTY Printout DGN:TMSP a,{CONTR b|COIPUB c|C1IPUB d} PH e STF
 ANALY:TLPFILE TMSP a,{CONTR b|COIPUB c|C1IPUB d} SUSPECTED FAULTY EQUIPMENT
 Note column contains NOTE 2
 Fuse blown SD-4A012-02 TAP-116

TTY Printout DGN:TMSP a,{CONTR b|COIPUB c|C1IPUB d} PH e STF
 ANALY:TLPFILE TMSP a,{CONTR b|COIPUB c|C1IPUB d} SUSPECTED FAULTY EQUIPMENT
 Note column contains NOTE 2
 Fuse blown SD-4A012-01 TAP-120

TTY Printout DGN:TMSP a,{CONTR b|COIPUB c|C1IPUB d} PH e STF
 ANALY:TLPFILE TMSP a,{CONTR b|COIPUB c|C1IPUB d} SUSPECTED FAULTY EQUIPMENT
 Note column contains NOTE 2
 No fuses blown TAP-129

TTY Printout DGN:TMSP a,{CONTR b|COIPUB c|C1IPUB d} PH e STF
 ANALY:TLPFILE TMSP a,{CONTR b|COIPUB c|C1IPUB d}
 TLP PROGRAM ABORTED TAP-122

TTY Printout DGN:TMSP a,{CONTR b|COIPUB c|C1IPUB d} PH e STF
 ANALY:TLPFILE TMSP a,{CONTR b|COIPUB c|C1IPUB d} TLP
 WARNING:VERSION X DOES NOT MATCH EXPECTED VERSION Y TAP-123

TTY Printout DGN:TMSP a,{CONTR b|COIPUB c|C1IPUB d} PH e STF
 ANALY:TLPFILE TMSP a,{CONTR b|COIPUB c|C1IPUB d} TLP
 CURRENT TLP SEARCH ABORTED
 ALL PENDING TLP SEARCHES INHIBITED TAP-128

FIND YOUR JOB IN THE LIST BELOW THEN GO TO

TTY Printout DGN:TMSP a,{CONTR b|COIPUB c|C1IPUB d} PH e STF
 ANALY:TLPFILE TMSP a,{CONTR b|COIPUB c|C1IPUB d} TLP
 TLP TAPE AQUISITION ERROR
 MOUNT TAPE WITH FILE = f TAP-124

TTY Printout DGN:TMSP a,{CONTR b|COIPUB c|C1IPUB d} PH e STF
 REPT:TAPE MUST BE MOUNTED FOR FUNCTION TLP TAP-125

No acceptance test procedures are required for this frame.
The readiness of this frame to become a part of the
working system was established by the successful
completion of Installation Handbook test procedures

ACCEPTANCE

Issue 6	JAN 1997
234-151-011	NTP
PAGE 1 of 1	002

DO THE ITEMS BELOW IN THE ORDER LISTED FOR DETAILS, GO TO

1	Type in OP:00SUNITS:TMSP,TSI!	-
	NOTE: Both Time Multiplexed Switching and Time Slot Interchange Frames with their respective mates must be available for diagnostic testing	
2	Determine Availability of Time Multiplexed Switching and Time Slot Interchange Frames for Test as indicated by OP:00SUNITS:TMSP,TSI Response	-
3	Initiate Diagnostic Phase 9 (DGN:TMSP a;CONTR b:PH 9,RTSI c,TTSI c,OPTION 10!) (DGN:TMSP a,CONTR b COMPLETED ATP Output Message Required) (a = TMS Member Numbers 0-3, b = TMS Controller Numbers 0-1, c = TSI Member Numbers 0-63)	DLP-517
4	Restore to Service (RST:TMSP a CONTR b!) (RST:TMSP a CONTR b COMPLETED Output Message Required) (a = Member Numbers 0-3, b = Controller Numbers 0-1)	-
5	Repeat From Item 2 for All Combinations of TMS, TTSI, and RTSI	-

DO THE ITEMS BELOW IN THE ORDER LISTED FOR DETAILS, GO TO

1	At Frame Power Control Switch in Bay Containing Converter, Rotate ROS/OFF Switch to ROS Position	-
2	Ensure OS Lamp Lighted on Power Control Switch	-
3	Replace Bulk Converter (245A With 245A)	DLP-509
4	Rotate ROS/OFF Switch to Normal Position	-
5	Ensure OS Lamp Goes Out After Diagnostic Completed ATP	-

DO THE ITEMS BELOW IN THE ORDER LISTED FOR DETAILS, GO TO

1	At Frame Power Control Switch in Bay Containing Converter, Rotate ROS/OFF Switch to ROS Position	-
2	Ensure OS Lamp Lighted on Power Control Switch	-
3	Replace Bulk Converter (245C With 245C)	DLP-521
4	Rotate ROS/OFF Switch to Normal Position	-
5	Ensure OS Lamp Goes Out After Diagnostic Completed ATP	-

DO THE ITEMS BELOW IN THE ORDER LISTED FOR DETAILS, GO TO

1	At Frame Power Control Switch in Bay Containing Converter, Rotate ROS/OFF Switch to ROS Position	-
2	Ensure OS Lamp Lighted on Power Control Switch	-
3	Replace Bulk Converter (245A With 245C)	DLP-522
4	Rotate ROS/OFF Switch to Normal Position	-
5	Ensure OS Lamp Goes Out After Diagnostic Completed ATP	-

DO THE ITEMS BELOW IN THE ORDER LISTED FOR DETAILS, GO TO

1	At Frame Power Control Switch in Bay Containing Converter, Rotate ROS/OFF Switch to ROS Position	-
2	Ensure OS Lamp Lighted on Power Control Switch	-
3	Replace Bulk Converter (245C With 245A)	DLP-523
4	Rotate ROS/OFF Switch to Normal Position	-
5	Ensure OS Lamp Goes Out After Diagnostic Completed ATP	-

GENERAL

The maintenance philosophy contained in this volume is based upon the design of equipment (hardware), diagnostic software and test equipment employed. Procedures are intended to aid personnel in performing trouble-clearing tasks. The degree to which these procedures accomplish this depends upon input and feedback from the user. Additions, corrections, and improvements to the data are encouraged. Manufacturer, engineering and software documentation such as I/O Manuals, SDs, PKs, PRs, etc, are referred to where applicable rather than duplicating that information in the TOP. Some portions of those documents may be utilized in procedures but only as examples for purposes of explanation. Test equipment (oscilloscopes, voltmeters, etc) and the parameters involved in the circuits being tested, adjusted, or checked are usually prescribed. Setup and method of use is not described unless it is unusual or unique.

IXL Philosophy [IXL-001]

The IXL is structured to provide fast access to those procedures pertinent to the symptoms identified. Procedures unique to a particular modification of frame are identified by that frame's SD number. If not so identified, the procedure would apply to all modifications.

Power problems are sensed by scan points which generate an alarm. It is assumed that the user following the aisle pilot lights can locate the frame with the power fault which is automatically powered down (**PWR OFF** lamp lighted and **OFF NORM** lamp off) or by reading REPT:PA printout which would identify the frame with

power fault. The precise structure of the message is given in the input/output (I/O) message manuals. Symptoms described in the IXL reflect the assumptions above, and indicate other conditions that are observable at the frame that would enable the user to access the proper trouble-clearing procedure. These conditions are fuse blown, lighted LEDs on converters, or power function circuit packs.

In general, logic circuit failures cause the fault recovery program to request a diagnostic program. This method of requesting the diagnostic program includes the TLP option. The IXL reflects this in the TTY printouts listed. Outside of the first two supplementary messages (**ANALY:TLPPFILE:**) all other supplementary messages pertain to problems in generating a **SUSPECTED FAULTY EQUIPMENT** list and reference to procedures (TAPs) which attempt to correct the problem. If successful in generating a **SUSPECTED FAULTY EQUIPMENT** list, those procedures reference to the appropriate procedure [TAP-101] which tells you what to do with this list. If not successful, they reference to the next level of trouble clearing, raw data analysis [TAP-102] which is an alternative to the first and common trouble clearing approach.

TAP PHILOSOPHY

When documenting a procedural approach to trouble clearing, certain assumptions are made. It is assumed that one fault is being cleared at a time. When directing the user to perform an action, it is assumed that he performs that action correctly. Similarly, when directed to make replacements, the replacement part is always assumed to be good. Equipment used for testing both built-in (hardware and software) and commercial,

are assumed to be good. Only consistent fault signatures are covered.

Trouble-clearing TAPs provided for diagnostic failures are provided on three levels. Level one [TAP-101] addresses what to do with a software generated TLP **SUSPECTED FAULTY EQUIPMENT** list and provides a step-by-step procedure for replacing circuit packs one-at-a-time, and analyzing the results. This level is straightforward and requires some familiarity with the equipment (descriptive and theory AT&T Practices), TTY techniques, and with diagnostic printouts.

Second level of trouble clearing is accessed from first level TAP when TLP generated **SUSPECTED FAULTY EQUIPMENT** list has been exhausted without clearing the problem or it can be accessed directly from the IXL or any of the **ANALY:TLPFILE:** TAPs which produce a **NULL PACK TEST GENERATED** response. This level [TAP-102] is known as raw data analysis and describes what to do with the summary and supplemental data printed out either with or instead of the **SUSPECTED FAULTY EQUIPMENT** list. It is expected that this will lead to an identification of faulty circuits within SD and possibly additional suspect circuit packs not previously identified. This level of trouble clearing is more complex and requires knowledge of equipment, of TTY techniques and printouts, and of SDs, PKs, PRs, etc.

Third level of trouble clearing is signal tracing using interactive diagnostics [TAP-103]. This procedure is accessible only from the previous level [TAP-102] and uses information derived in the performance of that procedure. This level of trouble clearing requires an increase in the capabilities cited in the first two levels but with additional knowledge and skill in the set-up and use of test equipment (oscilloscopes, voltmeters, etc).

ALTERNATE METHODS

The more knowledgeable and experienced personnel may access TOP documents at a point in trouble clearing where analyzation is completed (faulty component determined) and only repair or replacement required. In many instances, access to these procedures may be obtained by locating procedural data (NTP/DLP) through the Index [IXL-001]. Most DLPs are built to support TAPs and NTPs with preconditioning and system restoration steps covered in those level procedures (TAPs, NTPs). Therefore, access to data (DLPs) on a hunt and find basis is a threat to equipment operation and may compound trouble-clearing problems.

Another method of trouble clearing that may be utilized is F-level interrupt analysis. Trouble-clearing TAPs for F-level interrupts are provided on two levels. The first level addresses how to clear time multiplexed switching F-level interrupts using the SMCC-generated pack list and provides a step-by-step procedure for replacing suspect packs one at a time and analyzing the results. This level requires a familiarity with SMCC terminal operation, register layouts, hardware structures, and general software structures.

The second level addresses how to clear time multiplexed switching F-level interrupts using TOP Volume 234-353-003. This level is accessed from the first level TAP when the SMCC data base failed to produce a suspect pack list. It may also be accessed directly from the IXL of TOP Volume 234-353-003. It is expected this level will lead to an identification of suspect circuit packs by use of PMD description and bit positions set in registers. Replacing suspect circuit packs one at a time and analyzing the results should clear the interrupt. This level requires

Revised

Issue 6	JAN 1997
234-151-011	TAD
PAGE 2 of 3	100

a familiarity with F-level printouts, register layouts, bit position descriptions, hardware structures, and general software structures.

The TAPs provided for analyzing F-levels are for recurring interrupts. Therefore, a history of the time interval between interrupts is essential when replacing suspect circuit packs and analyzing the results. Sufficient time should be allowed between replacement of suspect packs for interrupt to recur. Should this be the wrong circuit pack, then the probability is high that the interrupt will occur again with the same symptoms. If interrupt recurs, the next most suspect circuit pack should be replaced. Prior to changing circuit packs, diagnostics should be run with ATP expected. If diagnostics produce:

- ATP – The most suspect circuit pack is the first pack on list obtained by analysis of interrupt.
- STF – The most suspect circuit pack is the pack that appears on both TLP SUSPECTED FAULTY EQUIPMENT list and list obtained by analysis of interrupt.

EQUIPMENT TEST LIST

This is a list of tasks recommended for preventive maintenance. Tasks are arranged by the frequency of the maintenance beginning with the shortest interval.

FREQUENCY	TASK	PROCEDURE
6 months	Tests Lamps on Power Switch	DLP-512

Issue 6	JAN 1997
234-151-011	TAD
PAGE 3 of 3	100

SUMMARY

Replace all listed packs located in failed TMS frame half beginning with first pack listed. After each pack replacement, check diagnostic results to determine if trouble was

cleared. If after all listed packs for failed TMS half and any TSI helper unit have been replaced and trouble is not cleared, perform raw data analysis using TAP-102.

[1] See NOTE 1.
Identify first TMS circuit pack on suspected faulty equipment list

[2] Type in RMV:TMSP message [TABLE A]

[3] Replace circuit pack [DLP-500]

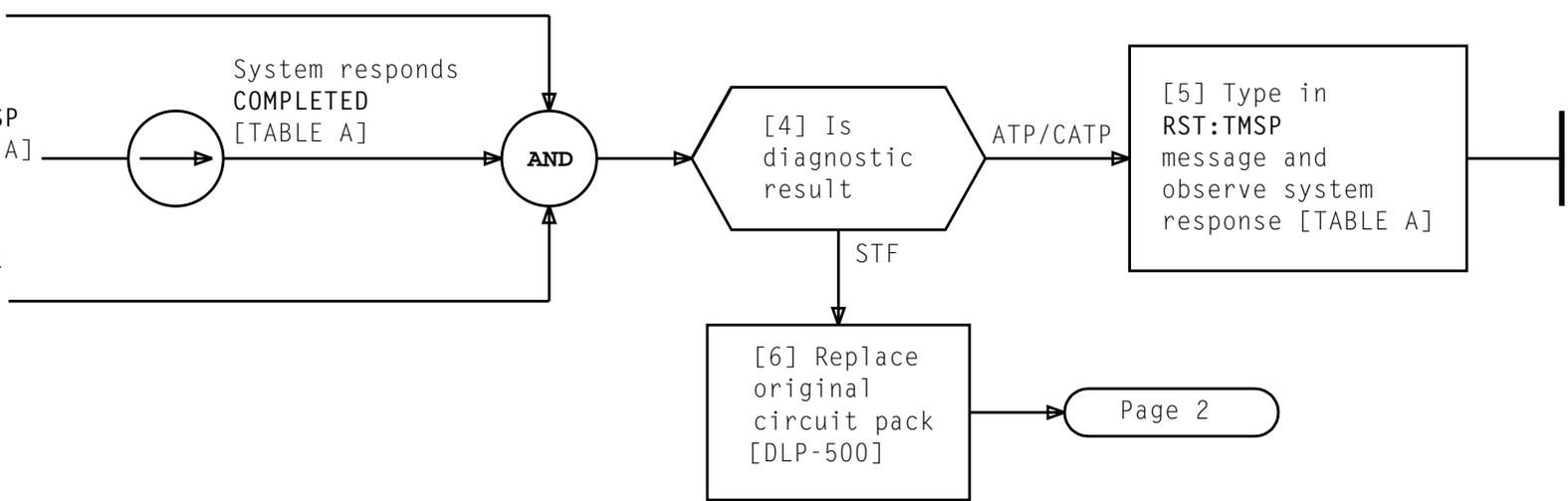


TABLE A

INPUT MESSAGE	RESPONSE
RMV:TMSP a,{CONTR b COIPUB c C1IPUB d}!	RMV:TMSP a,{CONTR b COIPUB c C1IPUB d}COMPLETED
RST:TMSP a,{CONTR b COIPUB c C1IPUB d}!	RST:TMSP a,{CONTR b COIPUB c C1IPUB d}COMPLETED
a, b, c and d = member and submember numbers	

NOTE 1
Red designation marker at pack to be replaced indicates fuse removal required to replace pack

Reissued

Issue 6	JAN 1997
234-151-011	TAP
PAGE 1 of 3	101

CLEAR DIAGNOSTIC FAILURE BY REPLACING PACKS ON TLP SUSPECTED FAULTY EQUIPMENT LIST

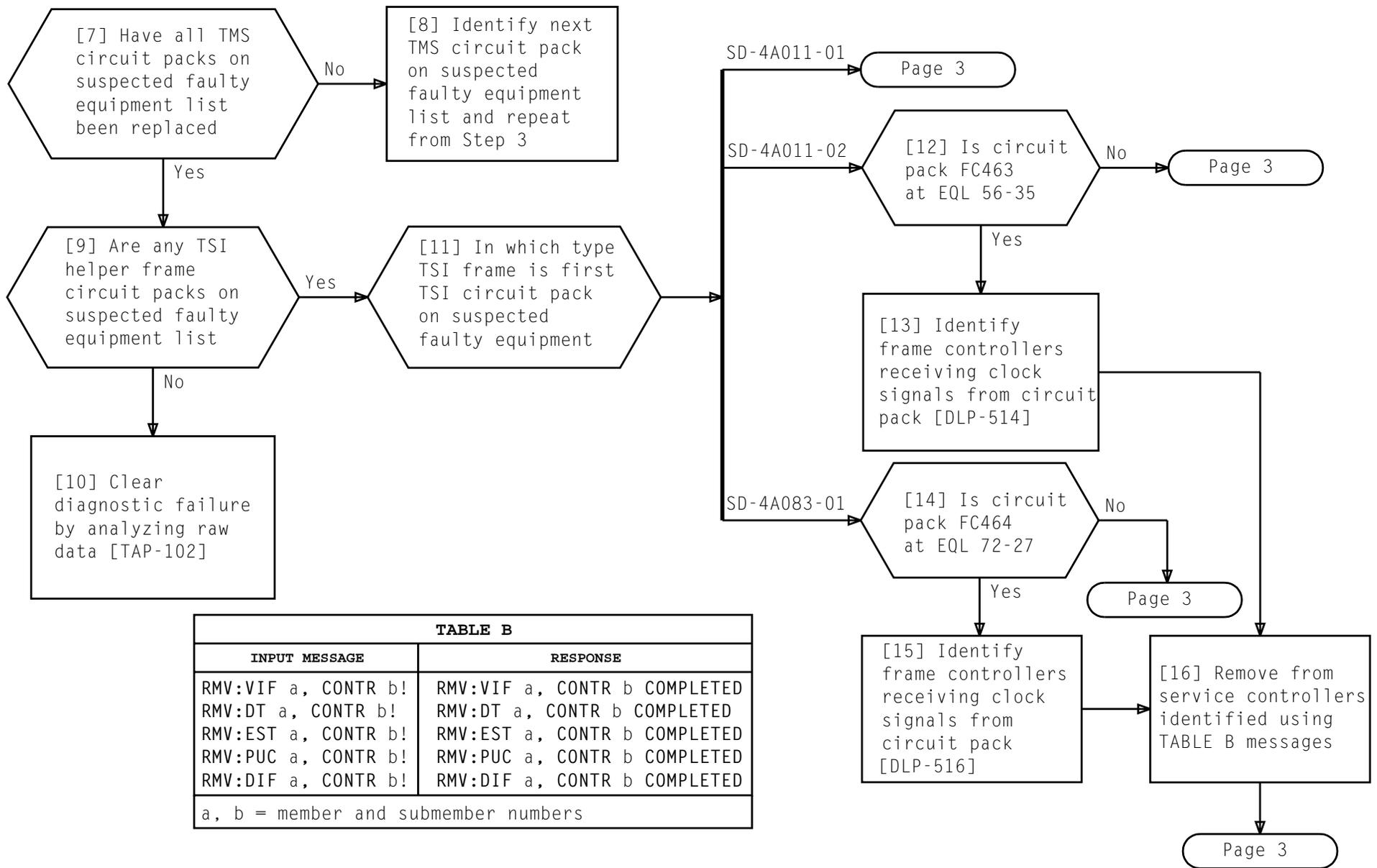


TABLE B	
INPUT MESSAGE	RESPONSE
RMV:VIF a, CONTR b!	RMV:VIF a, CONTR b COMPLETED
RMV:DT a, CONTR b!	RMV:DT a, CONTR b COMPLETED
RMV:EST a, CONTR b!	RMV:EST a, CONTR b COMPLETED
RMV:PUC a, CONTR b!	RMV:PUC a, CONTR b COMPLETED
RMV:DIF a, CONTR b!	RMV:DIF a, CONTR b COMPLETED
a, b = member and submember numbers	

**CLEAR DIAGNOSTIC FAILURE BY REPLACING
PACKS ON TLP SUSPECTED FAULTY EQUIPMENT LIST**

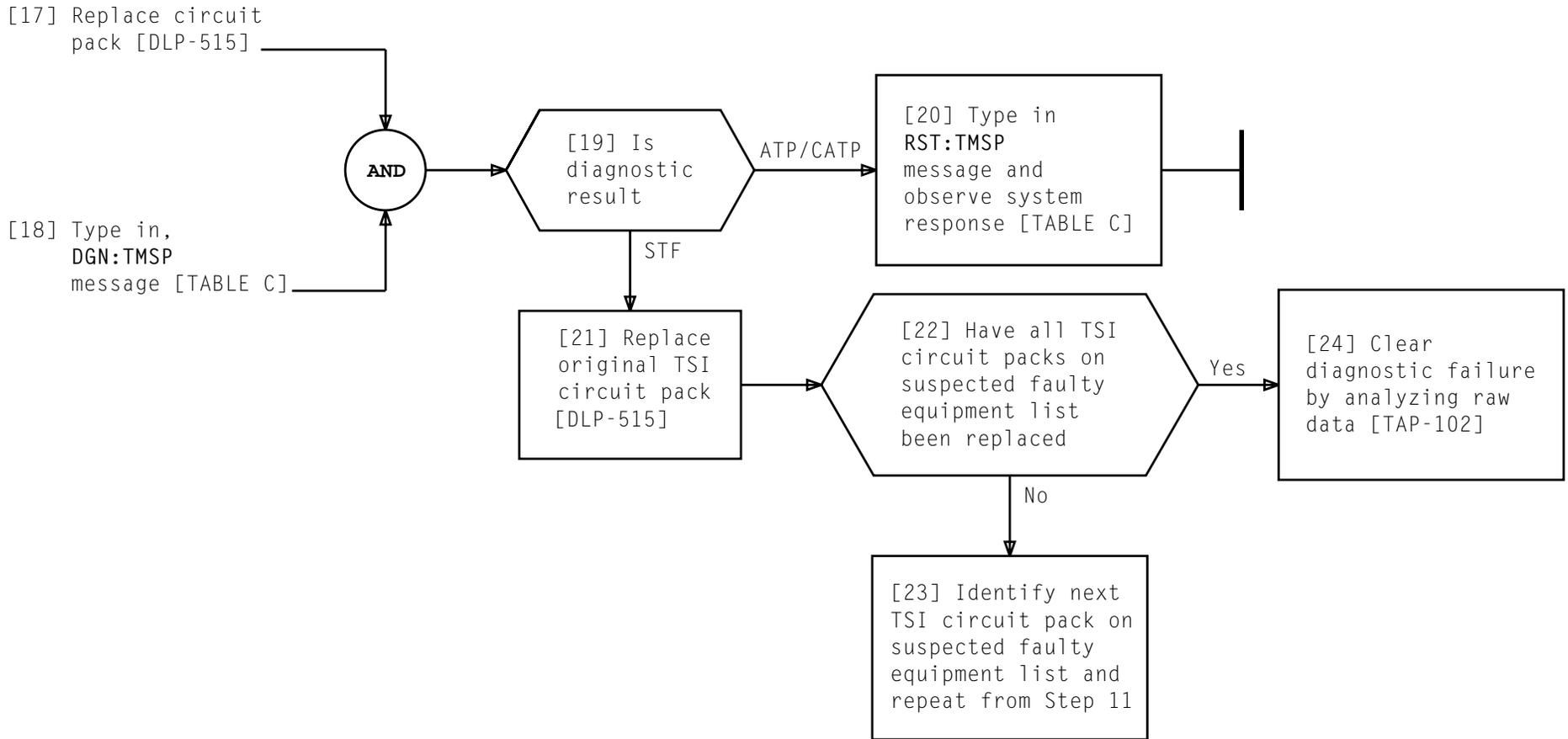


TABLE C	
INPUT MESSAGE	RESPONSE
DGN:TMSP a,{CONTR b COIPUB c C1IPUB d},TLP,CONTR e!	
RST:TMSP a,{CONTR b COIPUB c C1IPUB d}!	RST:TMSP a,{CONTR b COIPUB c C1IPUB d}COMPLETED
a,b,c,d,e = member and submember numbers	

**CLEAR DIAGNOSTIC FAILURE BY REPLACING
PACKS ON TLP SUSPECTED FAULTY EQUIPMENT LIST**

SUMMARY

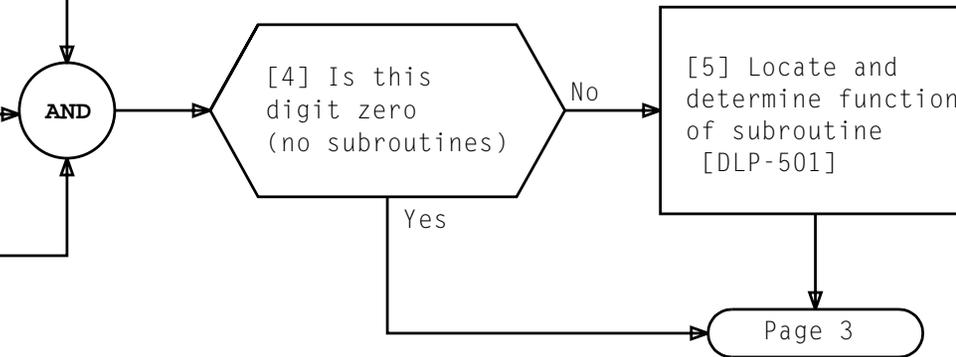
Read first failing phase prologue. Determine if subroutines were used and identify their location and function. Locate first failing test and determine test function. Determine if doloops were used and identify their location and

function. Use SDs/CDs and knowledge of first failing test function to identify and replace any suspect packs other than those previously replaced. If trouble is not cleared, refer to TAP-103 (clear diagnostic failure by looping over first failing test and signal tracing to locate fault)

[1] See NOTE 1. Obtain diagnostic PIDENT for first failing phase and read prologue

[2] See FIG. 1. On raw data printout locate first failing test raw data

[3] Locate sixth digit in fifth data word following MISMATCH data



NOTE 1
 PR number = 4A568 + phase number except phase 9 = 4A673 and IPUB phase 99 = 4A705. PIDENT is PUDGTGXX where XX = phase number subroutines in PUDGTGGR (4A568)

CLEAR DIAGNOSTIC FAILURE BY ANALYZING RAW DATA AND REPLACING ANY SUSPECT PACKS

Issue 6	JAN 1997
234-151-011	TAP
PAGE 1 of 5	102

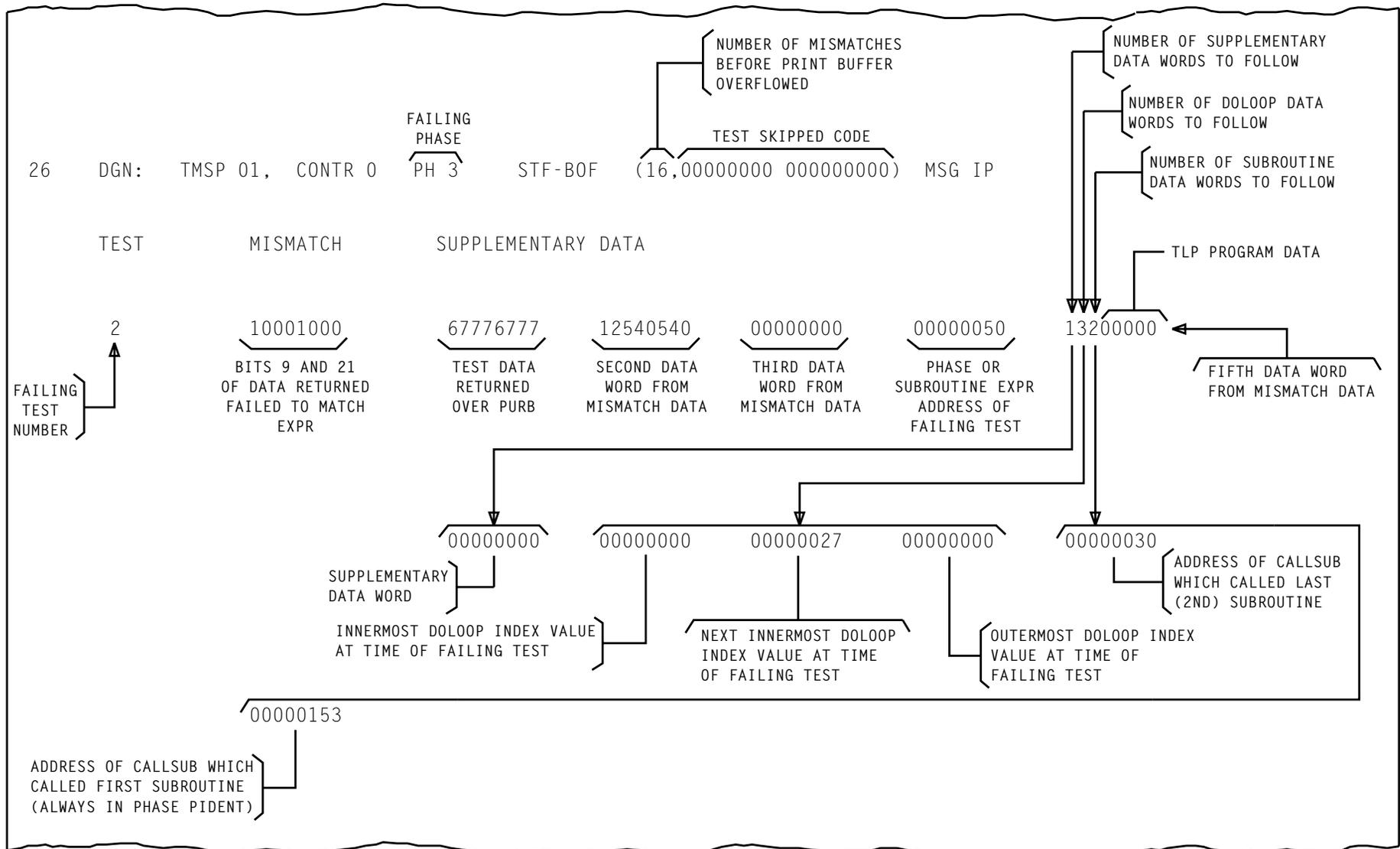


FIG. 1 - Example of TMS Raw Data Printout

CLEAR DIAGNOSTIC FAILURE BY ANALYZING RAW DATA AND REPLACING ANY SUSPECT PACKS

Issue 6	JAN 1997
234-151-011	TAP
PAGE 2 of 5	102

[6] See FIG. 1. Locate fourth raw data word following MISMATCH data

[7] See NOTE 2 and FIG. 2. Use this address to locate first failing test expected results (EXPR)

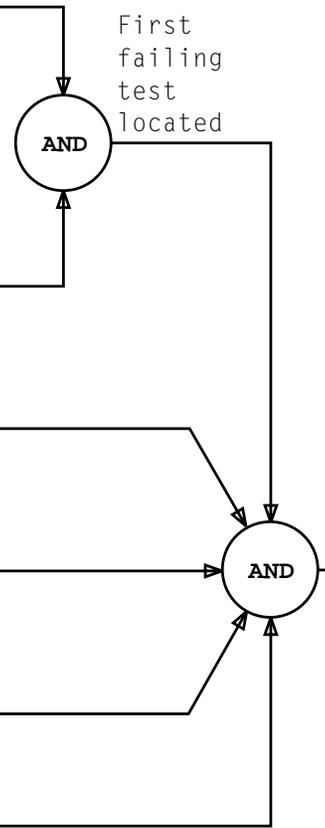
[8] See NOTE 3. Read prologue of program unit containing first failing test

[9] Analyze failing test data to determine failing test function [DLP-502]

[10] See FIG. 1. On raw data printout locate fifth word from MISMATCH data

[11] Locate seventh digit in fifth data word

NOTES
 2. Phase PIDENT may have address appearing in more than one strip. Be sure address located has EXPR data for your test
 3. Program unit name is indicated in upper left of each listing



```

ADDRESS  STRIP DESIGNATION
000050AB 4243 00 01000000. . . . .DATA=M(T14N00P) #EXPR
  
```

FIG. 2 - Example of EXPR Data in Listing

CLEAR DIAGNOSTIC FAILURE BY ANALYZING RAW DATA AND REPLACING ANY SUSPECT PACKS

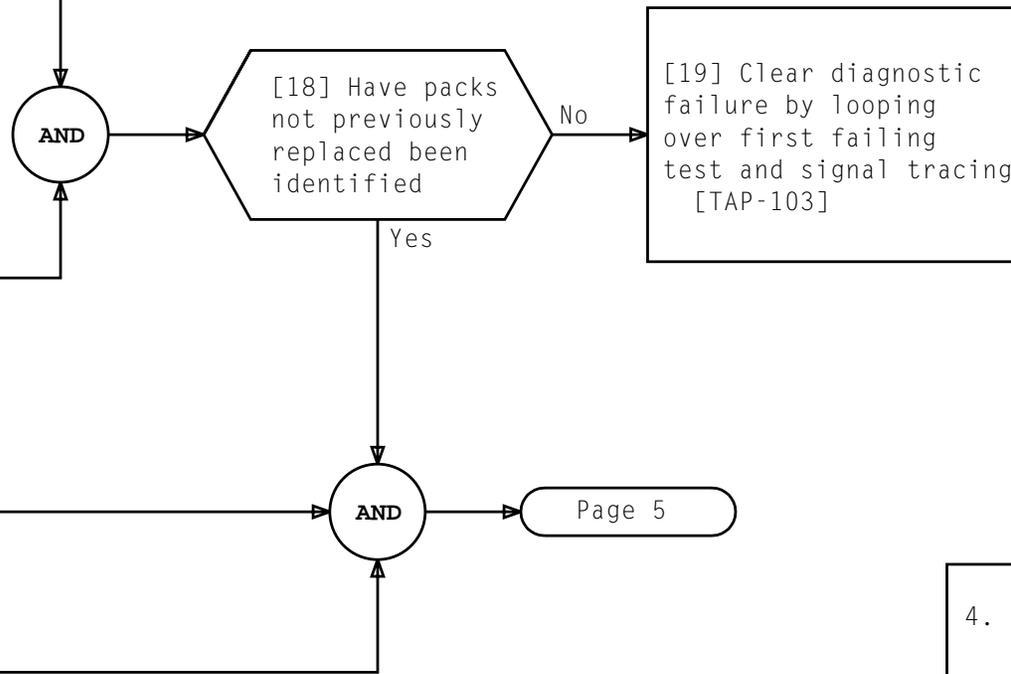
Issue 6	JAN 1997
234-151-011	TAP
PAGE 3 of 5	102

[16] Using summary data printout and Issue 2 or later Test Access PK Document, attempt to identify an SD lead in path of failing bit
 TMS = PK-4A021-01/02
 TMS-B = PK-4A087-01 [DLP-518]

[17] See NOTE 4. Using PR prologue data, knowledge of failing test function, failing bits indicated by MISMATCH data, lead information, and appropriate SDs, identify suspect circuit packs

[20] Type in
 RMV:TMSP message
 (System responds
 RMV:TMSP)
 [TABLE A]

[21] See NOTE 5.
 Replace circuit pack [DLP-500]



NOTES	
4. Test failures reads of memory or registers. Fault could be in path of read or in path of write that set up read	
5. Red designation marker at pack to be replaced indicates fuse removal required to replace pack	
Issue 6	JAN 1997
234-151-011	TAP
PAGE 4 of 5	102

CLEAR DIAGNOSTIC FAILURE BY ANALYZING RAW DATA AND REPLACING ANY SUSPECT PACKS

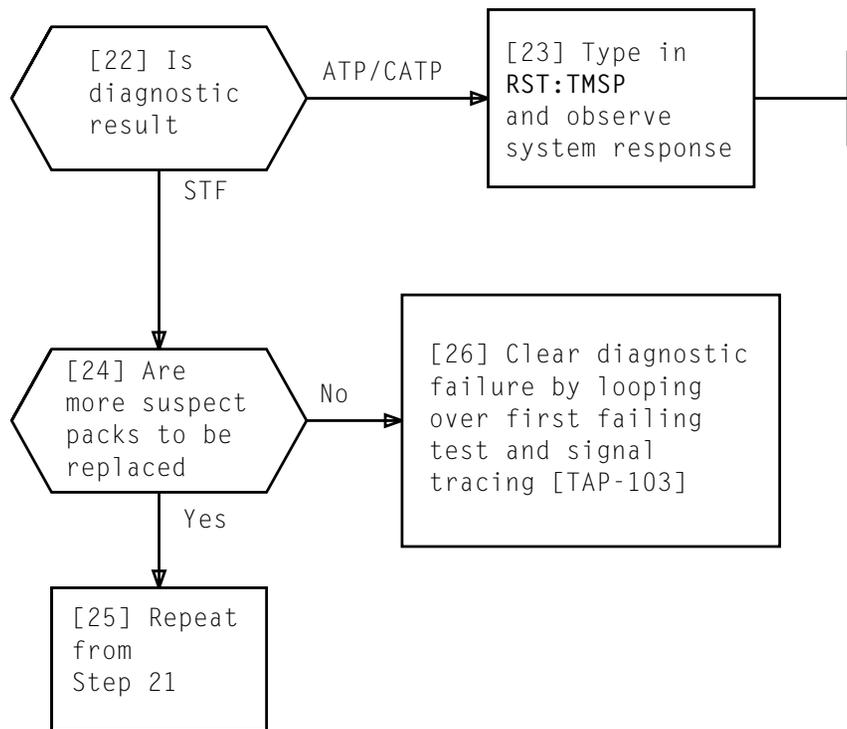


TABLE A	
INPUT MESSAGE	RESPONSE
RMV:TMSP a,{ CONTR b COIPUB c C1IPUB d}!	RMV:TMSP a,{ CONTR b COIPUB c C1IPUB d}COMPLETED
RST:TMSP a,{ CONTR b COIPUB c C1IPUB d}!	RST:TMSP a,{ CONTR b COIPUB c C1IPUB d}COMPLETED
a, b, c, d = member and submember numbers	

**CLEAR DIAGNOSTIC FAILURE BY ANALYZING
RAW DATA AND REPLACING ANY SUSPECT PACKS**

Reissued

Issue 6	JAN 1997
234-151-011	TAP
PAGE 5 of 5	102

<p style="text-align: center;">SUMMARY</p> <p>Type in TABLE A messages. Verify first failing test raw data printed twice. Resend last TABLE A message with RPT option deleted for infinite loop. Set up scope. If SYNC option is used, attach external sweep trigger to terminal</p>	<p>indicated in TABLE B. Using raw data analysis information obtained in TAP-102, SDs/CDs, and circuit pack SDs, signal trace path of failing bits to isolate and clear fault. If F-level interrupt associated with diagnostic failure, see TOP Volume AT&T 234-353-003</p>
--	---

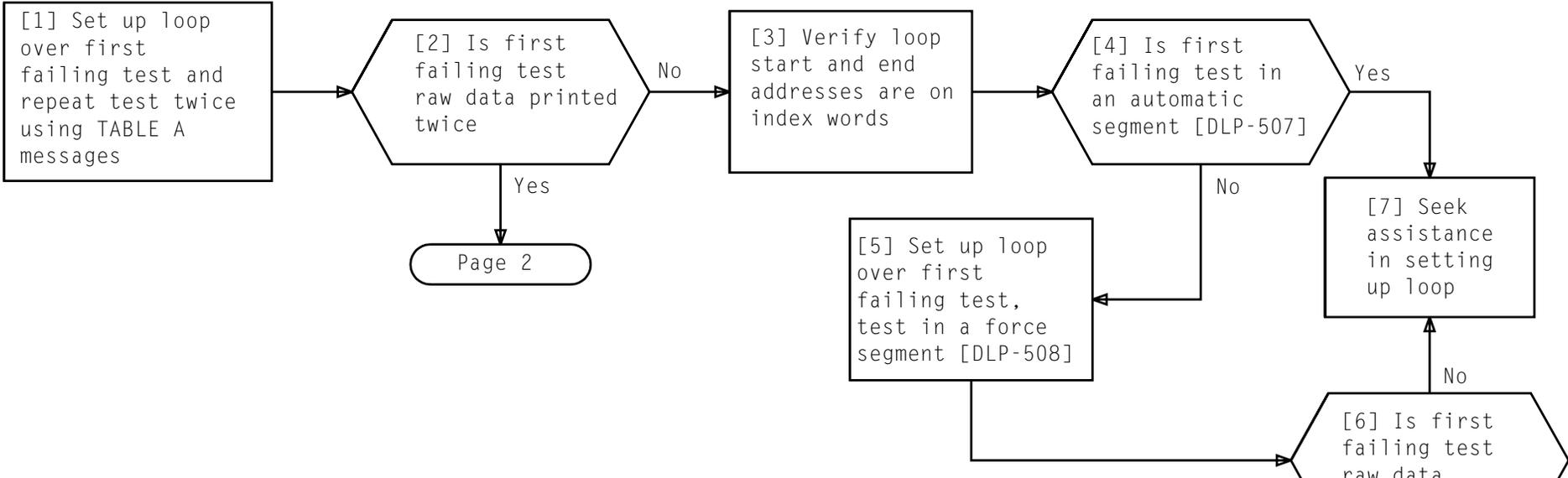


TABLE A – MESSAGES TO ESTABLISH LOOP	
INPUT MESSAGE	RESPONSE
EX:TMSP a,{CONTR b COIPUB c C1IPUB d};START!	EX:TMSP a,{CONTR b COIPUB c C1PUB d} SUSPENDED
EX:TMSP a:SYNC e,ENABLE f!	
EX:TMSP a;RPT 2:PH g,ADR e-h!	EX:TMSP a,{CONTR b COIPUB c C1IPUB d} Raw data
a, b, c, d = member and submember numbers e = address of first failing test statement index word f = first failing test number g = first failing phase number h = address of next index word following first failing test index word	

Revised

CLEAR DIAGNOSTIC FAILURE BY LOOPING OVER FIRST FAILING TEST AND SIGNAL TRACE TO LOCATE FAULT

Issue 6	JAN 1997
234-151-011	TAP
PAGE 1 of 3	103

[8] Set up infinite loop by typing in
EX:TMSP a:PH g,ADR e-h!
See TABLE A for a, e,
g, and h. Response is
"looping started"

[9] See TABLE
A. Was SYNC
option used

[13] Set
up scope

[14] See NOTE 2. Using
raw data analysis
information, TMS
SDs/CDs, and circuit
pack SDs, signal trace
path of failing bits to
isolate and clear fault

[10] Set up scope for signal
tracing using external
sweep trigger

[11] Connect external sweep
trigger to terminals
indicated in TABLE B
(TMS BAY 0 or 1)

AND

[12] See FIG. 1 and NOTE 1.
Display sweep trigger
and adjust for SYNC
pulse display

[15] Has
fault been
cleared

Page 3

[16] Are
mate packs
on TLP list

[17] See
CAUTION 1.
Are mate packs
to be replaced

[18] Contact
TAC for
assistance

TABLE B	
SD-4A012-01	Connect 80-10-104 to 80-10-304 with clip lead. Connect EXT sweep trigger to clip lead
SD-4A012-02	Connect EXT sweep to 80-10-104
SD-4A087-01	Connect EXT sweep to 76-26-104 or 80-26-104

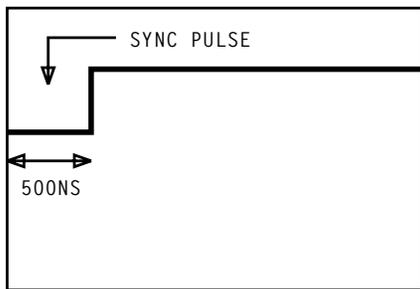


FIG. 1 - SYNC Pulse Display

NOTES
1. SYNC pulse arrives over PUWB bit 36 which is not tested by TMS diagnostic
2. Analysis of F-level interrupt associated with diagnostic failure may also be helpful [TAP-130]

CAUTION 1
Mate pack replacement may cause service degrading condition

CLEAR DIAGNOSTIC FAILURE BY LOOPING OVER FIRST FAILING TEST AND SIGNAL TRACE TO LOCATE FAULT

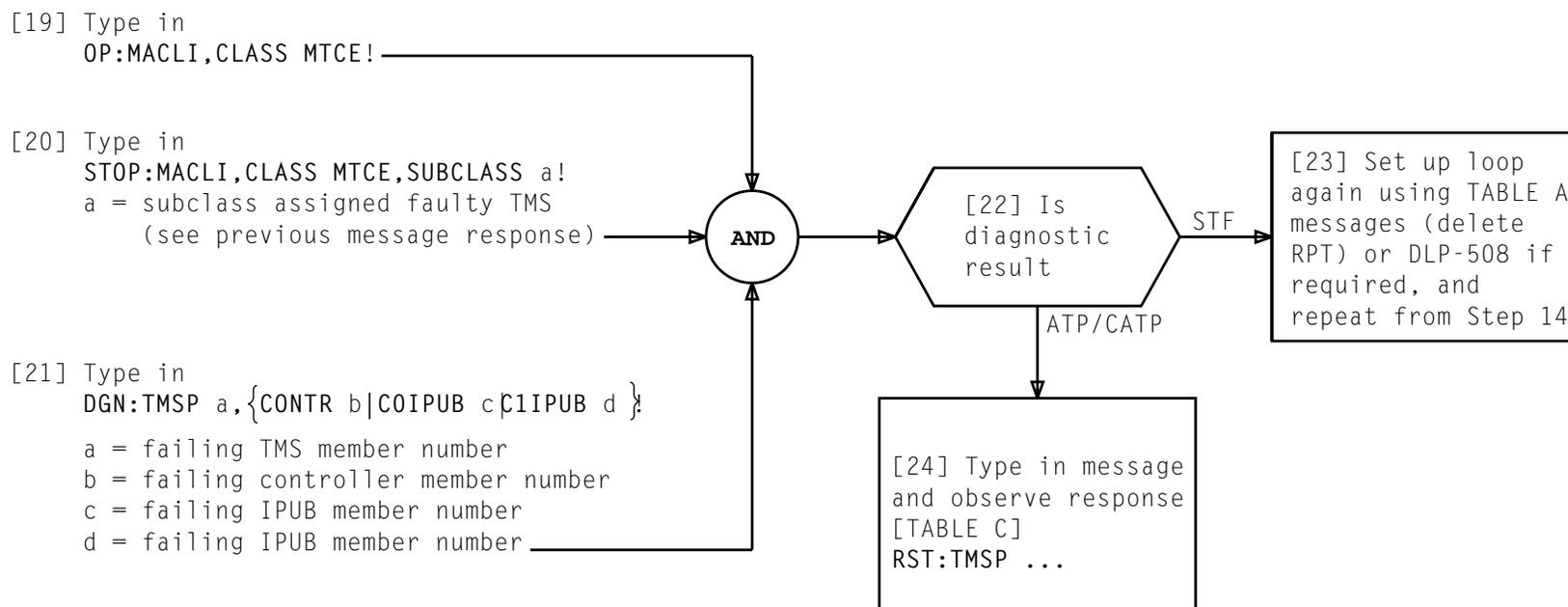
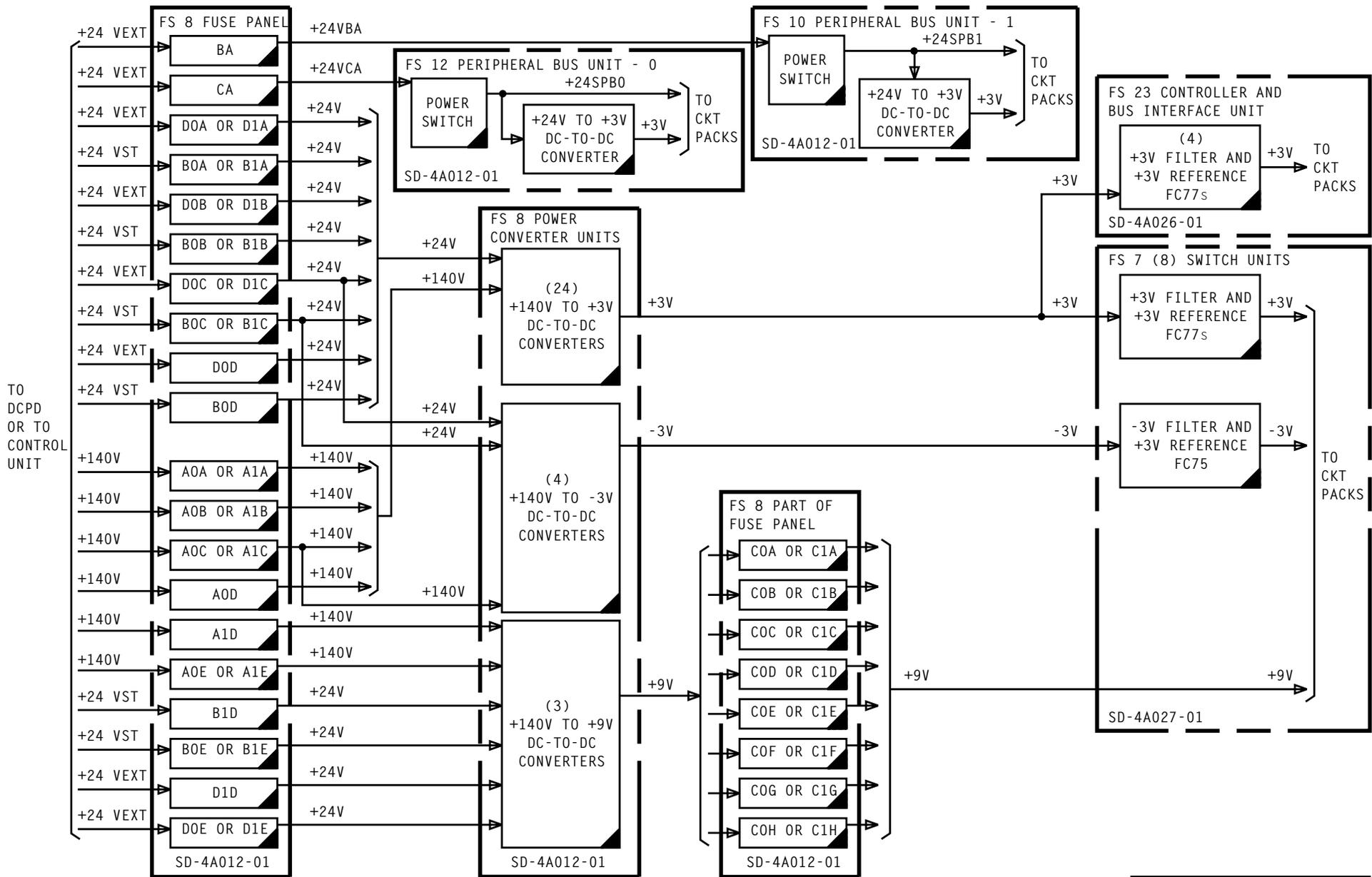


TABLE C	
INPUT MESSAGE	RESPONSE
RST:TMSP a,{CONTR b COIPUB c IPUB d }	RST:TMSP a,{CONTR b COIPUB c IPUB d }COMPLETED
a, b, c, d = member and submember numbers	

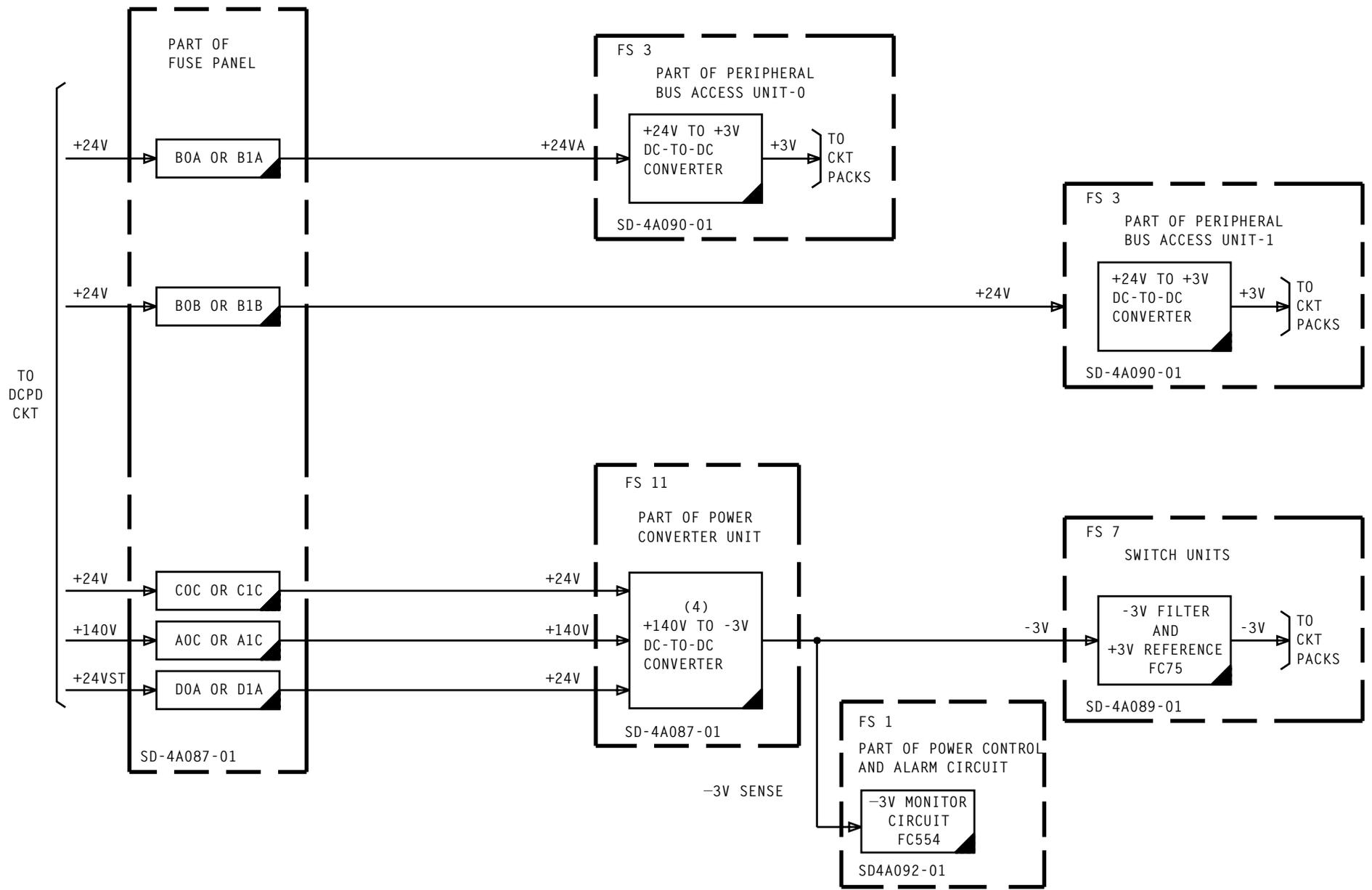
CLEAR DIAGNOSTIC FAILURE BY LOOPING OVER FIRST FAILING TEST AND SIGNAL TRACE TO LOCATE FAULT



POWER AND FUSING FOR NONBULK CONVERTERS, SD-4A012-01 FRAME

Copyright ©1986 AT&T - All Rights Reserved

Issue 6	JAN 1997
234-151-011	ISD
PAGE 1 of 1	104



POWER AND FUSING FOR NONBULK CONVERTERS, SD-4A087-01 FRAME

Copyright ©1986 AT&T - All Rights Reserved

Issue 6	JAN 1997
234-151-011	ISD
PAGE 1 of 1	106

SD-4A012-01 ISD-104
 SD-4A012-02 ISD-105
 SD-4A087-01 ISD-106

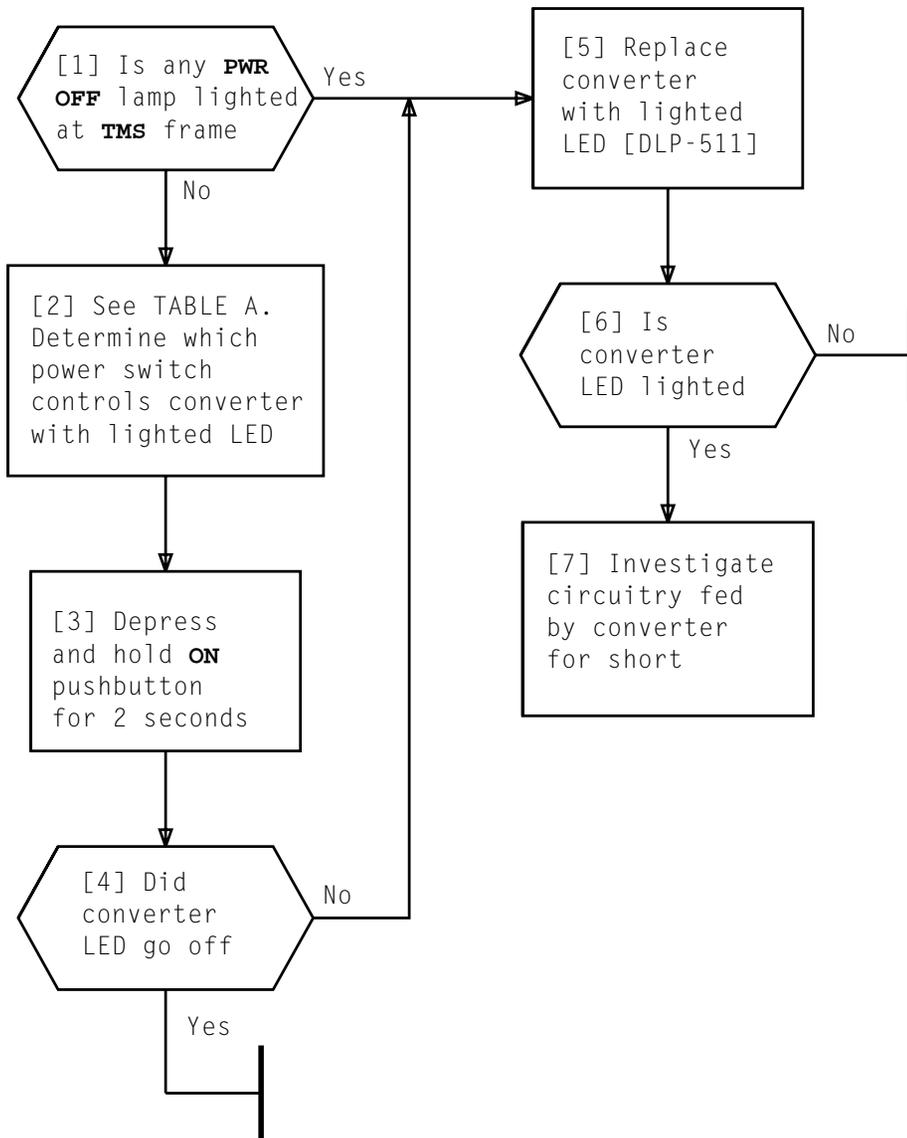
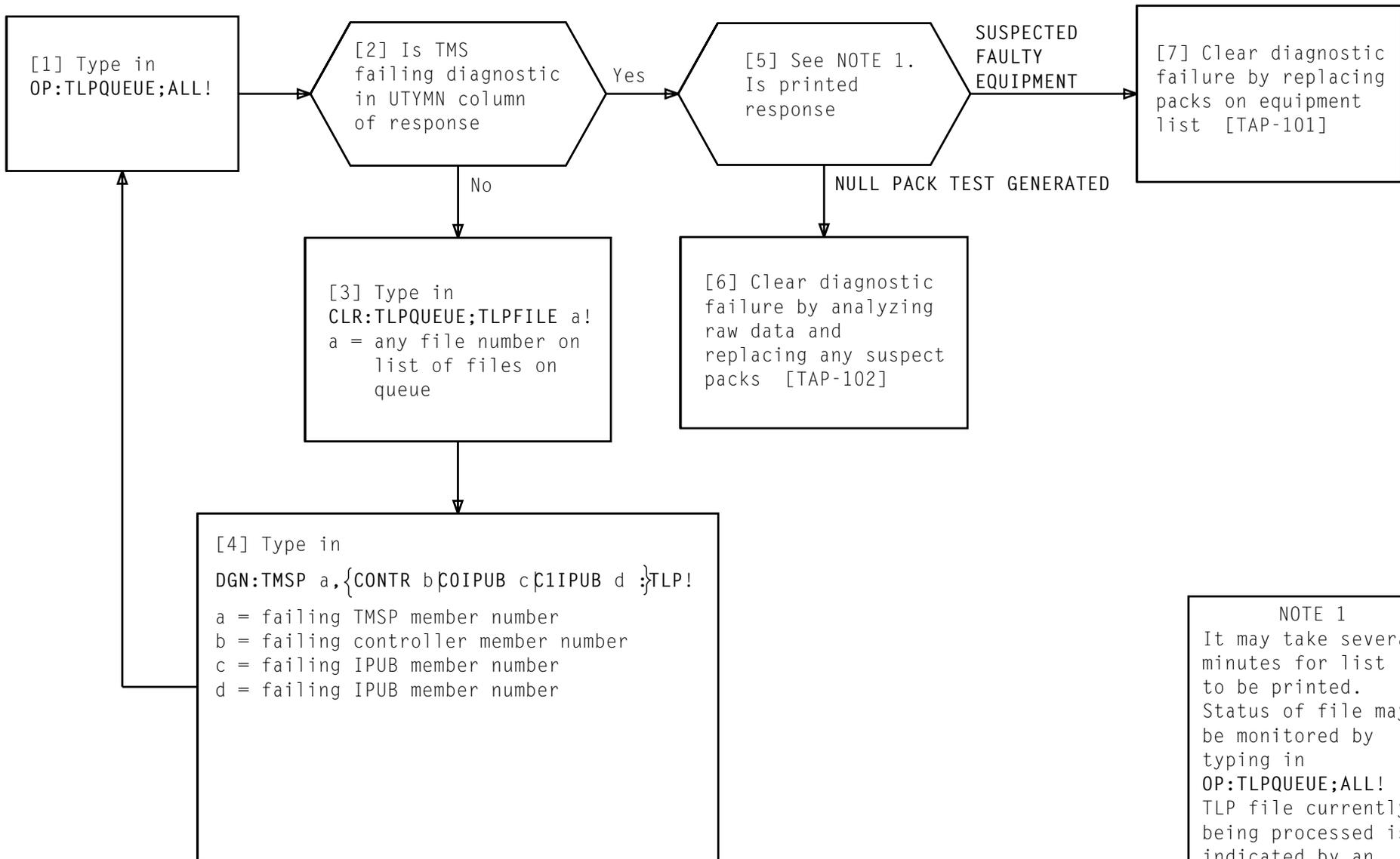


TABLE A				
SD	CONVERTER LOCATION	POWER SWITCH		
		LOCATION	NAME	
			BAY0	BAY1
4A087-01	*-80-26	*-80-29	IPUB0	IPUB1
	All others	1-68-09		CONTR
4A012-01,02	*-80-36	*-80-42	COIPUB1	C1IPUB1
	*-76-36	*-76-42	COIPUB0	C1IPUB0
	All others	*-44-38	CONTR0	CONTR1

* Converters located in Bay 0 or Bay 1 are controlled, respectively, by switches located in Bay 0 and Bay 1

CLEAR NONBULK CONVERTER LED LIGHTED CONDITION



NOTE 1
It may take several
minutes for list
to be printed.
Status of file may
be monitored by
typing in
OP:TLPQUEUE;ALL!
TLP file currently
being processed is
indicated by an
asterisk in priority
column

Issue 6	JAN 1997
234-151-011	TAP
PAGE 1 of 1	108

CLEAR DIAGNOSTIC FAILURE, TLP DISK QUEUE FULL

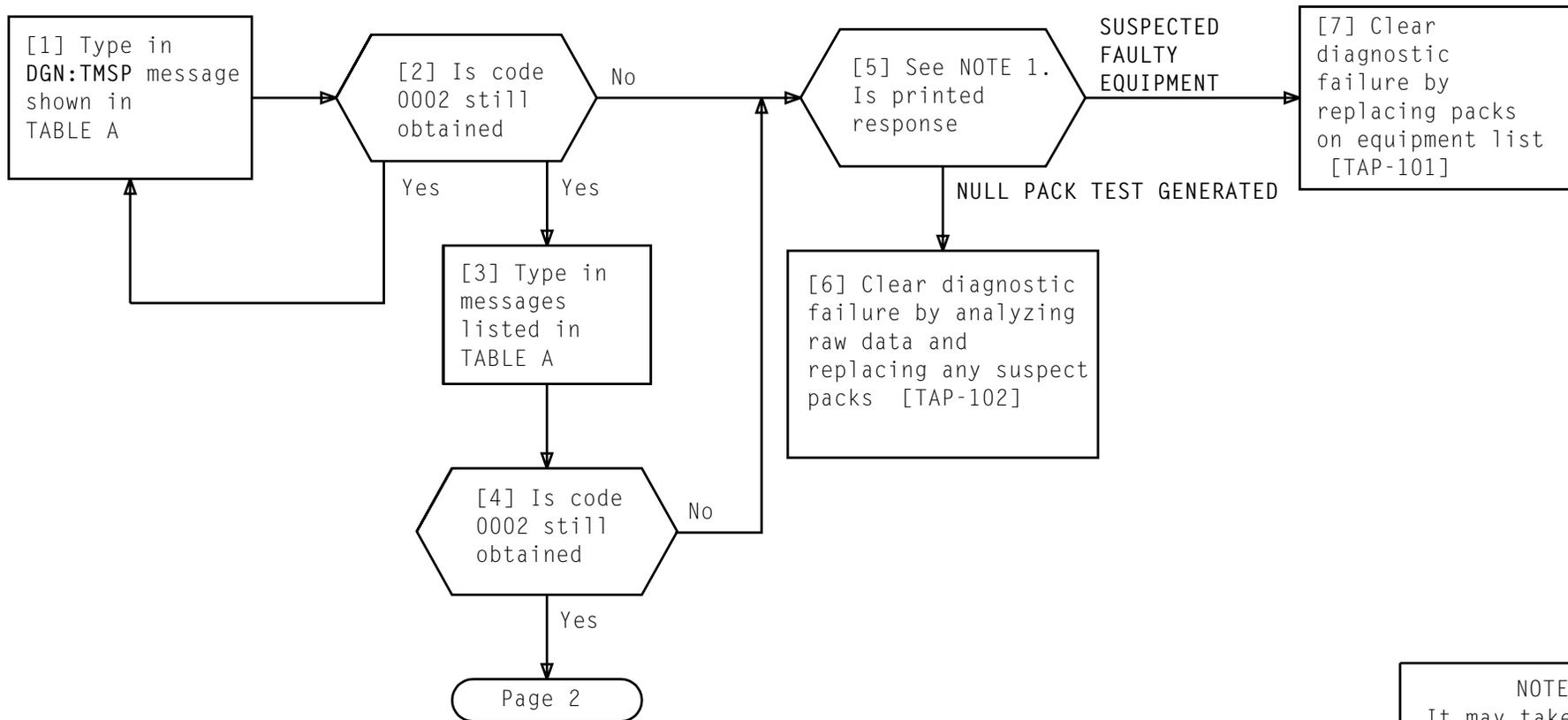
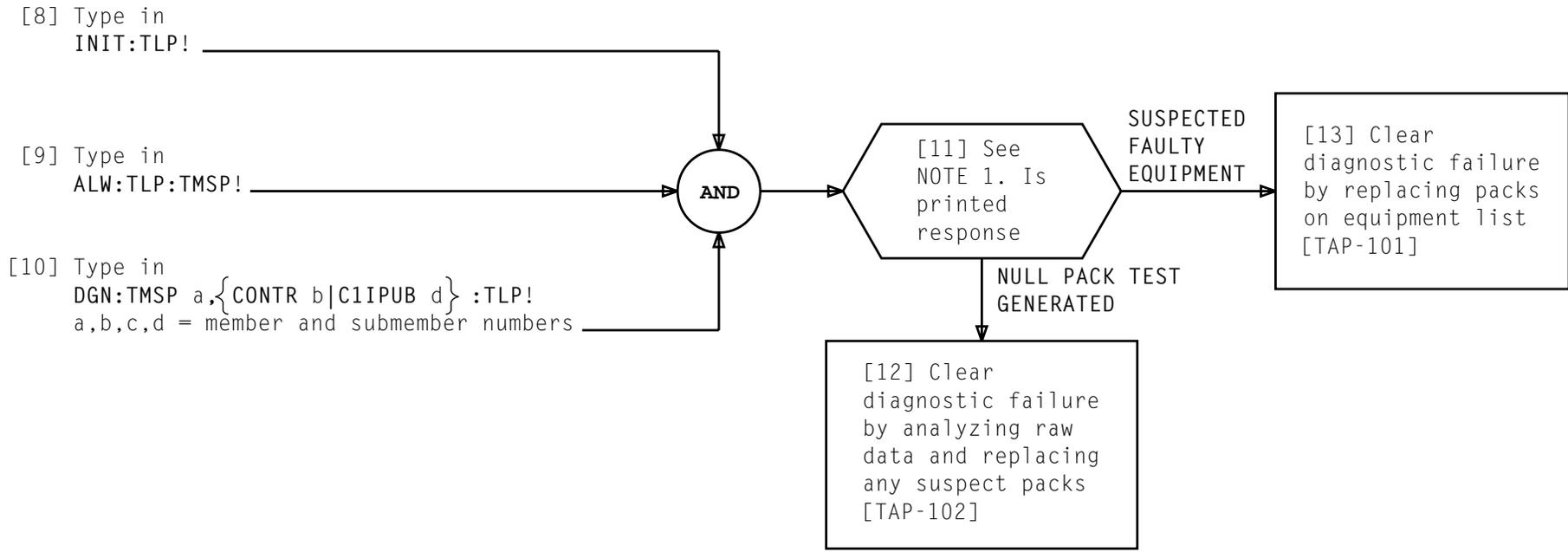


TABLE A	
ALW:TLP:SRCH, TMSP!	
ALW:TLP:SRCH, TMSP!	
DGN:TMSP a, {CONTR b c IPUB c IPUB d } TLP!	
a = failing TMS member number	
b = failing controller member number	
c = failing IPUB member number	
d = failing IPUB member number	

NOTE 1
 It may take several minutes for list to be printed. Status of file may be monitored by typing in
 OP:TLPQUEUE;ALL!
 TLP file currently being processed is indicated by an asterisk in priority column

Issue 6	JAN 1997
234-151-011	TAP
PAGE 1 of 2	109

CLEAR DIAGNOSTIC FAILURE, TLP QUEUE BLOCKAGE



CLEAR DIAGNOSTIC FAILURE, TLP QUEUE BLOCKAGE

Issue 6	JAN 1997
234-151-011	TAP
PAGE 2 of 2	109

[1] Type in
ALW:TLP:TMS

[2] Type in
DGN:TMS a,{CONTR b|OIPUB c|IPUB d }TLP!
a = failing TMS member number
b = failing controller member number
c = failing IPUB member number
d = failing IPUB member number

[3] See NOTE 1.
Is printed
response

SUSPECTED
FAULTY
EQUIPMENT

[5] Clear
diagnostic failure
by replacing
packs on equipment
list
[TAP-101]

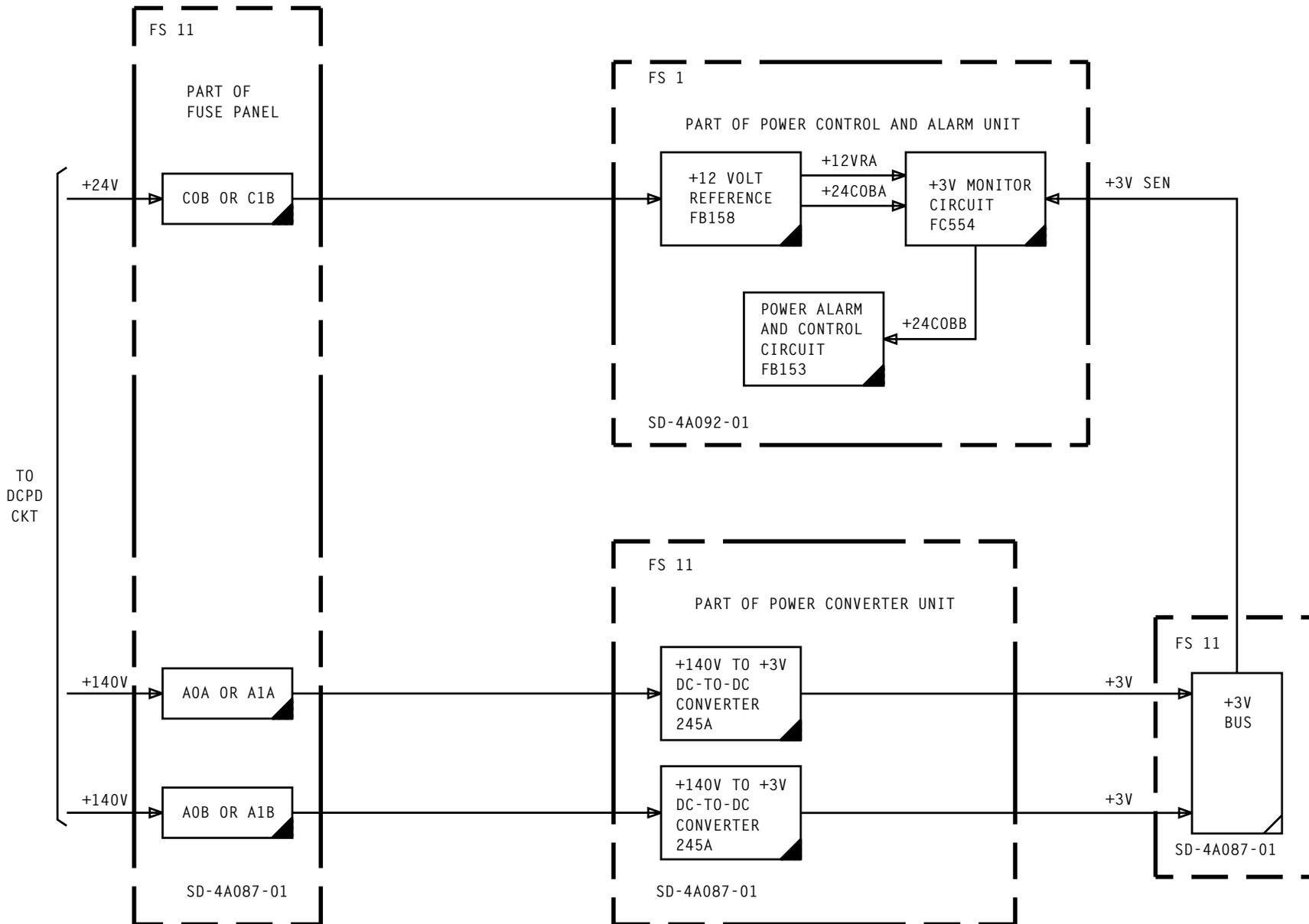
NULL PACK
TEST GENERATED

[4] Clear
diagnostic failure
by analyzing raw
data and replacing
any suspect packs
[TAP-102]

NOTE 1
It may take several
minutes for list
to be printed.
Status of file
may be monitored
by typing in
OP:TLPQUEUE;ALL!
TLP file currently
being processed is
indicated by an
asterisk in
priority column

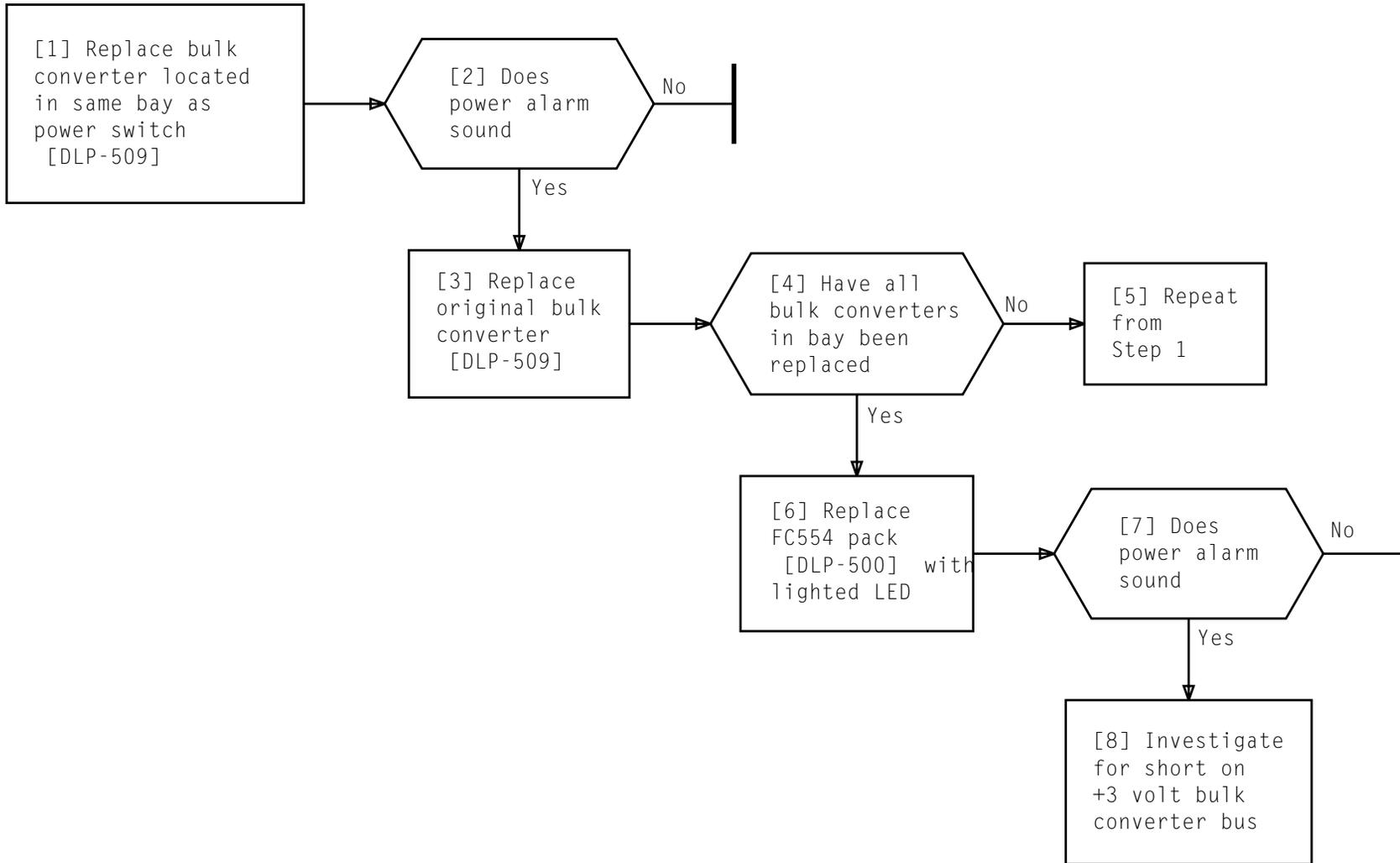
CLEAR DIAGNOSTIC FAILURE, TLP INHIBIT

Issue 6	JAN 1997
234-151-011	TAP
PAGE 1 of 1	110



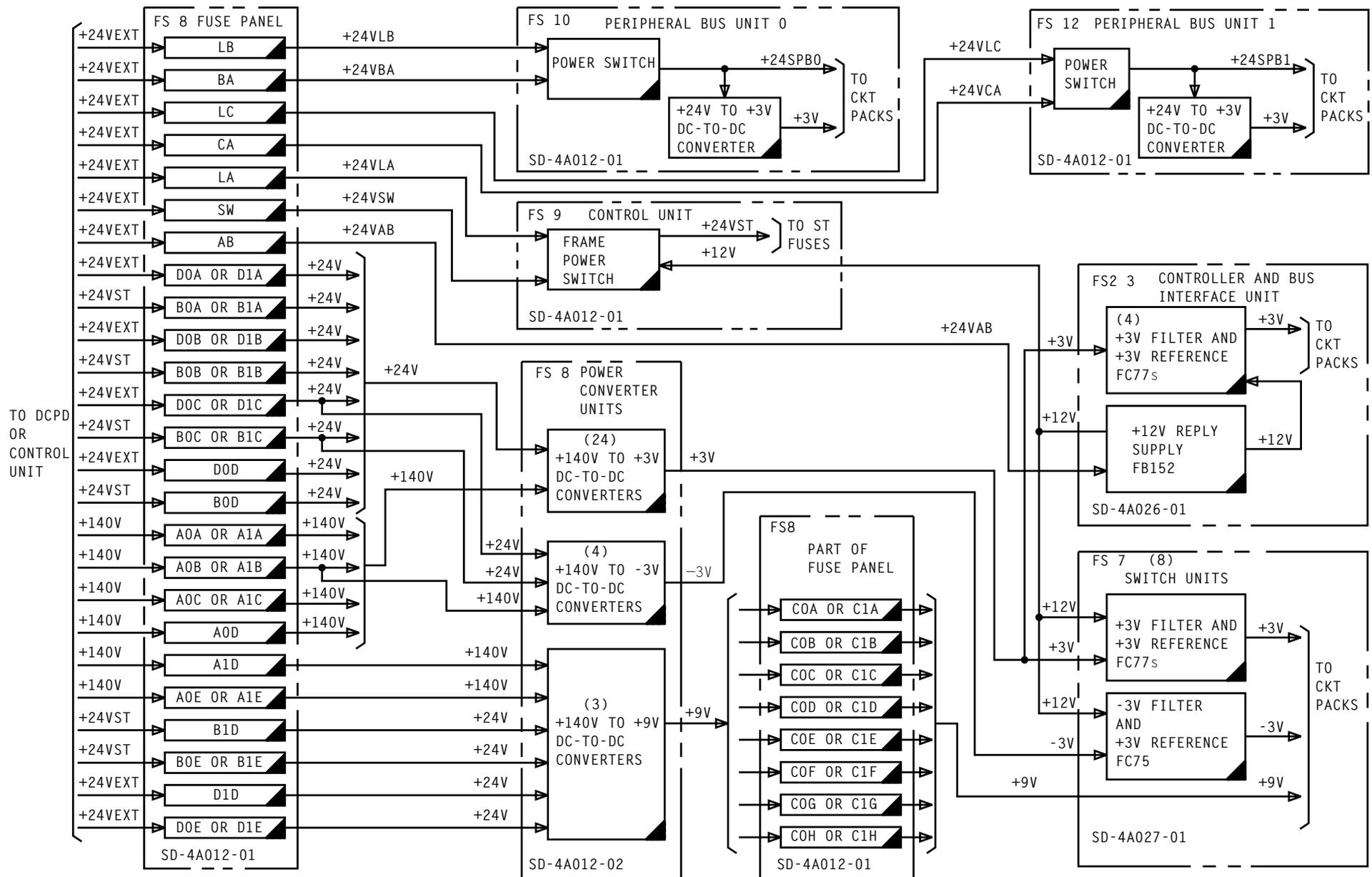
**POWER AND FUSING FOR BULK CONVERTERS
AND FC554 PACK, SD-4A087-01 FRAME**

Issue 6	JAN 1997
234-151-011	ISD
PAGE 1 of 1	111



CLEAR BULK CONVERTER AND FC554 CIRCUIT PACK LED LIGHTED CONDITION, SD-4A087-01 FRAME

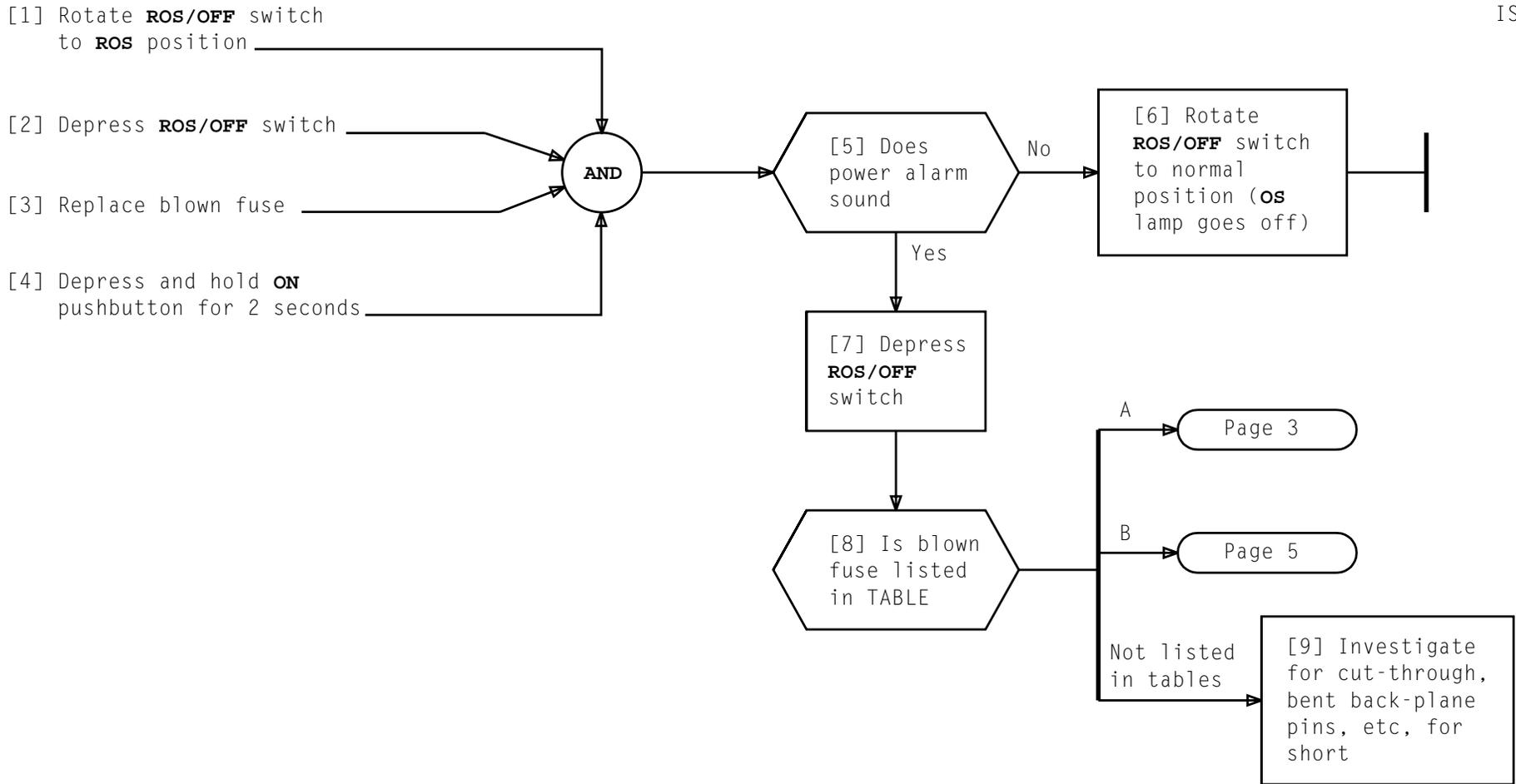
Issue 6	JAN 1997
234-151-011	TAP
PAGE 1 of 1	112



FUSING AND POWER FOR SD-4A012-01 FRAME

Copyright ©1986 AT&T - All Rights Reserved

Issue 6	JAN 1997
234-151-011	ISD
PAGE 1 of 1	113

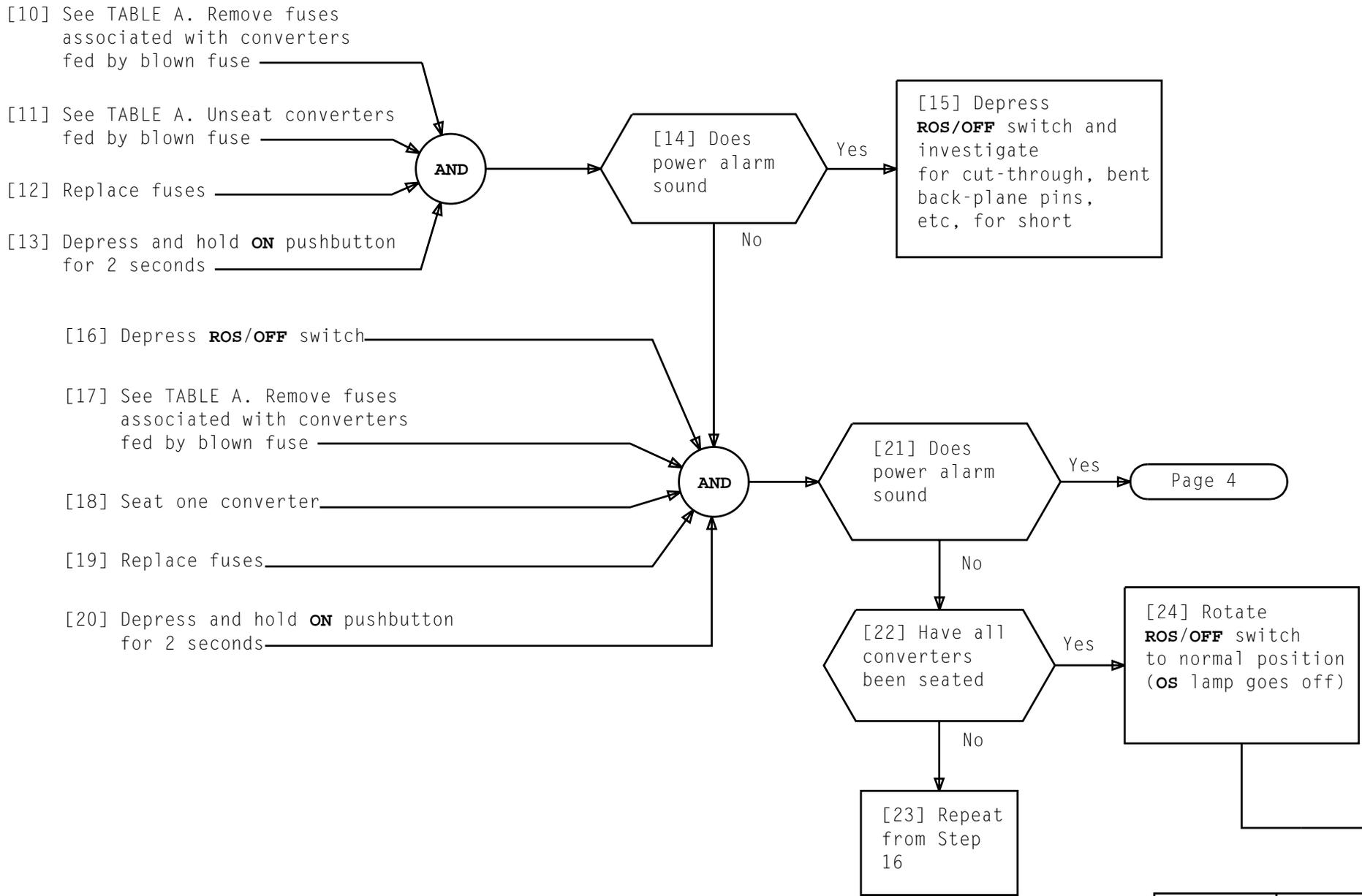


CLEAR BLOWN FUSE, SD-4A012-01 FRAME

Issue 6	JAN 1997
234-151-011	TAP
PAGE 1 of 5	114

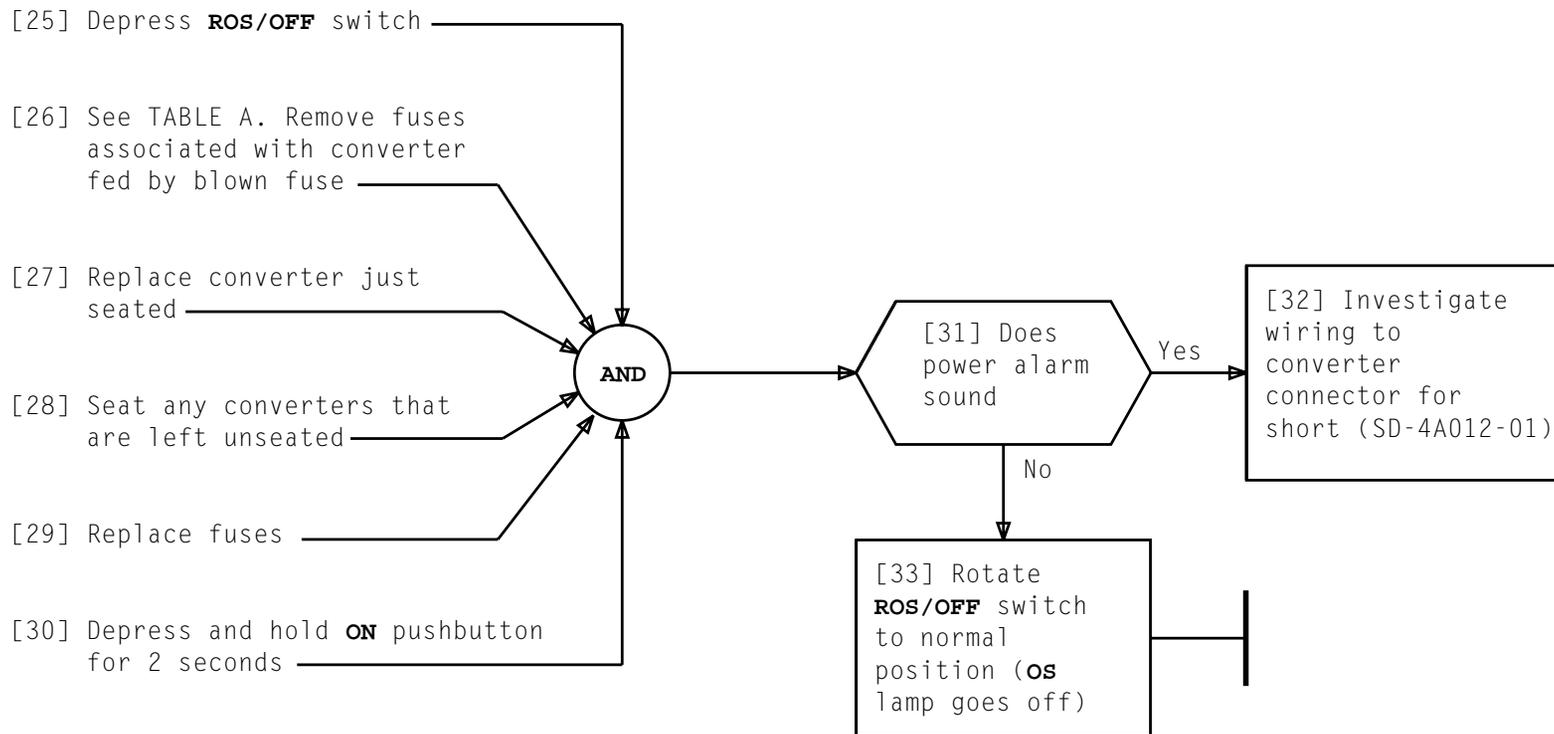
TABLE A			
FUSE BAY 0	CONVERTERS FED AT LOCATION	FUSE BAY 1	CONVERTERS FED AT LOCATION
A0A B0A D0A	0-12-00 0-12-06 0-12-12 0-12-18	A1A B1A D1A	1-12-00 1-12-06 1-12-12 1-12-18
A0B B0B D0B	0-12-24 0-12-30 0-12-36 0-12-42	A1B B1B D1B	1-12-24 1-12-30 1-12-36 1-12-42
A0C B0C D0C	0-17-24 0-17-30 0-17-36 0-17-39 0-17-42 0-17-45	A1C B1C D1C	1-17-24 1-17-30 1-17-36 1-17-39 1-17-42 1-17-45
A0D B0D D0D	0-17-00 0-17-06 0-17-12 0-17-18	A1D B1D D1D	1-21-04
A0E B0E D0E	0-21-40	A1E B1E D1E	1-21-40
BA	0-80-26	CA	1-80-26

TABLE B			
FUSE BAY 0	CIRCUIT PACKS FED AT LOCATION	FUSE BAY 1	CIRCUIT PACKS FED AT LOCATION
C0A	036-05 to 036-08 036-18 to 036-21	C1A	136-05 to 136-08 136-18 to 136-21
C0B	036-24 to 036-27 036-37 to 036-40	C1B	136-24 to 136-27 136-37 to 136-40
C0C	044-05 to 044-08 044-18 to 044-21	C1C	144-05 to 144-08 144-18 to 144-21
C0D	044-24 to 044-27 044-37 to 044-40	C1D	144-24 to 144-27 144-37 to 144-40
C0E	052-05 to 052-08 052-18 to 052-21	C1E	152-05 to 152-08 152-18 to 152-21
C0F	052-24 to 052-27 052-37 to 052-40	C1F	152-24 to 152-27 152-37 to 152-40
C0G	060-05 to 060-08 060-18 to 060-21	C1G	160-05 to 160-08 160-18 to 160-21
C0H	060-24 to 060-27 060-37 to 060-40	C1H	160-24 to 160-27 160-37 to 160-40
AB	068-40		



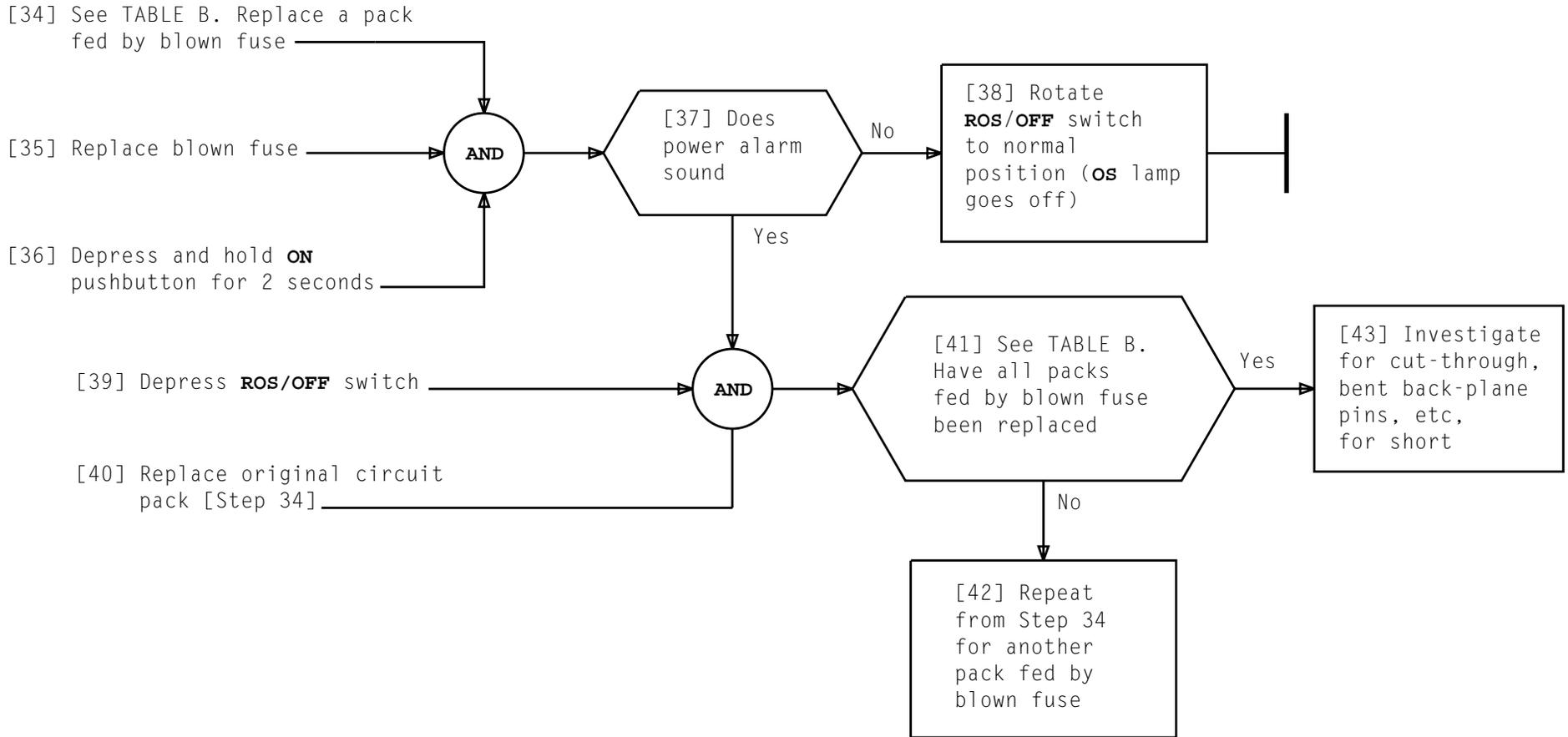
CLEAR BLOWN FUSE, SD-4A012-01 FRAME

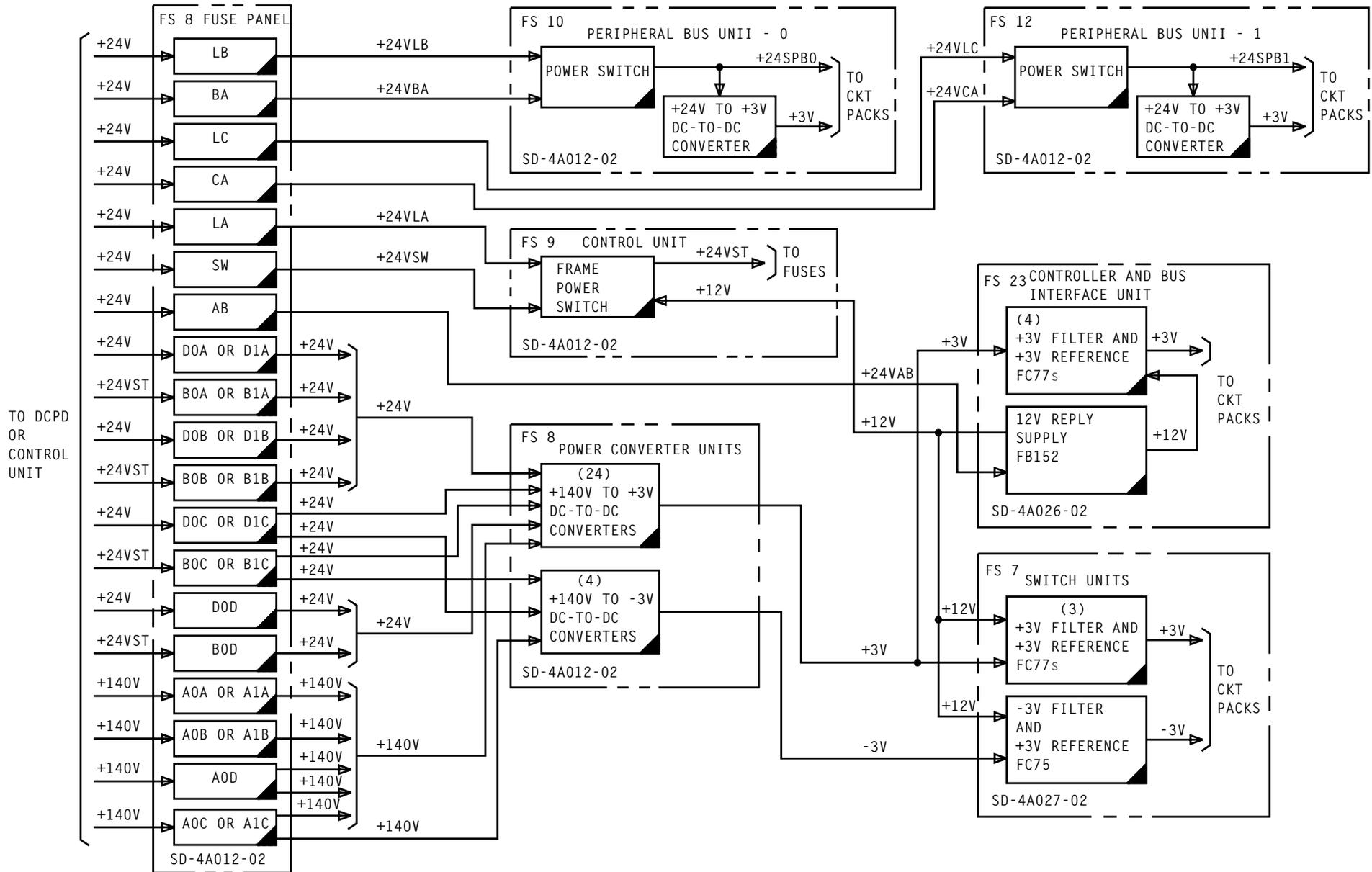
Issue 6	JAN 1997
234-151-011	TAP
PAGE 3 of 5	114



CLEAR BLOWN FUSE, SD-4A012-01 FRAME

Issue 6	JAN 1997
234-151-011	TAP
PAGE 4 of 5	114





FUSING AND POWER FOR SD-4A012-02 FRAME

Copyright ©1986 AT&T - All Rights Reserved

Issue 6	JAN 1997
234-151-011	ISD
PAGE 1 of 1	115

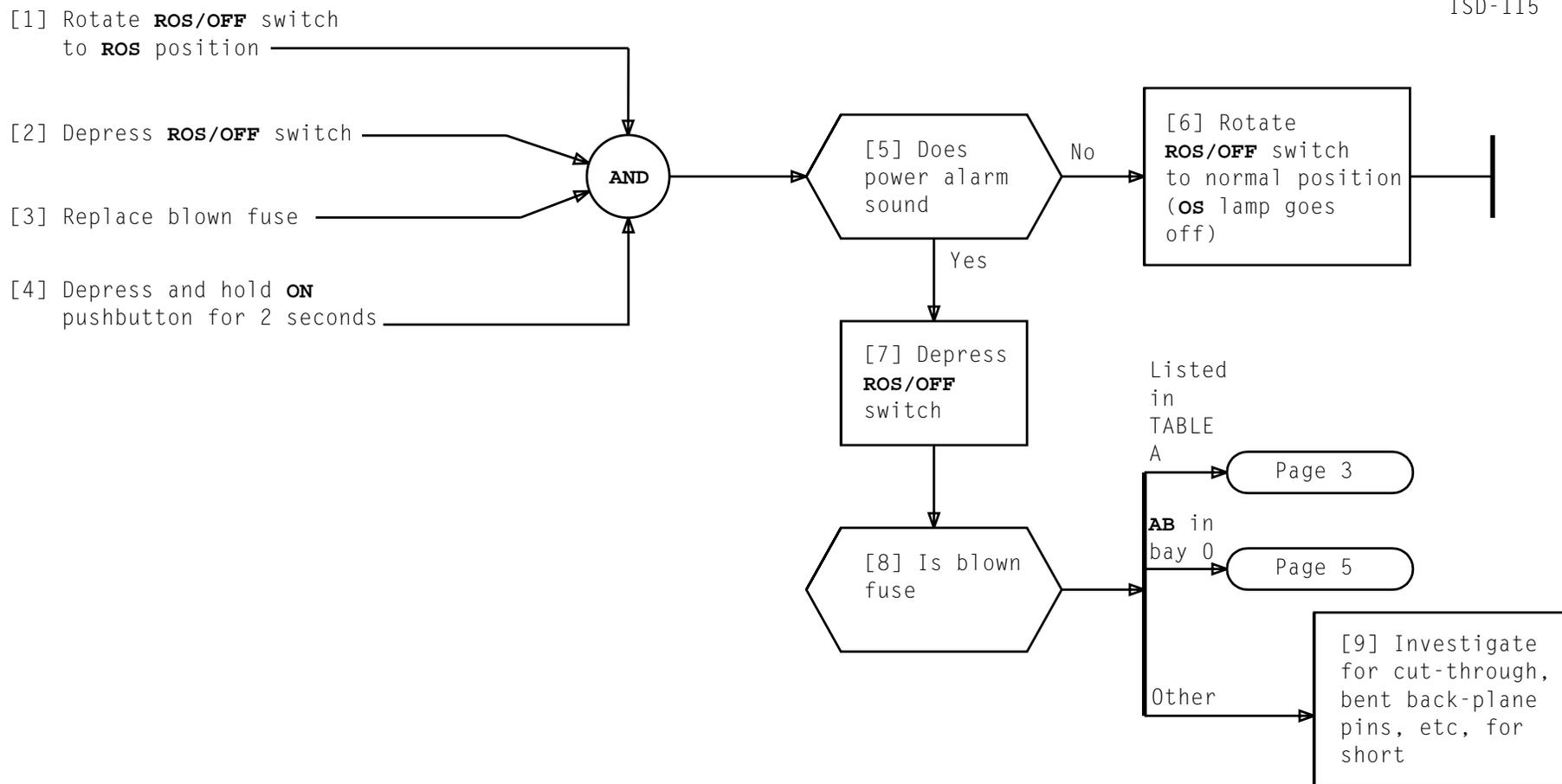


TABLE A			
FUSE BAY 0	CONVERTERS FED AT LOCATION	FUSE BAY 1	CONVERTERS FED AT LOCATION
A0A	0-12-00	A1A	1-12-00
B0A	0-12-06	B1A	1-12-06
D0A	0-12-12	D1A	1-12-12
	0-12-18		1-12-18
A0B	0-12-24	A1B	1-12-24
B0B	0-12-30	B1B	1-12-30
D0B	0-12-36	C1B	1-12-36
	0-12-42		1-12-42
A0C	0-17-24	A1C	1-17-24
B0C	0-17-30	B1C	1-17-30
D0C	0-17-36	D1C	1-17-36
	0-17-42		1-17-42
A0D	0-17-00	CA	1-80-26
B0D	0-17-06		
D0D	0-17-12		
	0-17-18		
BA	1-80-26		

[10] See TABLE A. Remove fuses associated with converters fed by blown fuse

[11] See TABLE A. Unseat converters fed by blown fuse

[12] Replace fuses

[13] Depress and hold **ON** pushbutton for 2 seconds

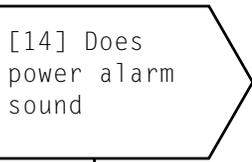
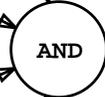
[16] Depress **ROS/OFF** switch

[17] See TABLE A. Remove fuses associated with converters fed by blown fuse

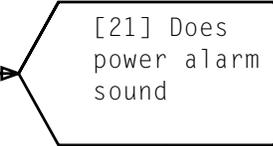
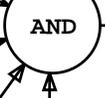
[18] Seat one converter

[19] Replace fuses

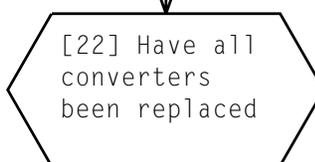
[20] Depress and hold **ON** pushbutton for 2 seconds



[15] Depress **ROS/OFF** switch and investigate for cut-throughs, bent back-plane pins, etc. for short



Page 4

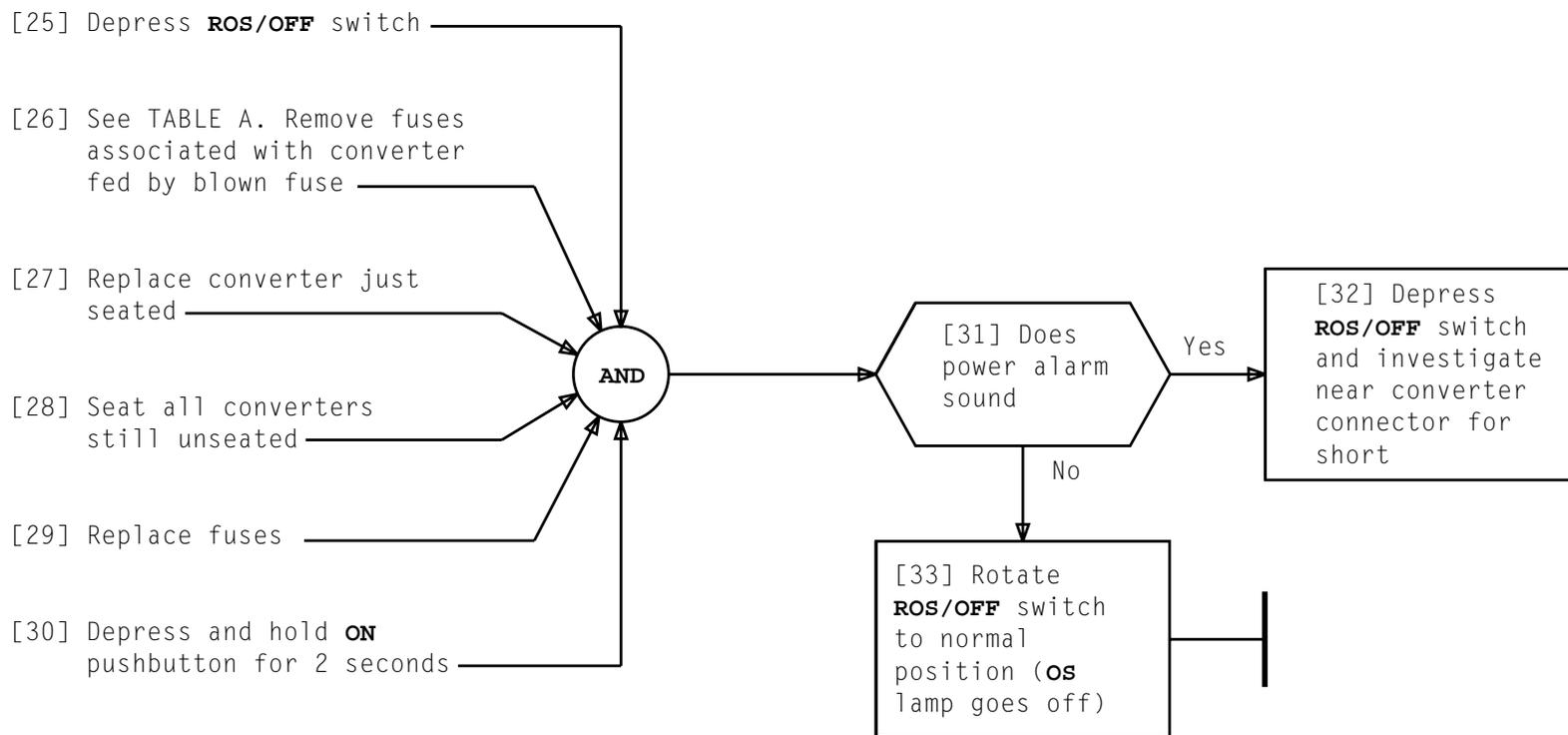


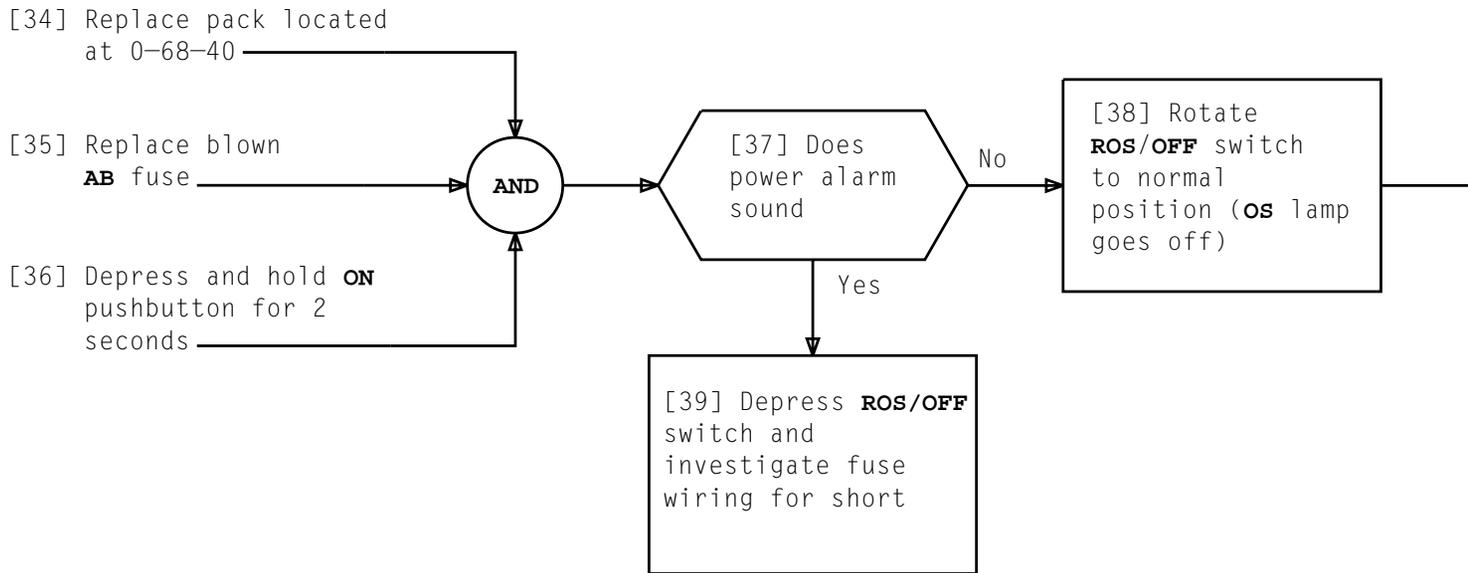
[24] Rotate **ROS/OFF** switch to normal position (**OS** lamp goes off)

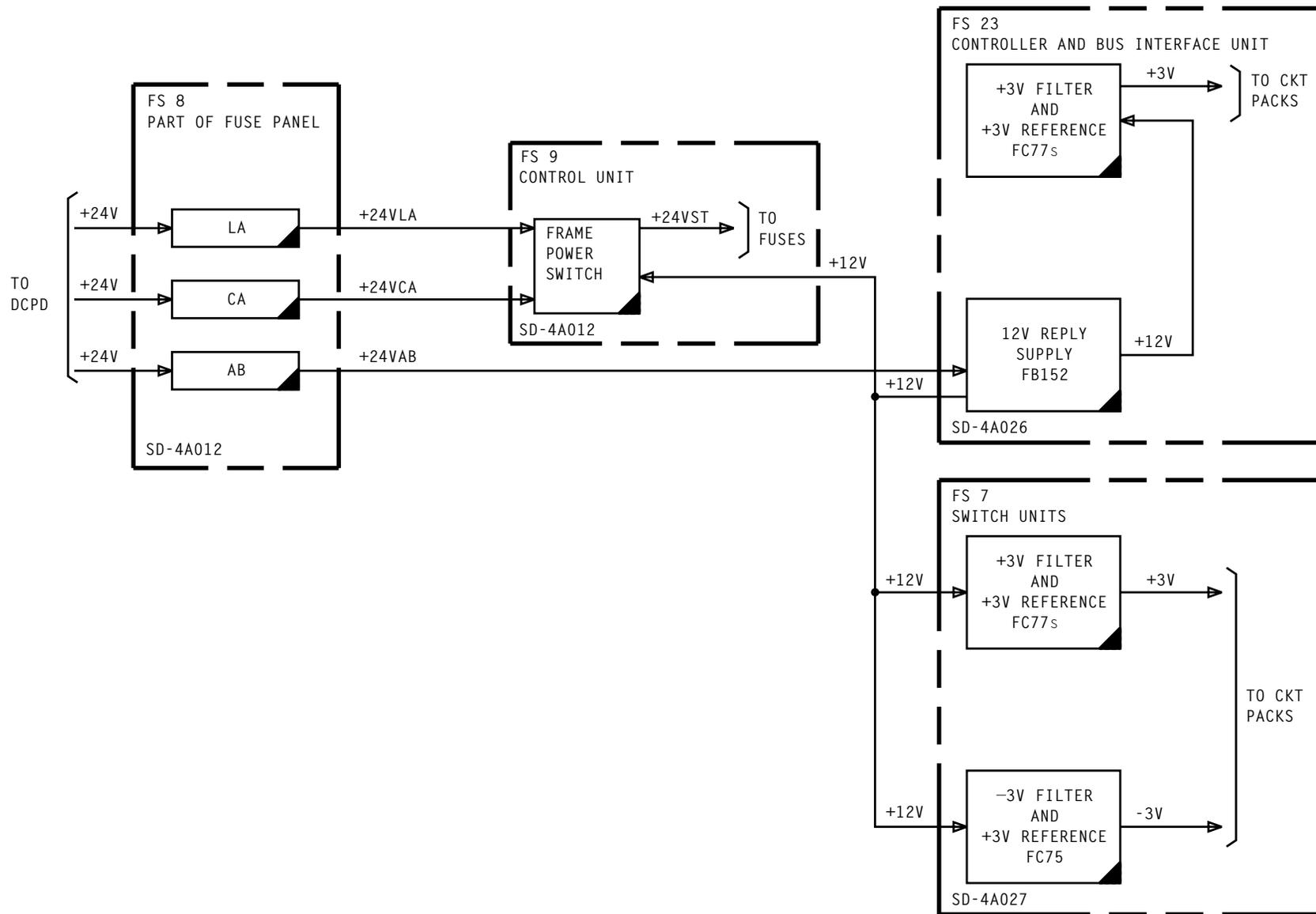
[23] Repeat from Step 16

CLEAR BLOWN FUSE, SD-4A012-02 FRAME

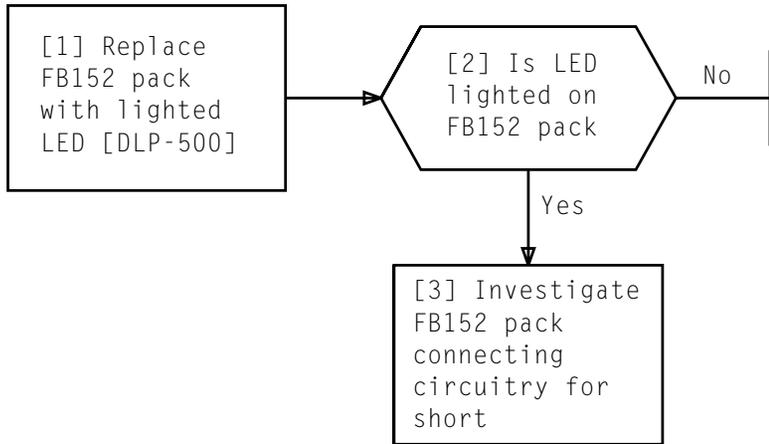
Issue 6	JAN 1997
234-151-011	TAP
PAGE 3 of 5	116





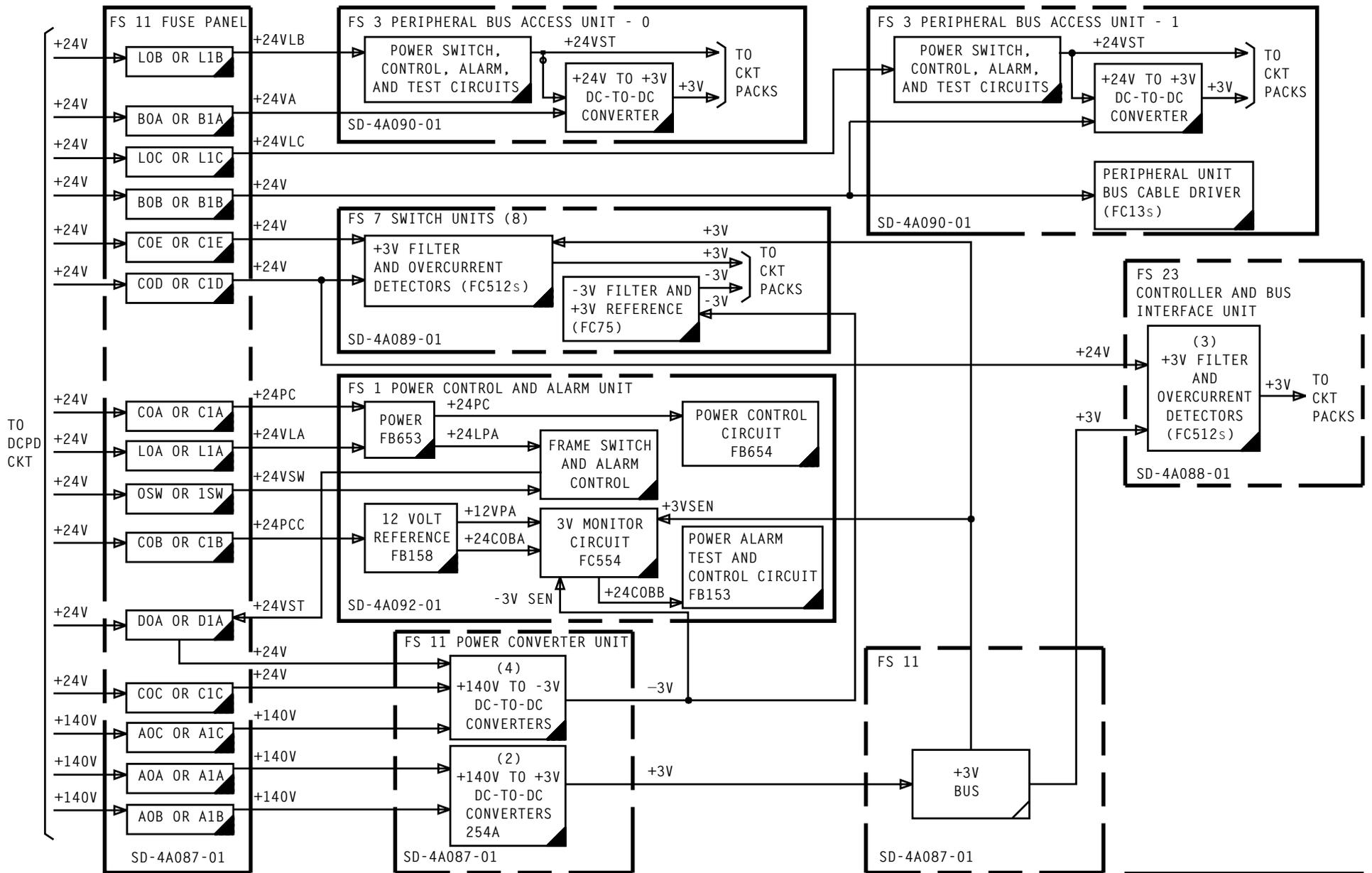


**FUSING AND POWER FOR FB152 PACK
SD-4A012-01 AND SD-4A012-02 FRAMES**



**CLEAR FB152 PACK LED LIGHTED CONDITION
SD-4A012-01 AND SD-4A012-02 FRAME**

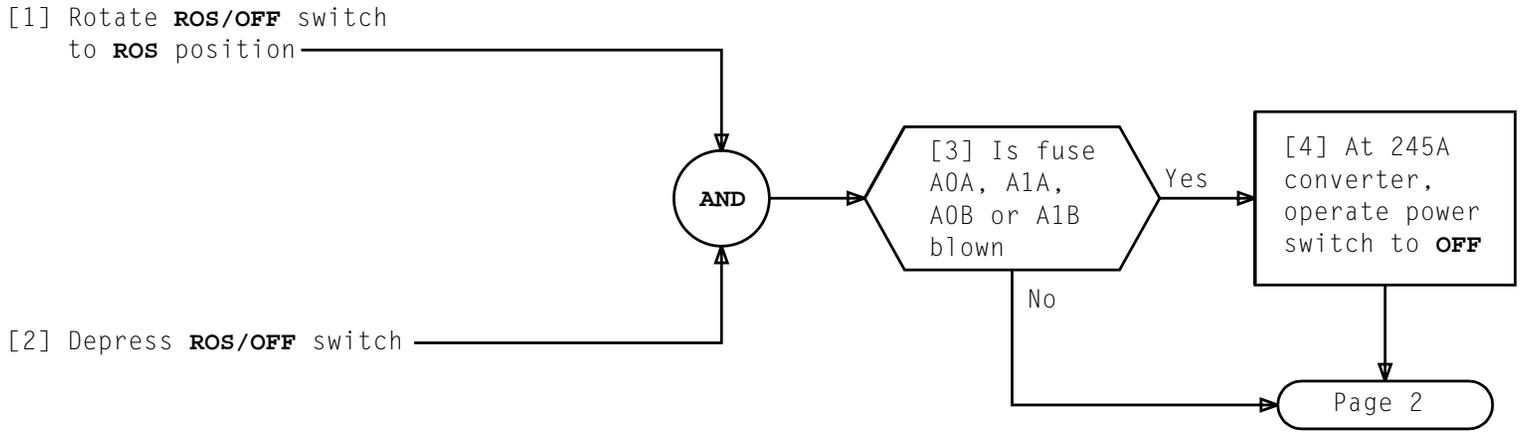
Issue 6	JAN 1997
234-151-011	TAP
PAGE 1 of 1	118



FUSING AND POWER FOR SD-4A087-01 FRAME

Copyright ©1986 AT&T - All Rights Reserved

Issue 6	JAN 1997
234-151-011	ISD
PAGE 1 of 1	119



CLEAR BLOWN FUSE, SD-4A087-01 FRAME

Issue 6	JAN 1997
234-151-011	TAP
PAGE 1 of 6	120

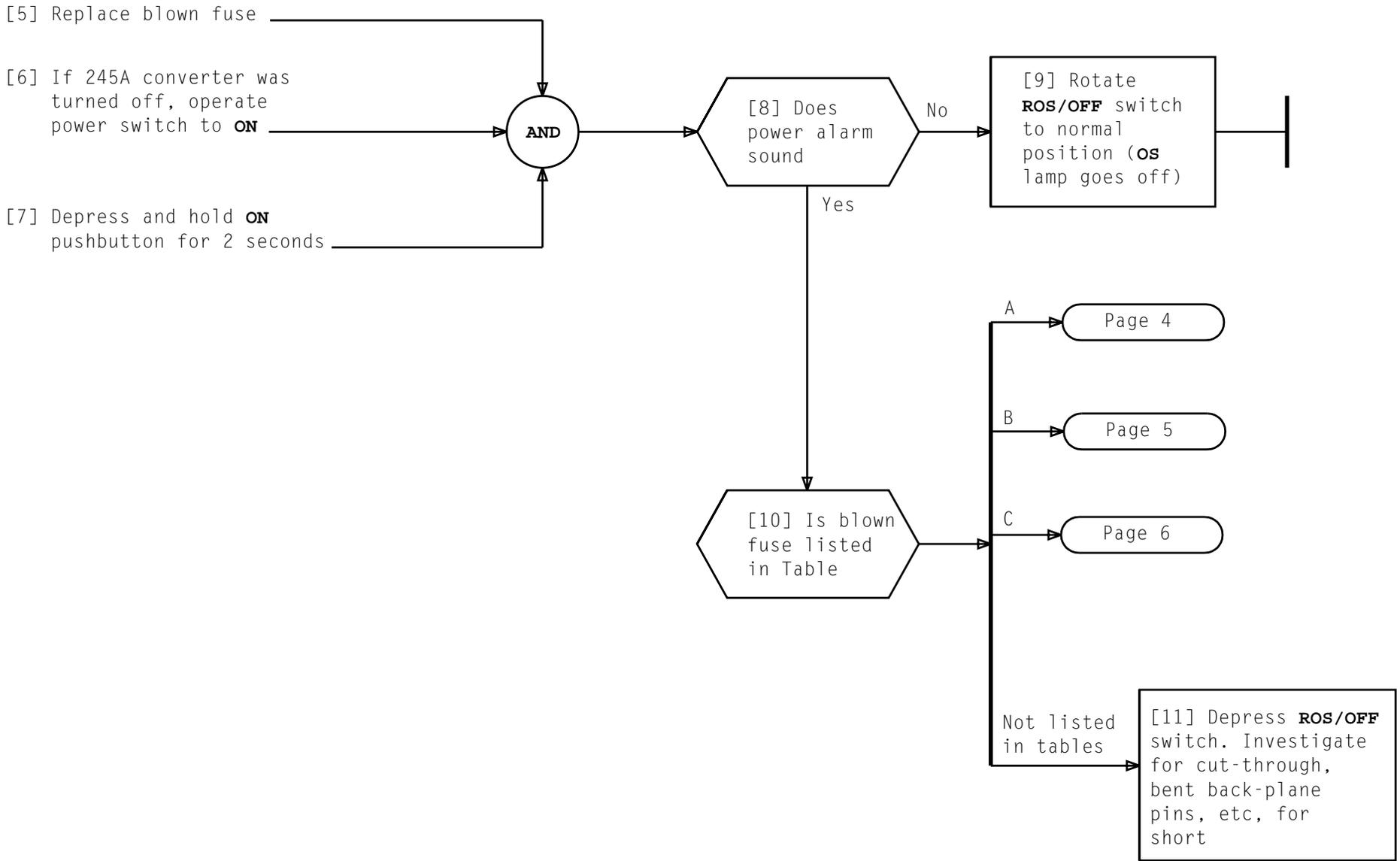
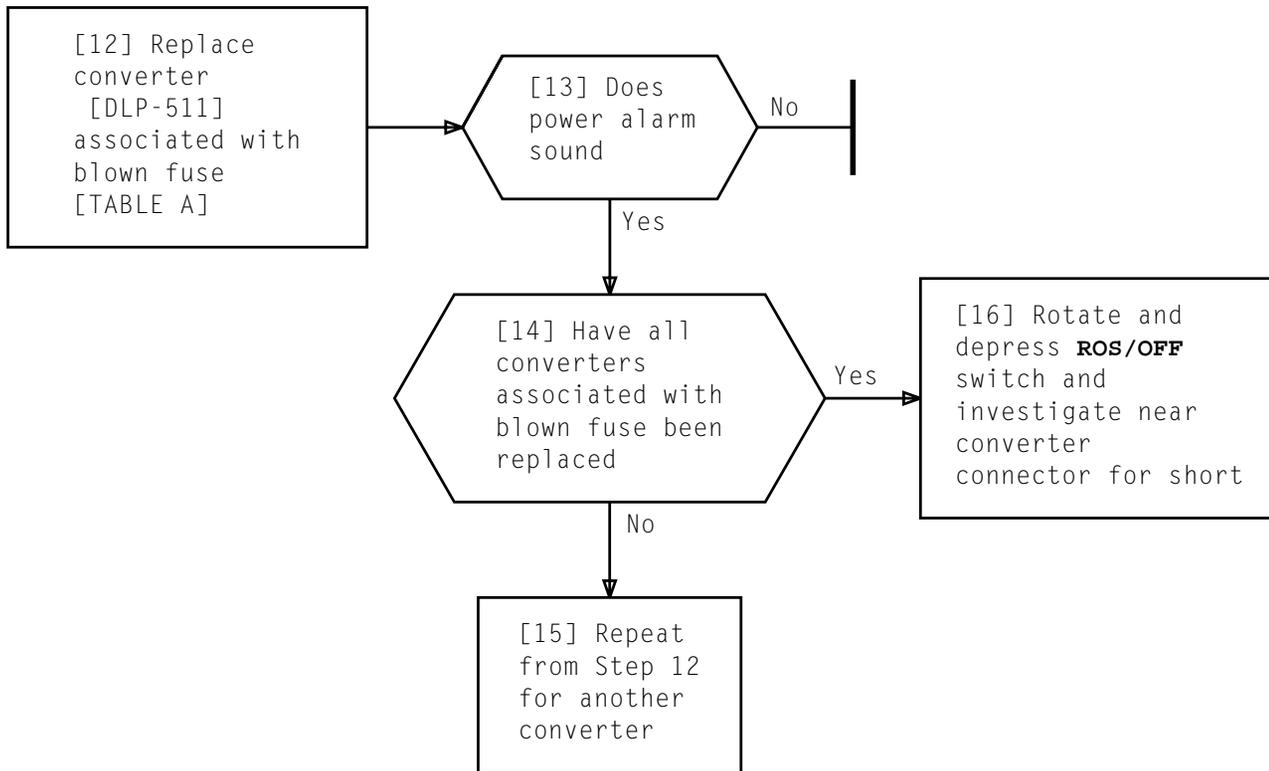
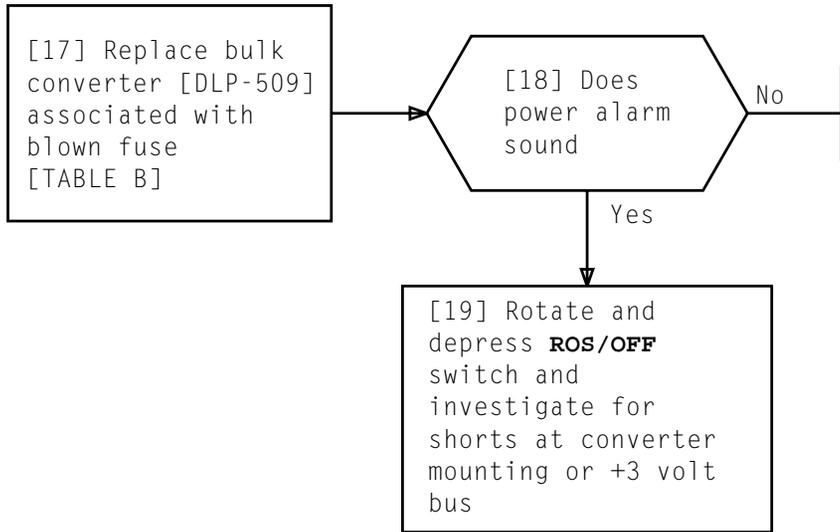


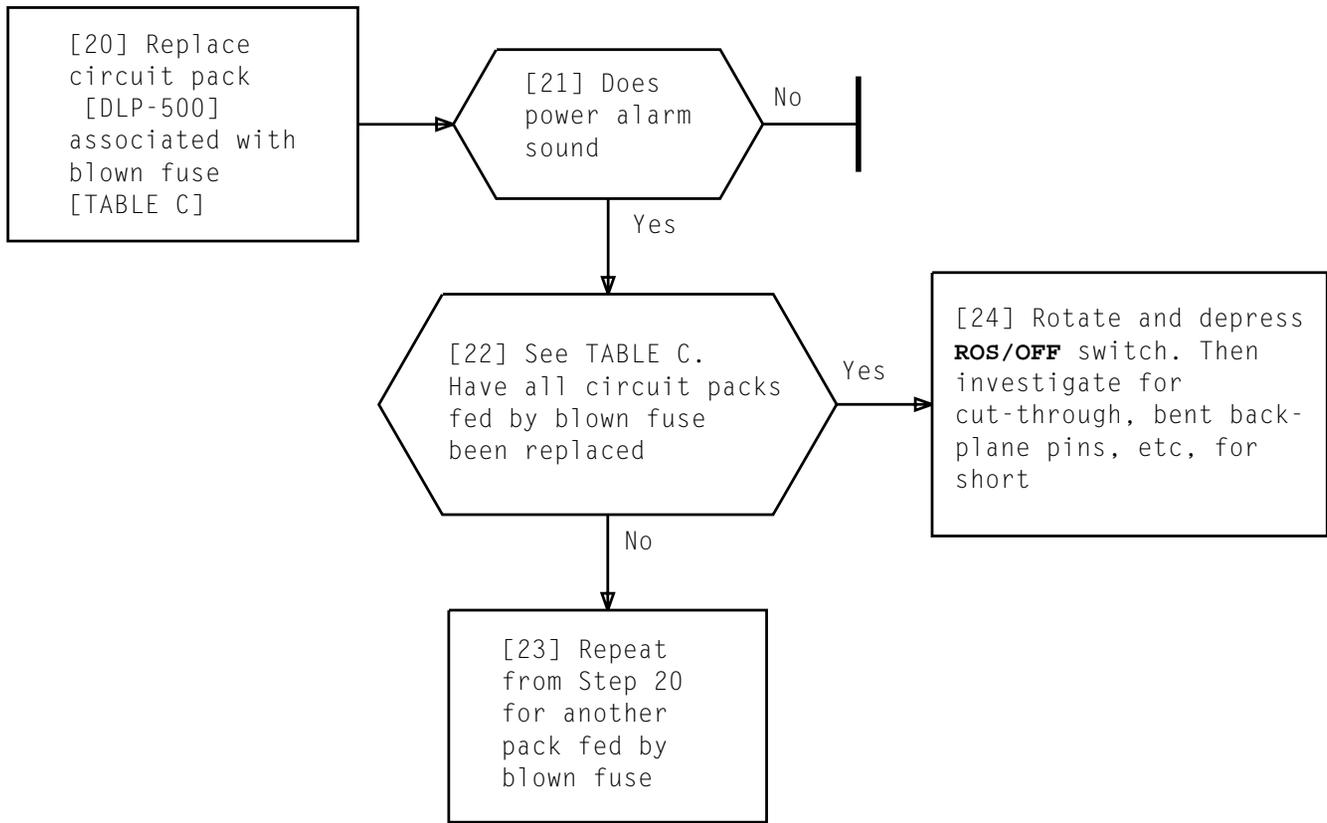
TABLE A			
FUSE BAY 0	NONBULK CONVERTERS FED AT LOCATION	FUSE BAY 1	NONBULK CONVERTER FED AT LOCATION
LOC	0-80-36	L1C	1-80-36
LOB	0-76-36	L1B	1-76-36
A0C	0-14-24	A1C	1-14-24
	0-14-30		1-14-30
C0C	0-14-36	C1C	1-14-36
	0-14-42		1-14-42
*BOA	0-76-36	*B1A	1-76-36
*BOB	0-80-36	*B1B	1-80-36
* Also Feeds FC13 Circuit Packs in TABLE C			

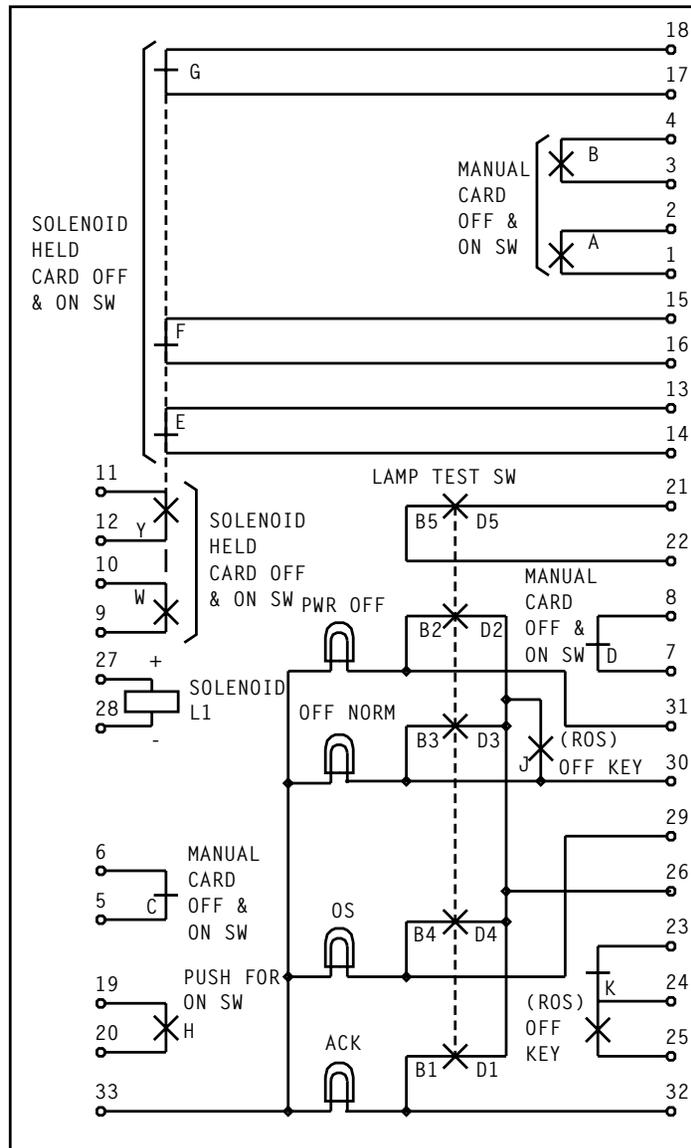
TABLE B			
FUSE BAY 0	BULK CONVERTERS FED AT LOCATION	FUSE BAY 1	BULK CONVERTER FED AT LOCATION
A0A	0-14-12	A1A	1-14-12
A0B	0-14-60	A1B	1-14-60

TABLE C			
FUSE BAY 0	CIRCUIT PACKS FED AT LOCATION	FUSE BAY 1	CIRCUIT PACK FED AT LOCATION
COA	044-26, 044-29	C1A	144-26, 144-29
LOA	044-26	L1A	144-26
COD	024-20, 028-20, 034-20, 040-20, 046-20, 052-20, 058-20, 064-20, 068-15, 068-56, 072-56	C1D	124-20, 128-20, 134-20, 140-20, 146-20, 152-20, 158-20, 164-20, 168-15, 168-56, 172-56
COE	024-52, 028-52, 034-52, 040-52, 046-52, 052-52, 058-52, 064-52	C1E	124-52, 128-52, 134-52, 140-52, 146-52, 152-52, 158-52, 164-52
COB	044-28 to 044-34	C1B	144-24 to 144-34
*BOA	076-14, 16, 18, 20	*B1A	176-14, 16, 18, 20
*BOB	080-14, 16, 18, 20	*B1B	180-14, 16, 18, 20
* Also feeds nonbulk converters in TABLE A			









POWER SWITCH

Issue 6	JAN 1997
234-151-011	TAD
PAGE 1 of 1	121

[1] Type in
 DGN:TMSP a,{CONTR b|COIPUB c|CIIPUB d}:TLP!
 a = failing TMS member number
 b = failing controller member number
 c = failing IPUB member number
 d = failing IPUB member number

[2] Did TLP
 abort message
 recur

Yes

[3] Clear diagnostic
 failure by analyzing
 raw data and
 replacing any suspect
 packs [TAP-102]

No

[4] See NOTE 1.
 Is printed
 reponse

SUSPECTED
 FAULTY
 EQUIPMENT

[6] Clear diagnostic
 failure by replacing
 packs on equipment
 list [TAP-101]

NULL PACK
 TEST GENERATED

[5] Clear diagnostic
 failure by analyzing
 raw data and
 replacing any suspect
 packs [TAP-102]

NOTE 1
 It may take several
 minutes for list
 to be printed.
 Status of file may
 be monitored by
 typing in
 OP:TLPQUEUE;ALL!
 TLP file currently
 being processed is
 indicated by an
 asterisk in priority
 column

Issue 6	JAN 1997
234-151-011	TAP
PAGE 1 of 1	122

CLEAR DIAGNOSTIC FAILURE, TLP ABORT

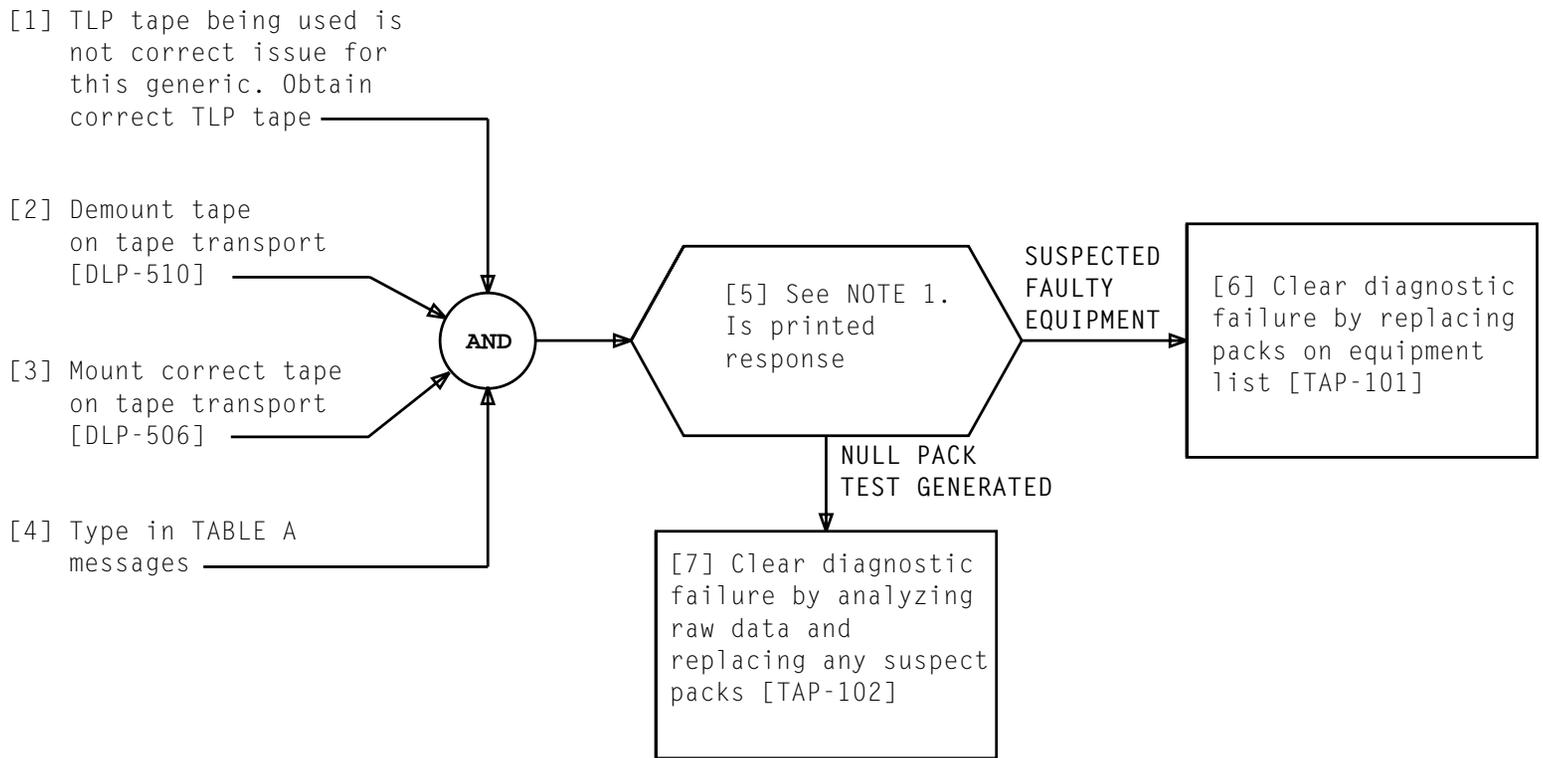


TABLE A
SET:TUC a;FUNCTION TLP!
ALW:TUC a:RO!
ALW:TLP:SRCH, TMSP!
DGN:TMSP b, {CONTR c COIPUB d C1IPUB e}:TLP!
a = member number of TUC with TLP tape mounted b = failing TMSP member number c = failing controller member number d = failing IPUB member number e = failing IPUB member number

NOTE 1
It may take several minutes for list to be printed. Status of your file may be monitored by typing in
OP:TLPQUEUE;ALL!
TLP file currently being processed is indicated by an asterisk in priority column

CLEAR DIAGNOSTIC FAILURE, TLP TAPE VERSION X DOES NOT MATCH VERSION Y

[1] TLP tape being used does not contain TMS data file. Obtain correct TLP tape

[2] Demount tape mounted on tape transport [DLP-510]

[3] Mount correct TLP tape on tape transport [DLP-506]

[4] Type in TABLE A messages

AND

[5] See NOTE 1. Is printed response

SUSPECTED FAULTY EQUIPMENT

[6] Clear diagnostic failure by replacing packs on equipment list [TAP-101]

NULL PACK TEST GENERATED

[7] Clear diagnostic failure by analyzing raw data and replacing any suspect packs [TAP-102]

TABLE A
SET:TUC a;FUNCTION TLP!
ALW:TUC a:RO!
ALW:TLP:SRCH, TMSP!
DGN:TMSPb, {CONTR c COIPUB d C1IPUB e}:TLP!
a = member number of TUC with TLP tape mounted b = failing TMSP member number c = failing controller member number d = failing IPUB member number e = failing IPUB member number

NOTE 1
It may take several minutes for list to be printed. Status of file may be monitored by typing in
OP:TLPQUEUE;ALL!
TLP file currently being processed is indicated by an asterisk in priority column

CLEAR DIAGNOSTIC FAILURE, TLP TAPE ACQUISITION ERROR

Issue 6	JAN 1997
234-151-011	TAP
PAGE 1 of 1	124

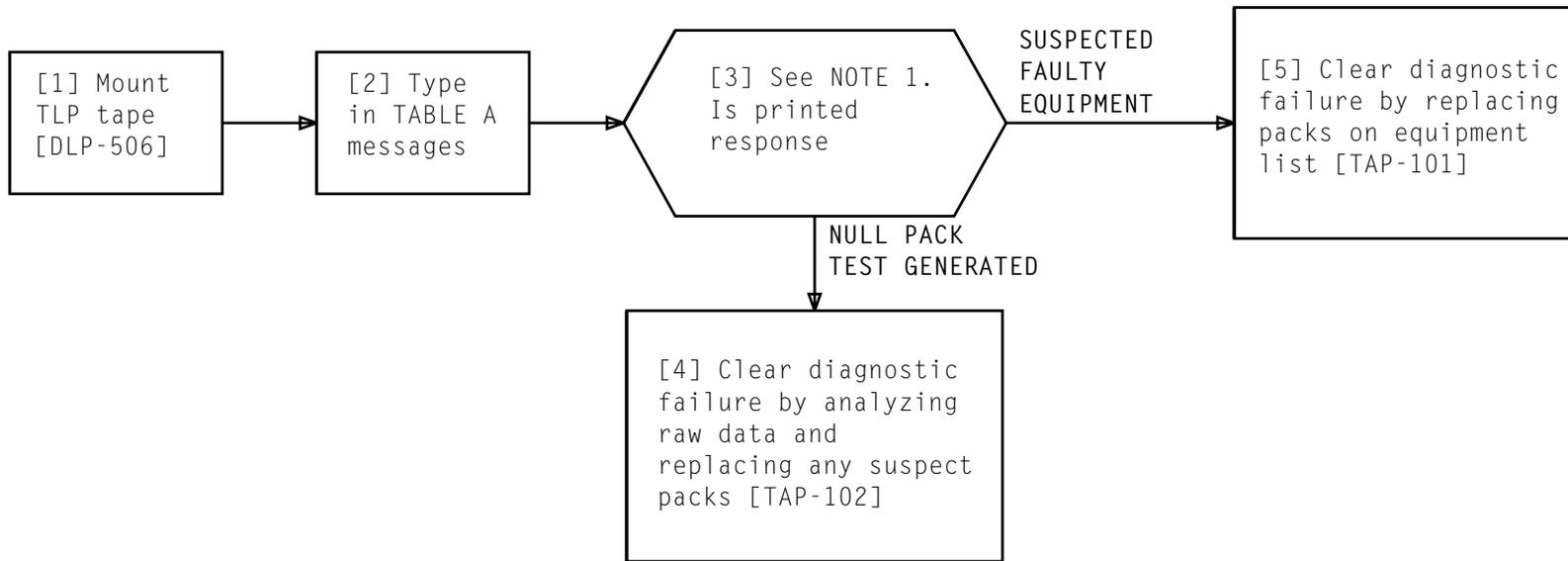
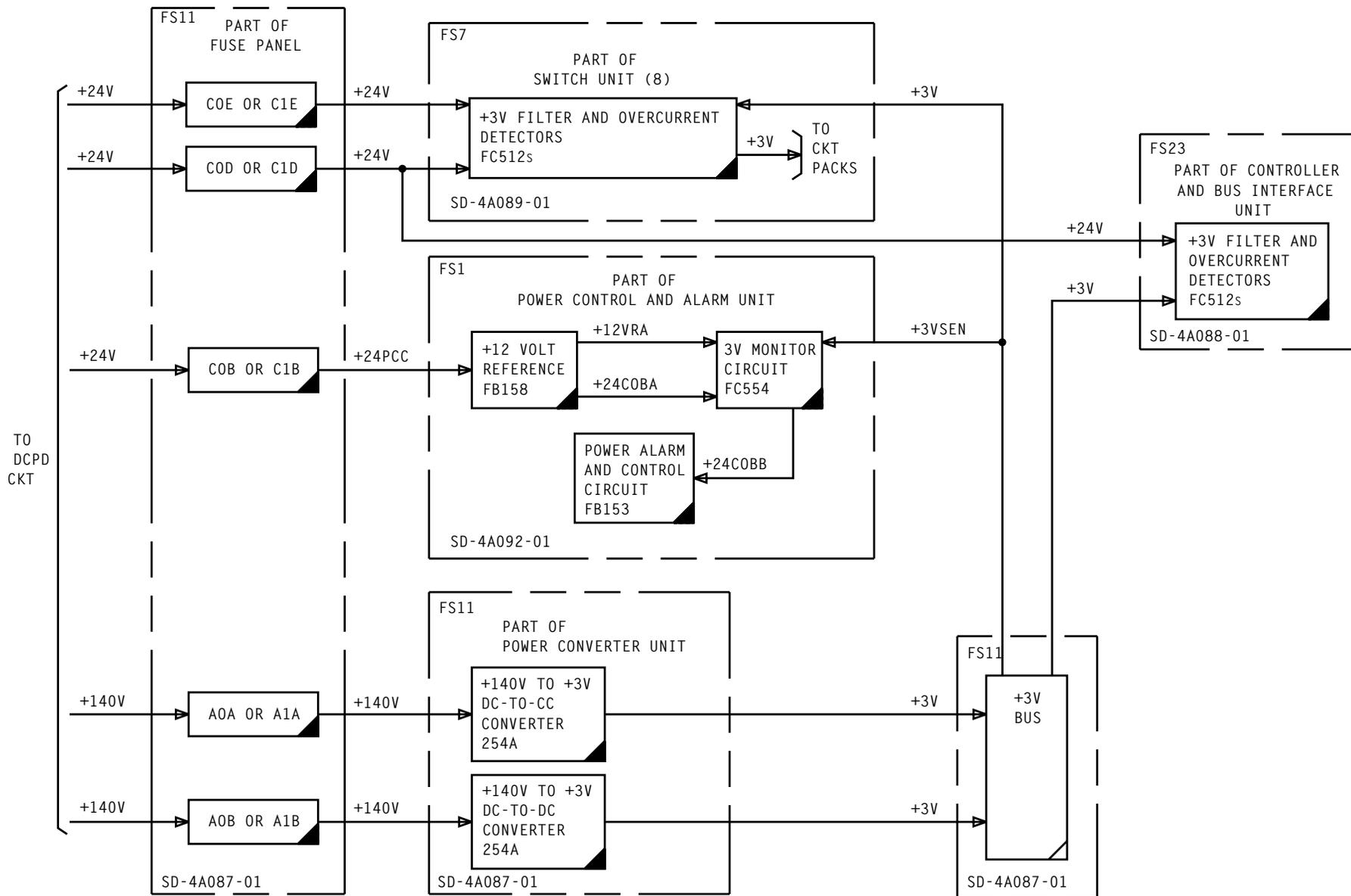


TABLE A
SET:TUC a;FUNCTION TLP!
ALW:TUC a:RO!
ALW:TLP:SRCH, TMSP!
DGN:TMSP b,{ CONTR c COIPUB d C1IPUB e}:TLP!
a = member number of TUC with TLP tape mounted b = failing TMS member number c = failing controller member number d = failing IPUB member number e = failing IPUB member number

NOTE 1
 It may take several minutes for list to be printed. Status of file may be monitored by typing in
OP:TLPQUEUE;ALL!
 TLP file currently being processed is indicated by an asterisk in priority column

Issue 6	JAN 1997
234-151-011	TAP
PAGE 1 of 1	125

CLEAR DIAGNOSTIC FAILURE, TLP TAPE NOT MOUNTED



POWER AND FUSING FOR BULK CONVERTER, FC554 PACK, AND FC512 PACK, SD-4A087-01 FRAME

Issue 6	JAN 1997
234-151-011	ISD
PAGE 1 of 1	126

[1] At power switch with **PWR OFF** lamp lighted, rotate and depress **ROS/OFF** switch

[2] See TABLE A. Use SD tables to identify packs getting power monitored by FC512 with lighted LED

[3] Unseat packs identified

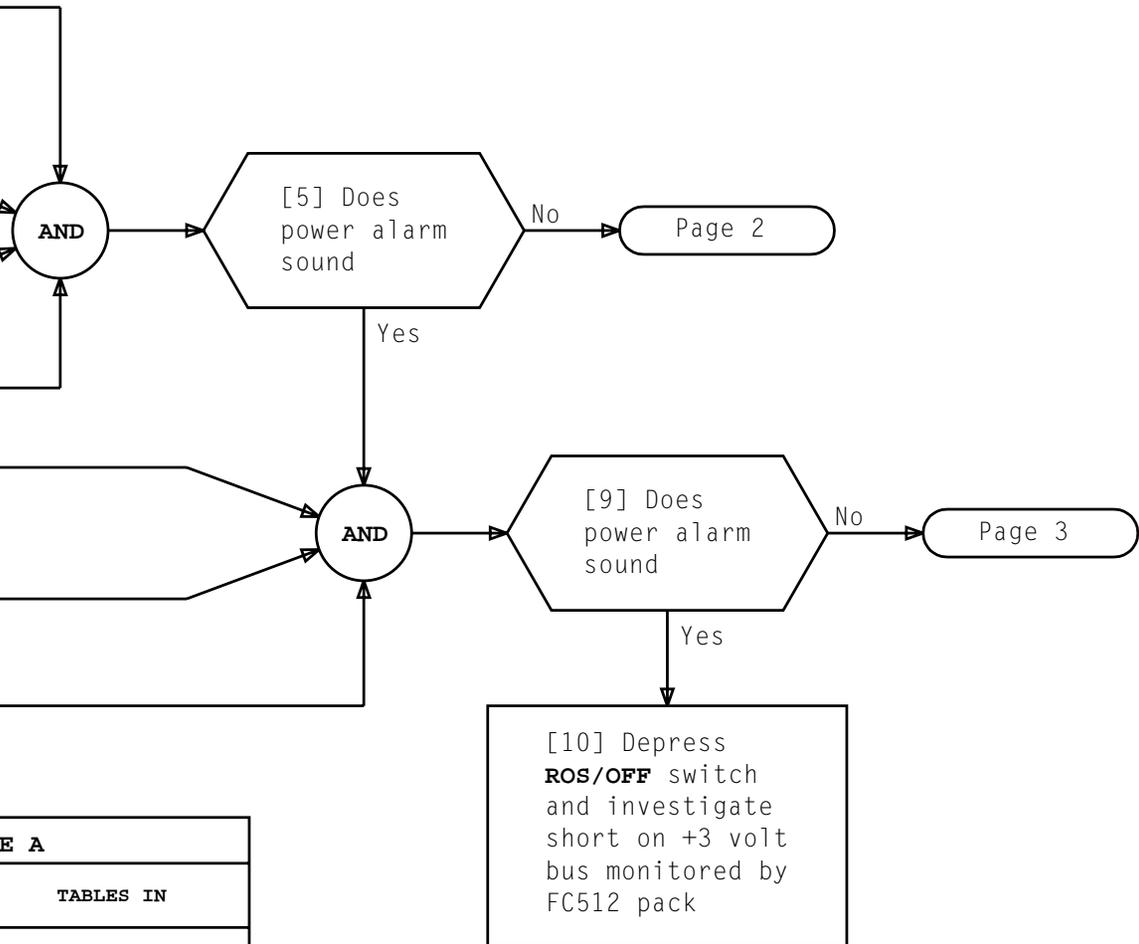
[4] Depress and hold **ON** pushbutton for 2 seconds

[6] Depress **ROS/OFF** switch

[7] Replace FC512 pack

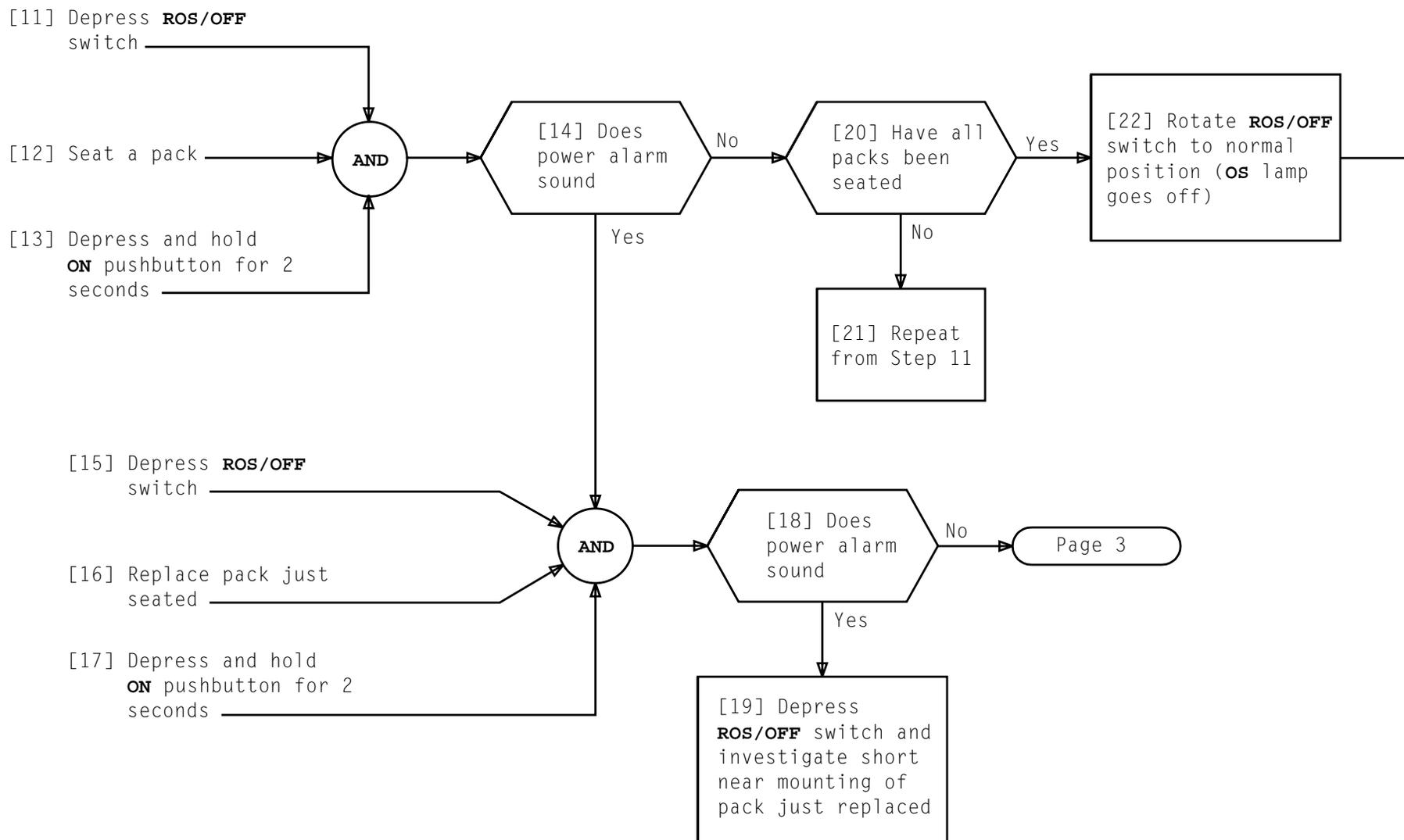
[8] Depress and hold **ON** pushbutton for 2 seconds

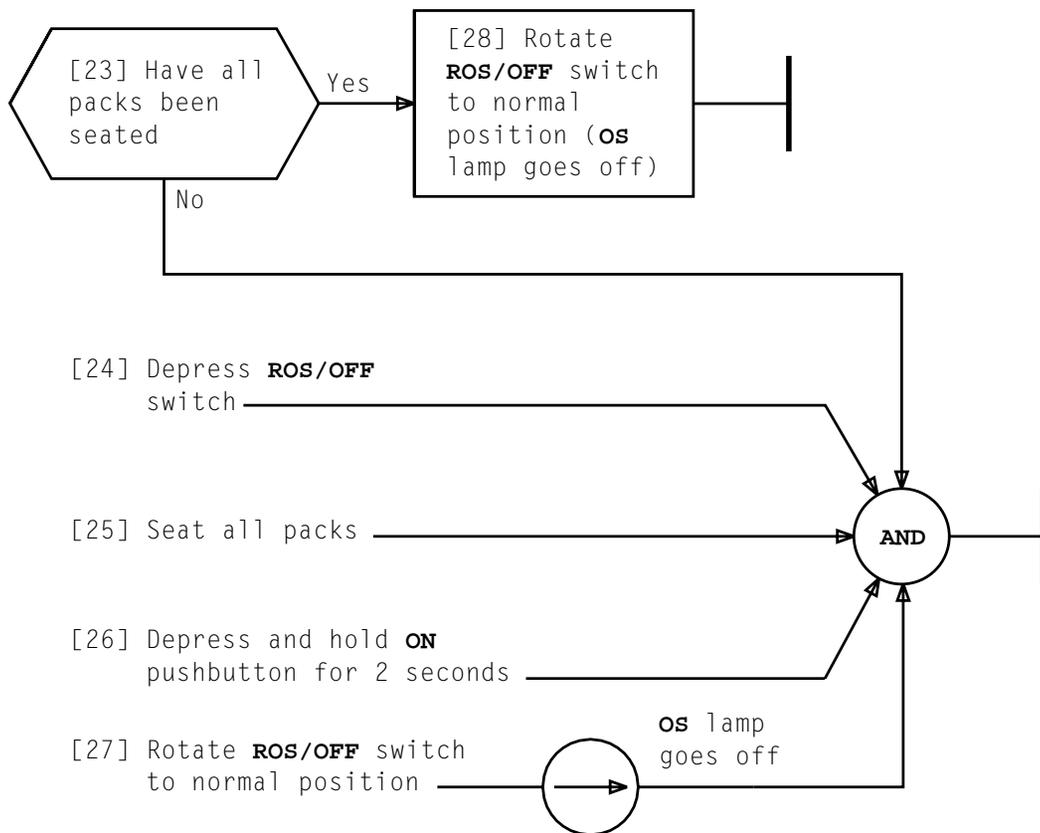
TABLE A	
FC512 LOCATION BAY 0 OR 1	TABLES IN
68-15, 68-56, 72-52	SD-4A088-01 FS23
All other FC512 location	SD-4A089-01 FS7



**CLEAR BULK CONVERTER, FC554 AND FC512 CIRCUIT PACKS
LED LIGHTED CONDITION, SD-4A087-01 FRAME**

Issue 6	JAN 1997
234-151-011	TAP
PAGE 1 of 3	127





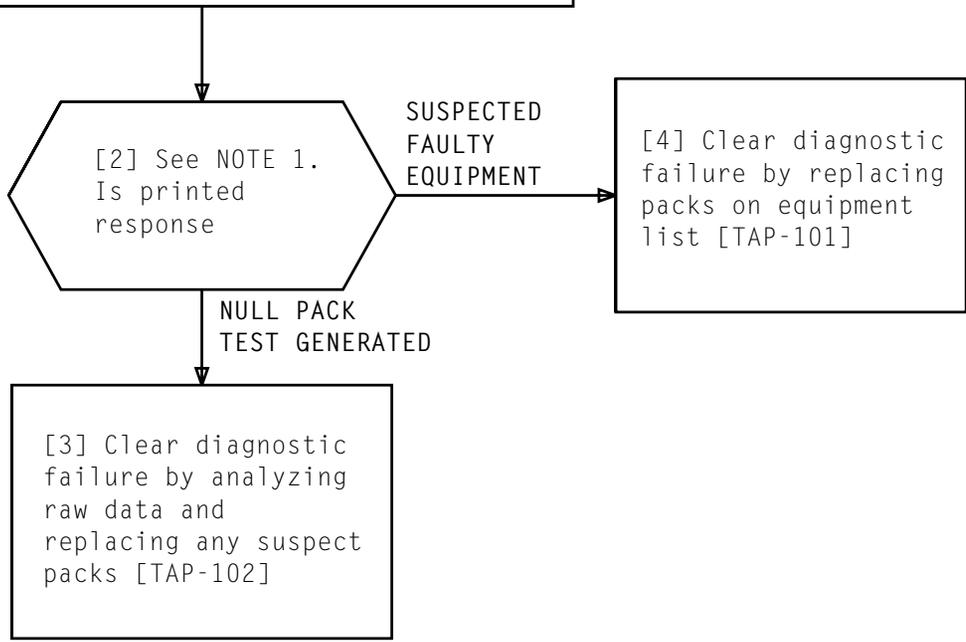
**CLEAR BULK CONVERTER, FC554 AND FC512 CIRCUIT PACKS
LED LIGHTED CONDITION, SD-4A087-01 FRAME**

```

[1] Type in
ALW:TLP:SRCH, TMSP!
DGN:TMSP a,{CONTR b|COIPUB c|C1IPUB d}:TLP!

a = failing TMS member number
b = failing controller member number
c = failing IPUB member number
d = failing IPUB member number

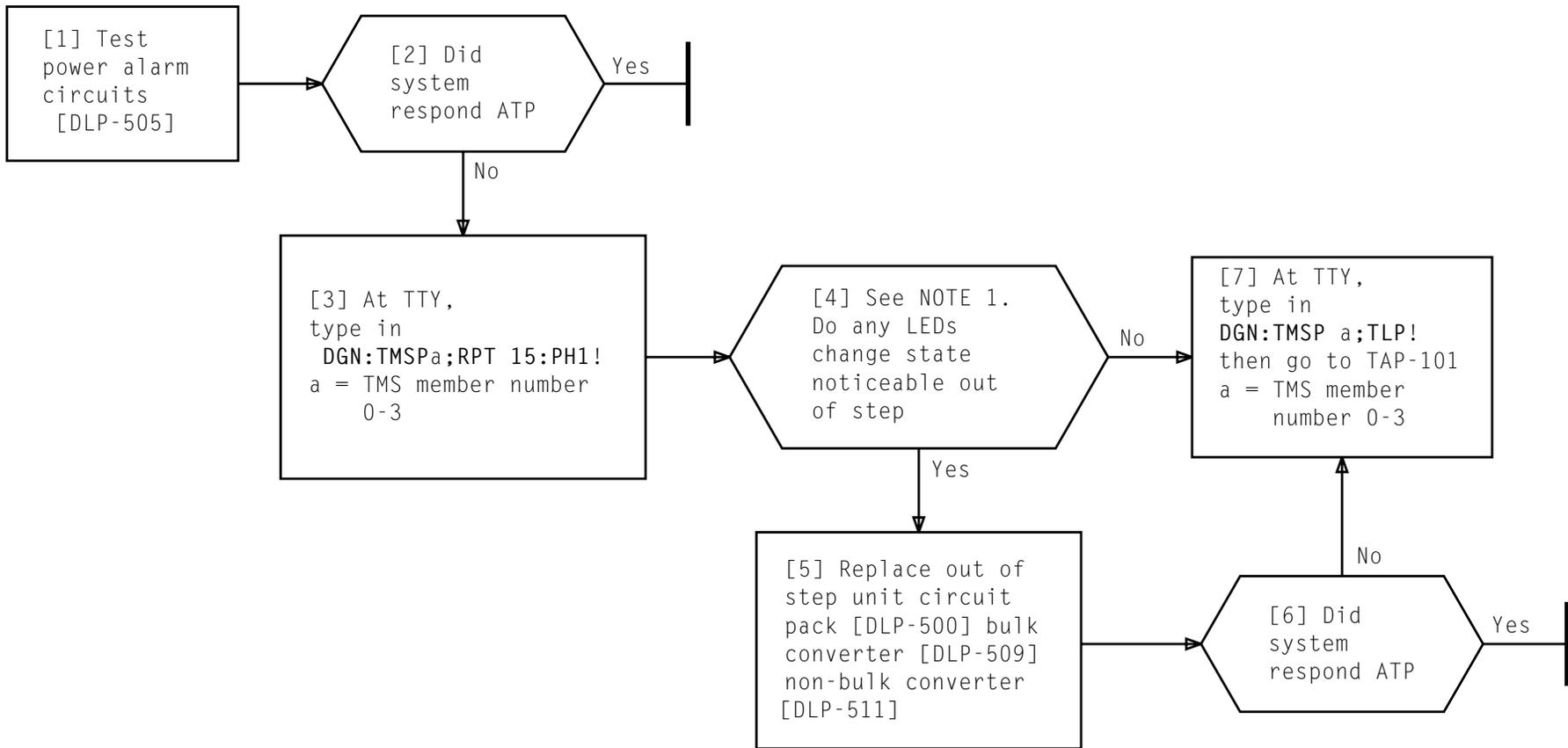
```



NOTE 1
It may take several minutes for list to be printed. Status of file may be monitored by typing in **OP:TLPQUEUE;ALL!** TLP file currently being processed is indicated by an asterisk in priority column

Issue 6	JAN 1997
234-151-011	TAP
PAGE 1 of 1	128

CLEAR DIAGNOSTIC FAILURE, TLP SEARCHES INHIBITED



NOTE 1 Normally, LEDs will not all change state simultaneously	
Issue 6	JAN 1997
234-151-011	TAP
PAGE 1 of 1	129

CLEAR AUTOMATIC POWER MONITOR TEST FAILURE

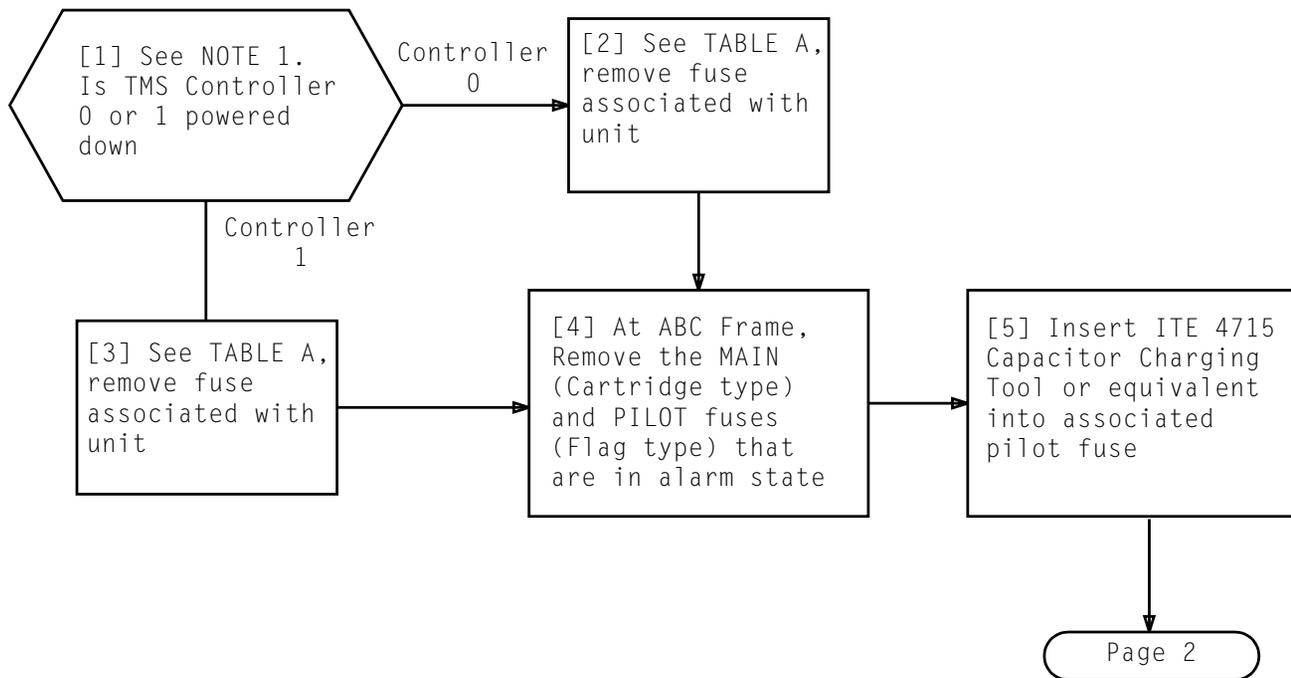
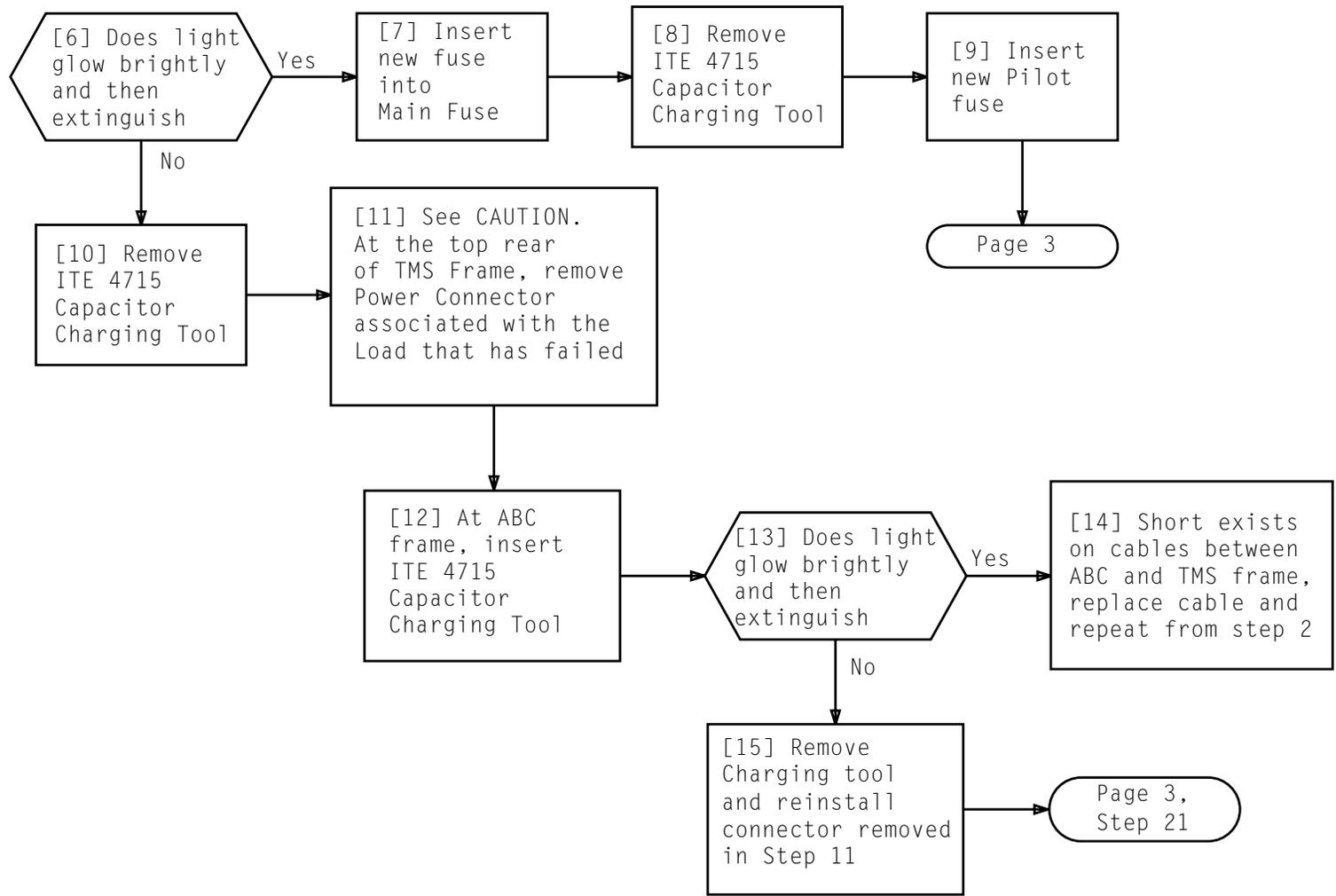


TABLE A				
	CONVERTER	LOCATION	FUSE	LOCATION
CONT 0	0COA	0-14-12	0A0A	007-13
	0COB	0-14-60	0A0B	
CONT 1	1COA	1-14-12	1A0A	107-13
	1COB	1-14-60	1A0B	

NOTE 1
It is assumed that an attempt has been made at the +140V Distribution Frame to restore power to TMS frame and charging lamp does not extinguish indicating short circuit exists, or charging lamp extinguishes but the LED on a given 245 type converter does not light indicating an open diode

Added

Issue 6	JAN 1997
234-151-011	TAP
PAGE 1 of 3	134

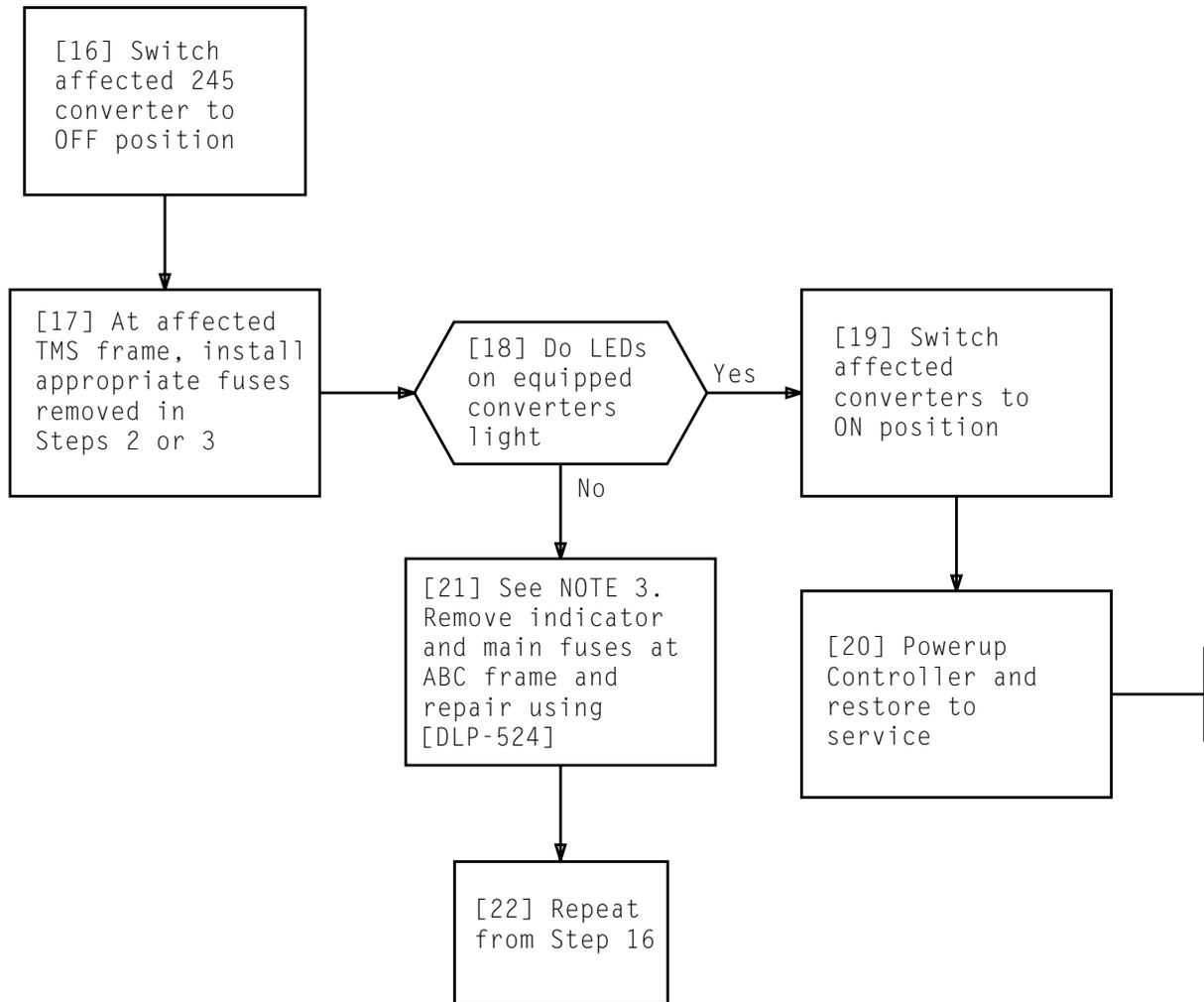


CAUTION
 Removing wrong connector will duplex fail TMS-B

Added

Issue 6	JAN 1997
234-151-011	TAP
PAGE 2 of 3	134

ISOLATE DEFECTIVE FILTER CIRCUIT TIME MULTIPLEX SWITCHING (TMS)



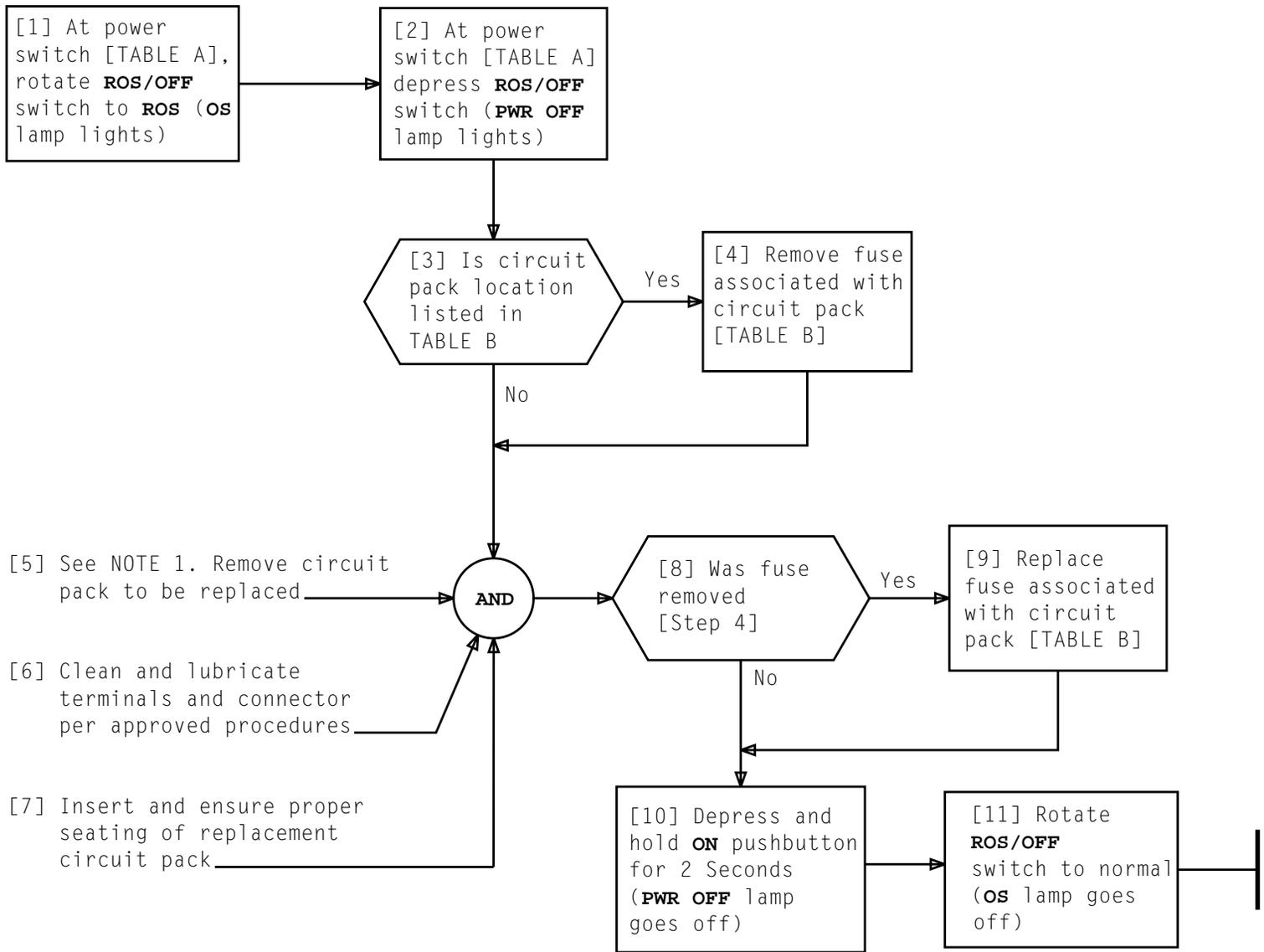
NOTES

2. If you have reached this point without replacing any frame components in the TMS bay, there are damaged filter circuit parts in the TMS bay. It is likely that a power failure will occur in the +140V circuitry again. It is recommended that the Filter Circuit components be replaced at the earliest convenience

3. If you have arrived here through Step 15, the initial indication is a shorted capacitor in the filter circuit. If you came from Step 18, the symptom is an open diode

Added

Issue 6	JAN 1997
234-151-011	TAP
PAGE 3 of 3	134



NOTE 1
 Packs designated FA632, FA633, and FA634 can be replaced with FA632B, FA633B, and FA634B packs, respectively. Packs designated FA632B, FA633B, and FA634B cannot be replaced with FA632, FA633, and FA634 packs

Issue 6	JAN 1997
234-151-011	DLP
PAGE 1 of 2	500

REPLACE PACK

TABLE A			
SD-4A012-01, 02			
CIRCUIT PACK LOCATIONS	POWER SWITCH		
	LOCATION	NAME	
0-80-01 to 0-80-14	0-80-29	IPUB0	
1-80-01 to 1-80-14	1-80-29	IPUB1	
All others	1-68-08	CONTR	
SD-4A087-01			
CIRCUIT PACK LOCATIONS	POWER SWITCH		
	LOCATION	NAME	
		BAY 0	BAY 1
*-80-14 to *-80-32	*-80-42	COIPUB1	C1IPUB1
*-76-14 to *-76-32	*-76-42	COIPUB0	C1IPUB0
All others	*-44-38	CONTR0	CONTR1
* Circuit Packs located in Bay 0 or Bay 1 are controlled, respectively, by switches located in Bay 0 and Bay 1			

TABLE B			
SD-4A012-01, 02			
CIRCUIT PACK LOCATIONS	FUSE		
	BLOCK LOCATION	NAME	
0-68-40	1-07-33	AB	
SD-4A087-01			
CIRCUIT PACK LOCATIONS	BLOCK LOCATION	NAME	
		BAY 0	BAY 1
	*-44-26	*-07-46	COA
*-44-28 to 44-34	*-07-46	COB	C1B
* Circuit Packs located in Bay 0 or Bay 1 are controlled, respectively, by fuses located in Bay 0 and Bay 1			

[1] See FIG. 1. On raw data printout for first failing test, locate last data word printed

[2] In first failing phase PIDENT, use last data word address to locate where first subroutine was called

[3] Read any comments at CALLSUB statement located

[4] Note name of subroutine called in CALLSUB statement label item

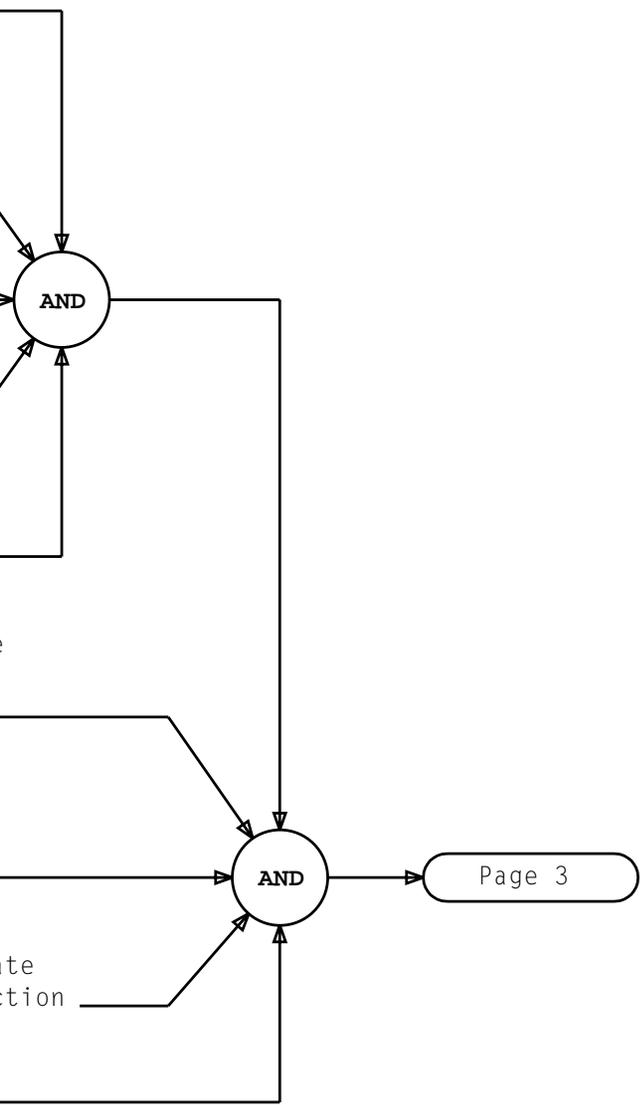
[5] Locate and read prologue of program unit containing CALLSUB

[6] In loader map symbols section, locate name of subroutine called in symbol column (name noted in Step 4)

[7] In PIDENT column, note PIDENT that contains this subroutine and obtain this PIDENT

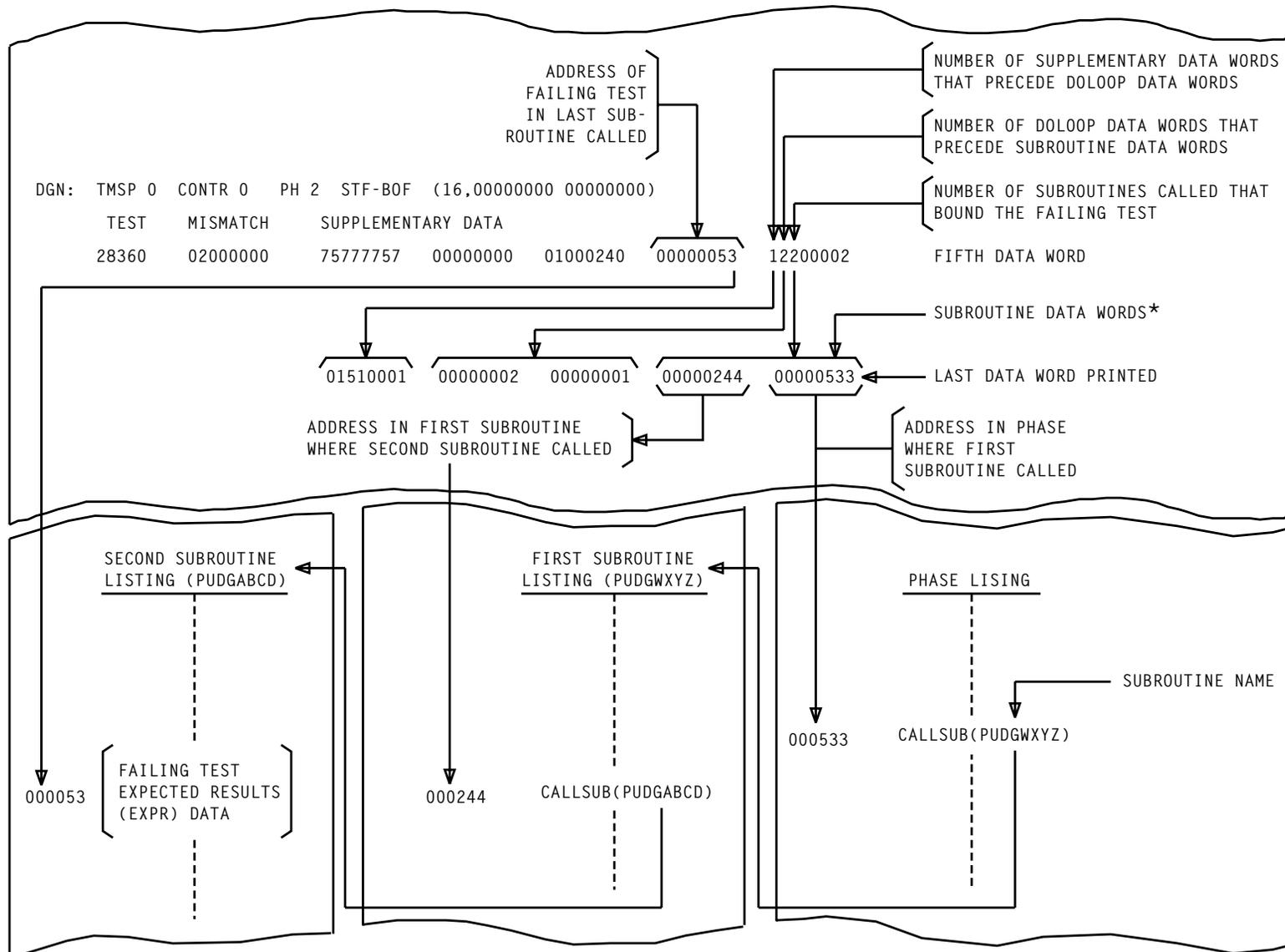
[8] In PIDENT containing subroutine, locate subroutine using PIDENT reference section

[9] Read subroutine prologue



DETERMINE LOCATION AND FUNCTION OF SUBROUTINES CALLED

Issue 6	JAN 1997
234-151-011	DLP
PAGE 1 of 3	501

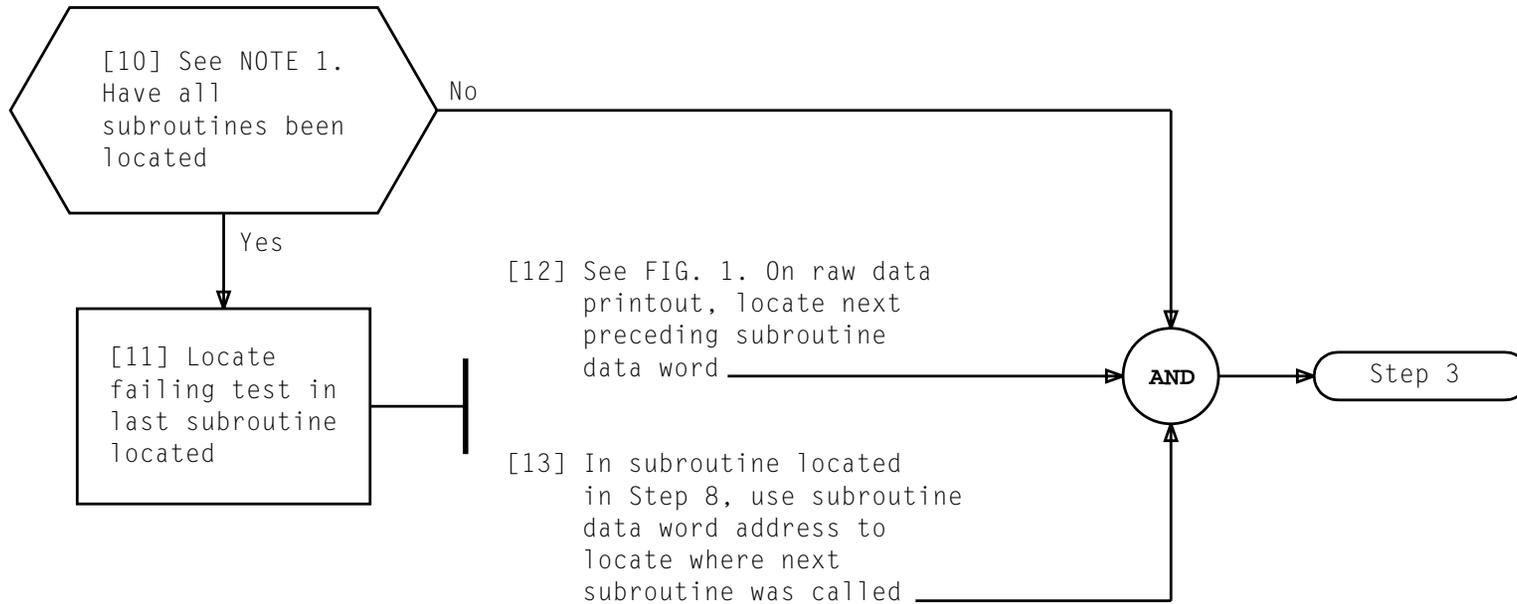


* SUBROUTINE DATA WORDS THAT PRECEDE THE LAST ONE PRINTED ARE FOR THE 2ND, 3RD, ETC, SUBROUTINES CALLED (RIGHT TO LEFT)

FIG. 1 - Relationship of Subroutine Data Words to Phase and Subroutine Listings

DETERMINE LOCATION AND FUNCTION OF SUBROUTINES CALLED

Issue 6	JAN 1997
234-151-011	DLP
PAGE 2 of 3	501



NOTE 1	
On raw data printout, sixth digit in fifth data word following mismatch data indicates number of subroutines called	
Issue 6	JAN 1997
234-151-011	DLP
PAGE 3 of 3	501

NOTE: Section 234-180-020 contains descriptions of dial statements

1. Read several DIAL statements just before failing test to determine what occurred prior to test failing
2. Read failing test DIAL statement and comments
3. Note "asterisk data" that follows failing test number in listing
4. See FIG. 1. Note relationship of asterisk line data to first five raw data printout words that follow mismatch data

5. In TABLE A, locate failing DIAL statement and use description column to determine meaning of data contained in second and third raw data words following mismatch data

NOTE: For scan point, SD point, and SP point addresses, third data word breaks down as follows:

23-17 = Don't care
 16-12 = SP number
 11-10 = Matrix
 09-04 = Row
 03-00 = Column

6. Use TABLE B to obtain additional information with respect to second and third data words

End of procedure

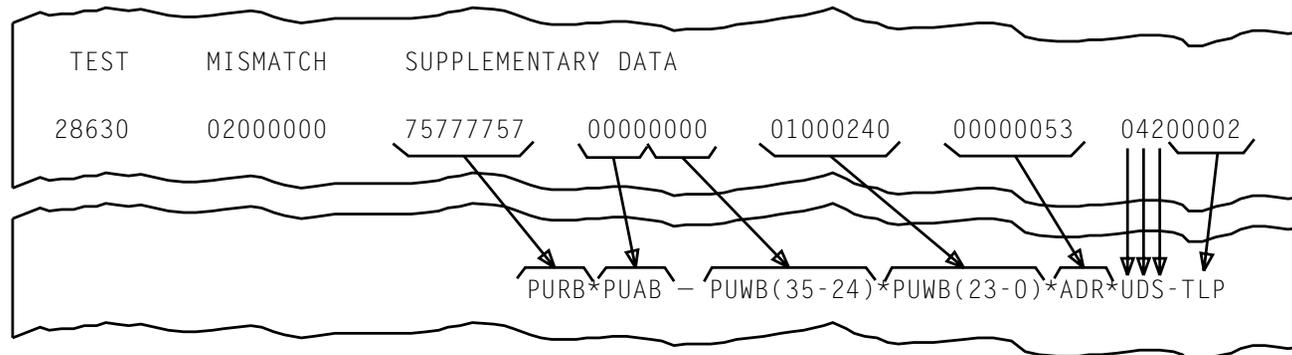


FIG. 1 - Example of Raw Data Printout Relationship to Asterisk Line at Failing Test

TABLE A DESCRIPTION OF DATA CONTAINED IN SECOND AND THIRD DATA WORD FOR EACH TYPE DIAL TEST STATEMENT					
DIAL TEST STATEMENT	DESCRIPTION*	DIAL TEST STATEMENT	DESCRIPTION*		
CCBB	A = B = 0, C = buffer bus address	SCANI	A(bits 11-2) = SP K-code B = SP OP code to read scan points 0/(1540) C = address of point		
CITOP CITOPI	Standard PUB format†				
CLKOP	A = fault chain, B = reply bus C = CC pulse point address	SDI	A(bits 11-2) = SP K-code B = SP OPCODE to read SD points 0/(1440) C = address of point		
MEMOPI	Standard PUB format† PUWB bits 16-10 = address of memory accessed PUWB bits 9-7 = memory level For time slot memories and busy-idle map Memories bit 0 = switching and permuting CKT	SESOP	Standard PUB format†		
		STORE	A = B = 0, C = specified expected result for VIC diagnostic B = VIC failing test		
MTXMOP	Standard PUB format† PUWB bits 8-0 = matrix under test	TMSOP TMSOPI	Standard PUB format† PUWB bits 16-10 = address of memory accessed		
		TSIESR	Standard PUB format† except C = don't care		
PLOP	MA pulse point accessed by an SP: A (bits 11-2) = SP K-code B = SP OPCODE to bit pulse point 0/ (1640) C = address of point MA pulse point accessed by CC pulse point A = B = 0, C = CC pluse point address	TSIMOP	Same as MEMOPI statement		
		<p>*The following format relates A, B, and C to the second and third data words following mismatch data:</p> <table style="margin-left: auto; margin-right: auto;"> <tr> <td style="text-align: center;"><u>SECOND WORD</u></td> <td style="text-align: center;"><u>THIRD WORD</u></td> </tr> <tr> <td style="text-align: center;">AAAABBBB</td> <td style="text-align: center;">CCCCCCC</td> </tr> </table>		<u>SECOND WORD</u>	<u>THIRD WORD</u>
<u>SECOND WORD</u>	<u>THIRD WORD</u>				
AAAABBBB	CCCCCCC				
PUDROP PUDROPI	Standard PUB format†	<p>†The standard PUB format is: A = PUEA/PUAB B = PUWB (bits 35-24) = OPAD, (bits 35-29) = OPCODE C = PUWB (bits 23-0) = ADDRESS</p>			
PULSE	A = B = 0, C = CC pulse point address				
PULSI	Same as PLOP statement				
PUOP PUOPI	Standard PUB format†				
PUOPBBR PUOPIBBR	PUOP part: standard PUB format† BBR part: A = B = 0, C = buffer bus address				

TABLE B			
SECOND AND/OR THIRD DATA WORD	LOCATION OF INFORMATION		
	SD-4A012-01 FRAME	SD-4A012-02 FRAME	SD-4A087-01 FRAME
OPAD/OPCODE	SD-4A026-01 (B16GA)	SD-4A026-02 (B16GA)	SD-4A088-01 (B16GA)
SD point address	VER:SPMTXPK:SDP,MDN 0'a! a = SD point address		
Scan point address	VER:SPMTXPK:SCP,MSN 0'a! a = scan point address		

SUMMARY

Locate failing test in last subroutine called. Look PAST failing test for endloop statements. For each endloop statement located in subroutine, use endloop label variable to identify location of the associated doloop statements. Locate each doloop statement. Obtain doloop index values from raw data printout and determine their

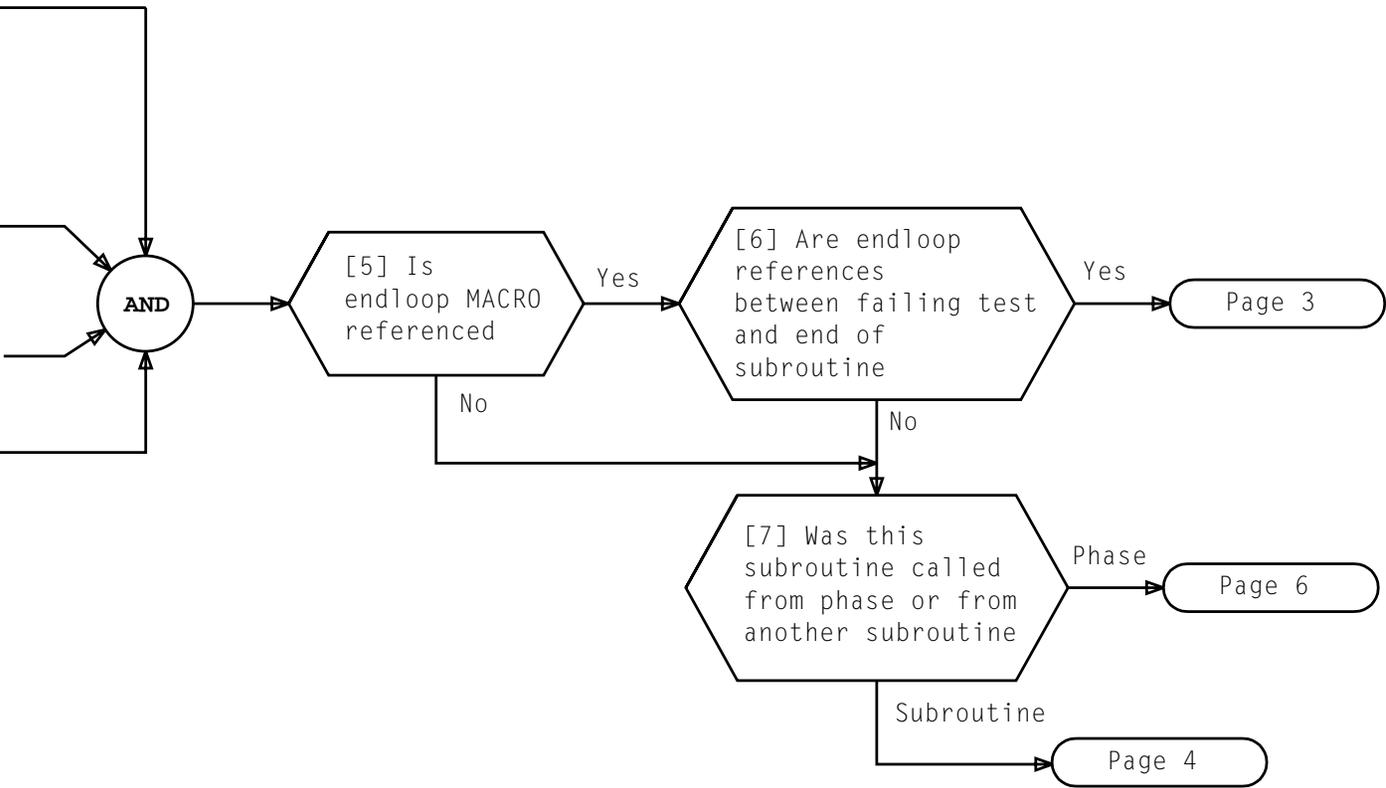
meaning for each doloop [FIG. 1]. If an endloop statement was not found in subroutine, go to where subroutine was called and look for endloop statements after CALLSUB statement. Continue to look for endloop statements after CALLSUB statements until all doloops indicated on raw data printout for first failing test are located. Read comments at the doloop statements.

[1] Refer to FIG. 1 and dial statement definitions in Section 234-180-020

[2] Locate failing test in last subroutine called and note page and line number of Expected Results (EXPR)

[3] Locate last address in this subroutine and note its page and line number

[4] Locate subroutine PIDENT reference section



DETERMINE LOCATION AND FUNCTION OF DOLOOPS, SUBROUTINES CALLED

Issue 6	JAN 1997
234-151-011	DLP
PAGE 1 of 6	503

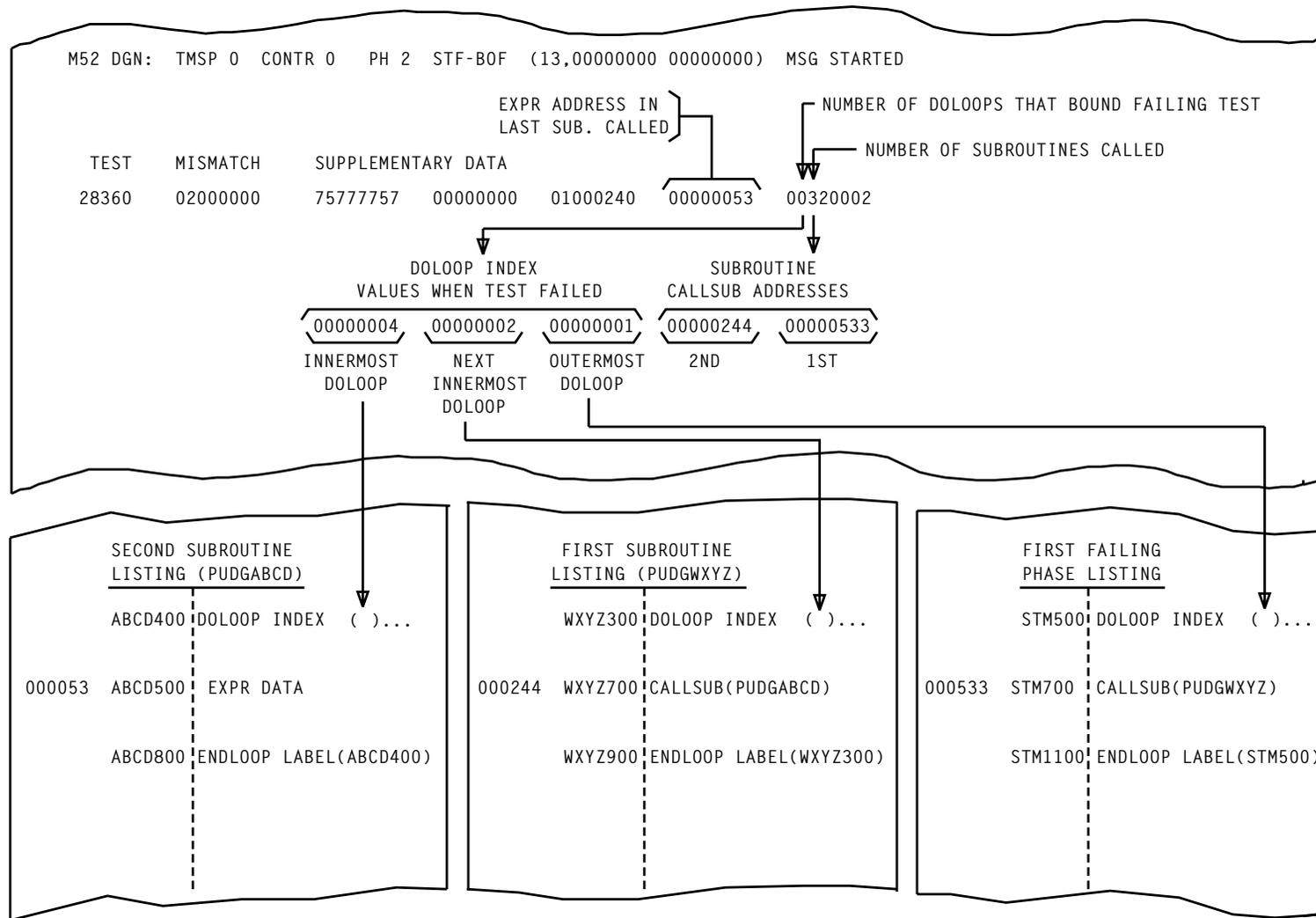


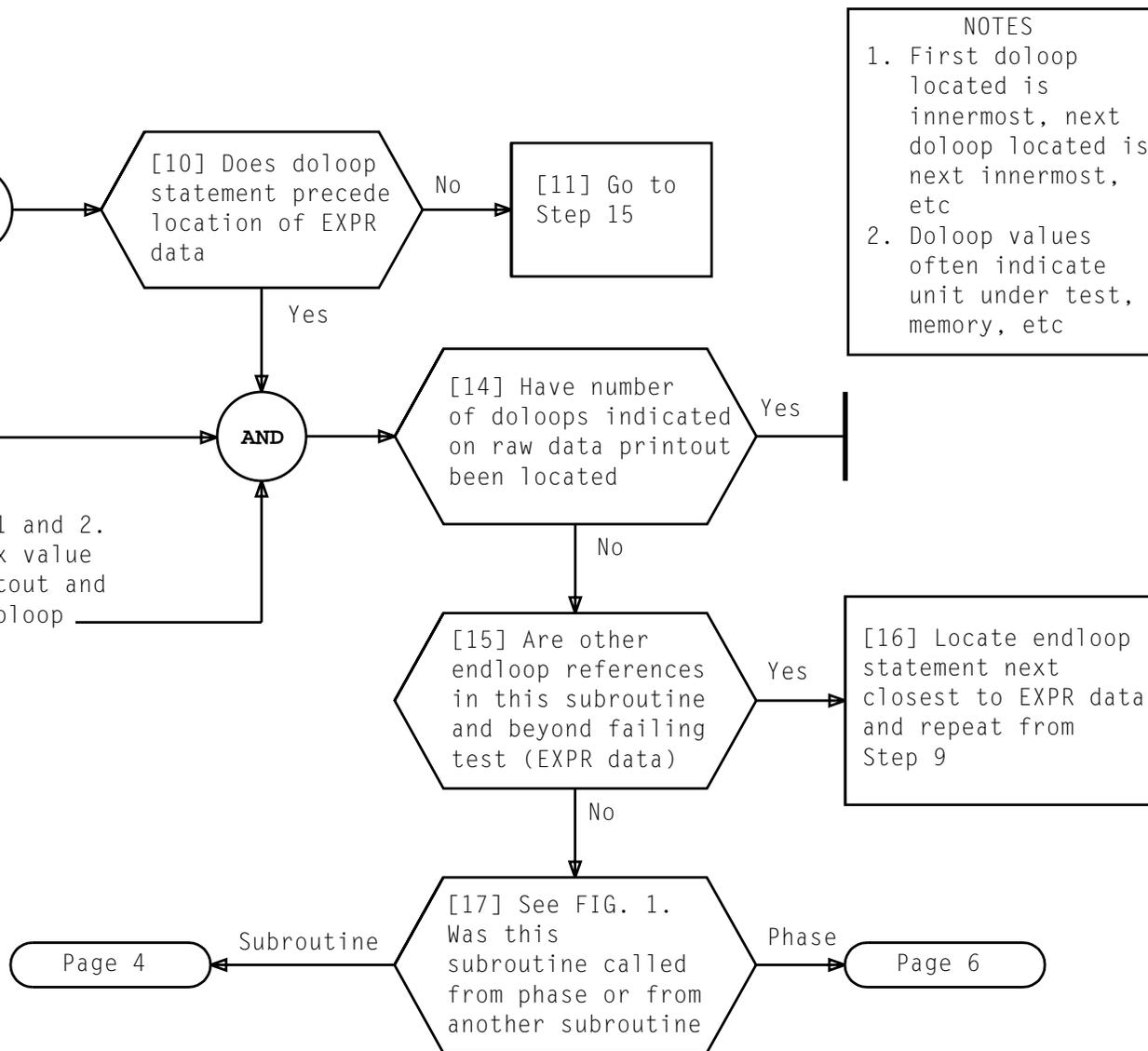
FIG. 1 - Example of Doloop Raw Data Relationship to Listings When Subroutines Called

[8] Locate referenced endloop statement closest to, but beyond, EXPR data noted in Step 2

[9] Locate doloop statement using label (in parentheses) at endloop statement

[12] Read comments at doloop statement

[13] See FIG. 1, NOTES 1 and 2. Obtain doloop index value from raw data printout and note meaning for doloop



NOTES
 1. First doloop located is innermost, next doloop located is next innermost, etc
 2. Doloop values often indicate unit under test, memory, etc

[16] Locate endloop statement next closest to EXPR data and repeat from Step 9

DETERMINE LOCATION AND FUNCTION OF DOLOOPS, SUBROUTINES CALLED

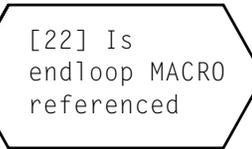
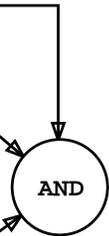
Issue 6	JAN 1997
234-151-011	DLP
PAGE 3 of 6	503

[18] In subroutine that called last subroutine checked for doloops, locate CALLSUB statement that called subroutine

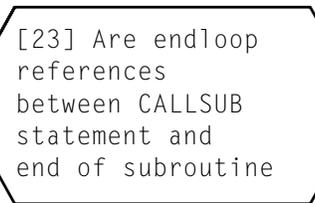
[19] Note page and line number of CALLSUB statement

[20] Locate last address in this subroutine and note page and line number

[21] Locate subroutine PIDENT reference section



Yes

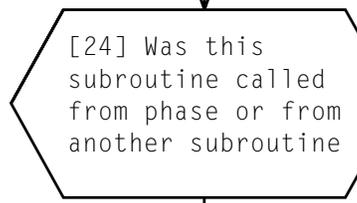


Yes



No

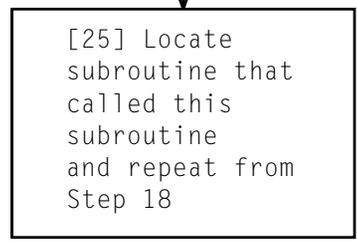
No



Phase

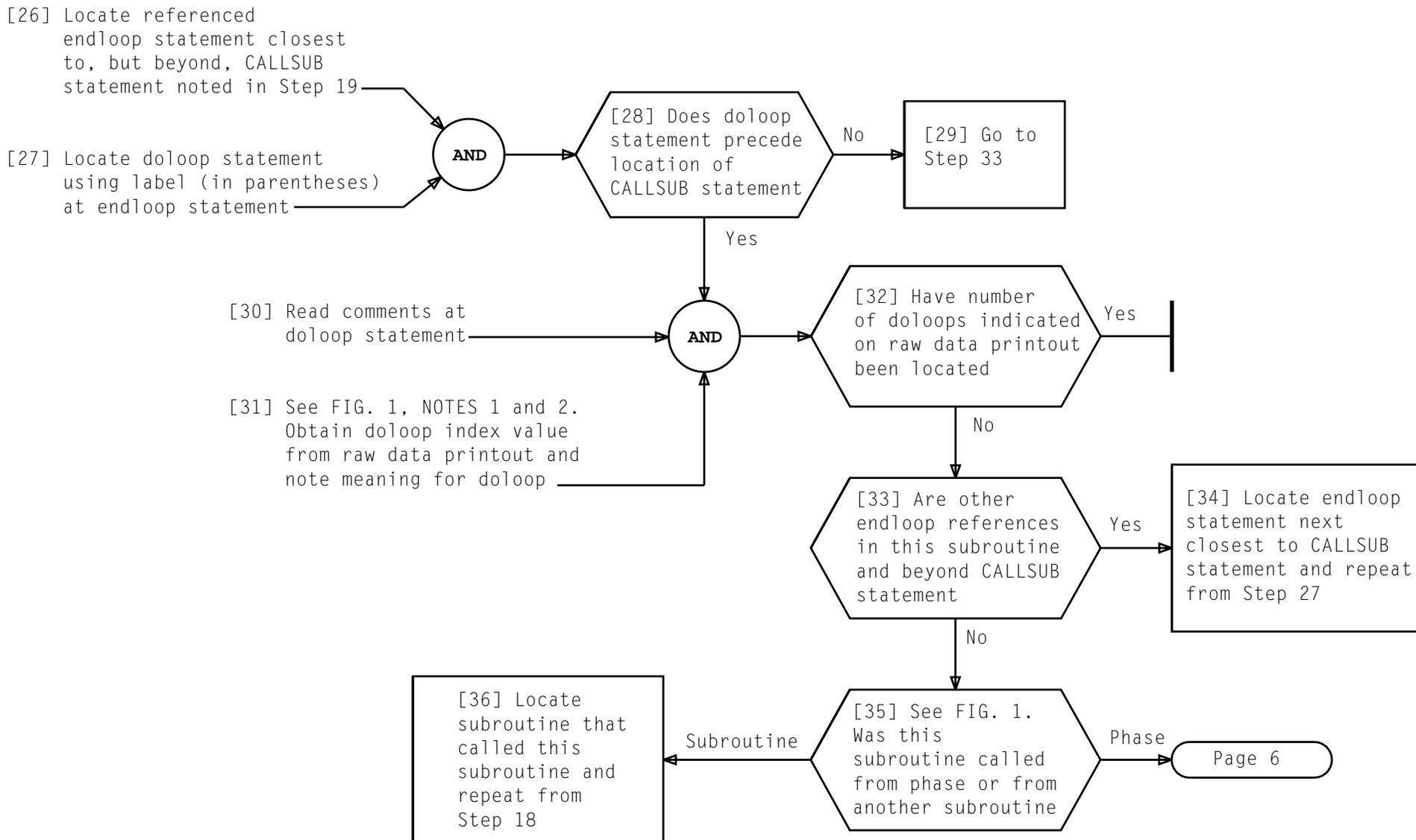


Subroutine



DETERMINE LOCATION AND FUNCTION OF DOLOOPS, SUBROUTINES CALLED

Issue 6	JAN 1997
234-151-011	DLP
PAGE 4 of 6	503



**DETERMINE LOCATION AND FUNCTION OF DOLOOPS,
SUBROUTINES CALLED**

Issue 6	JAN 1997
234-151-011	DLP
PAGE 5 of 6	503

In first failing phase PIDENT:

[37] See FIG. 1. Locate CALLSUB statement that called for last subroutine checked for doloops

[38] Note page and line number of CALLSUB statement

[39] Locate endloop MACRO in PIDENT reference section

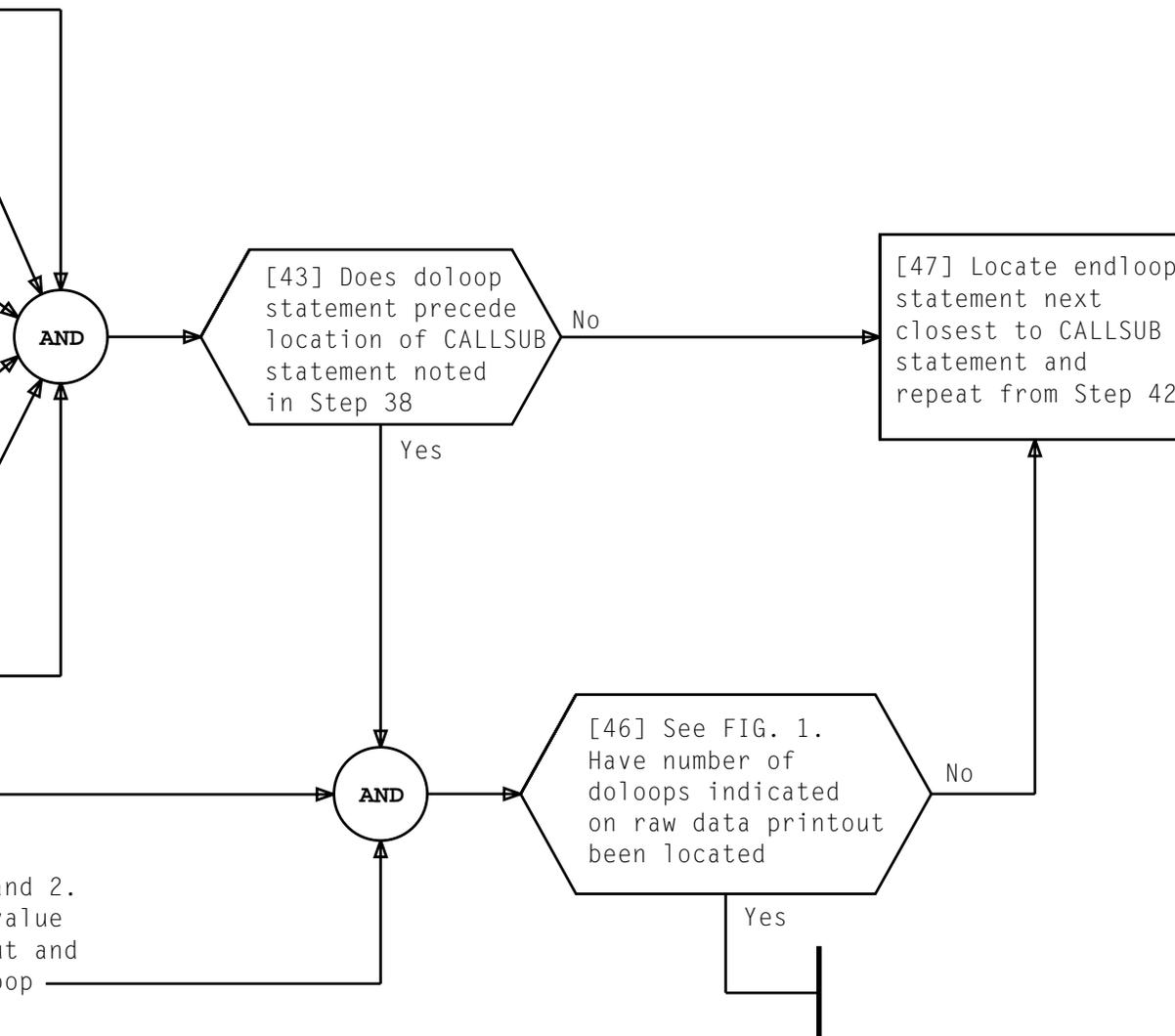
[40] Note endloop reference closest to, but beyond, CALLSUB statement

[41] Locate endloop statement noted in Step 40

[42] Locate doloop statement using label (in parentheses) at endloop statement

[44] Read comments at doloop statement

[45] See FIG. 1, NOTES 1 and 2. Obtain doloop index value from raw data printout and note meaning for doloop



**DETERMINE LOCATION AND FUNCTION OF DOLOOPS,
SUBROUTINES CALLED**

Issue 6	JAN 1997
234-151-011	DLP
PAGE 6 of 6	503

In first failing phase PIDENT:

[1] See FIG. 1. Locate first failing test using EXPR address on raw data printout

[2] Note page and line number of EXPR data

[3] Locate endloop MACRO in PIDENT reference section

[4] Locate endloop reference closest to, but beyond, EXPR data

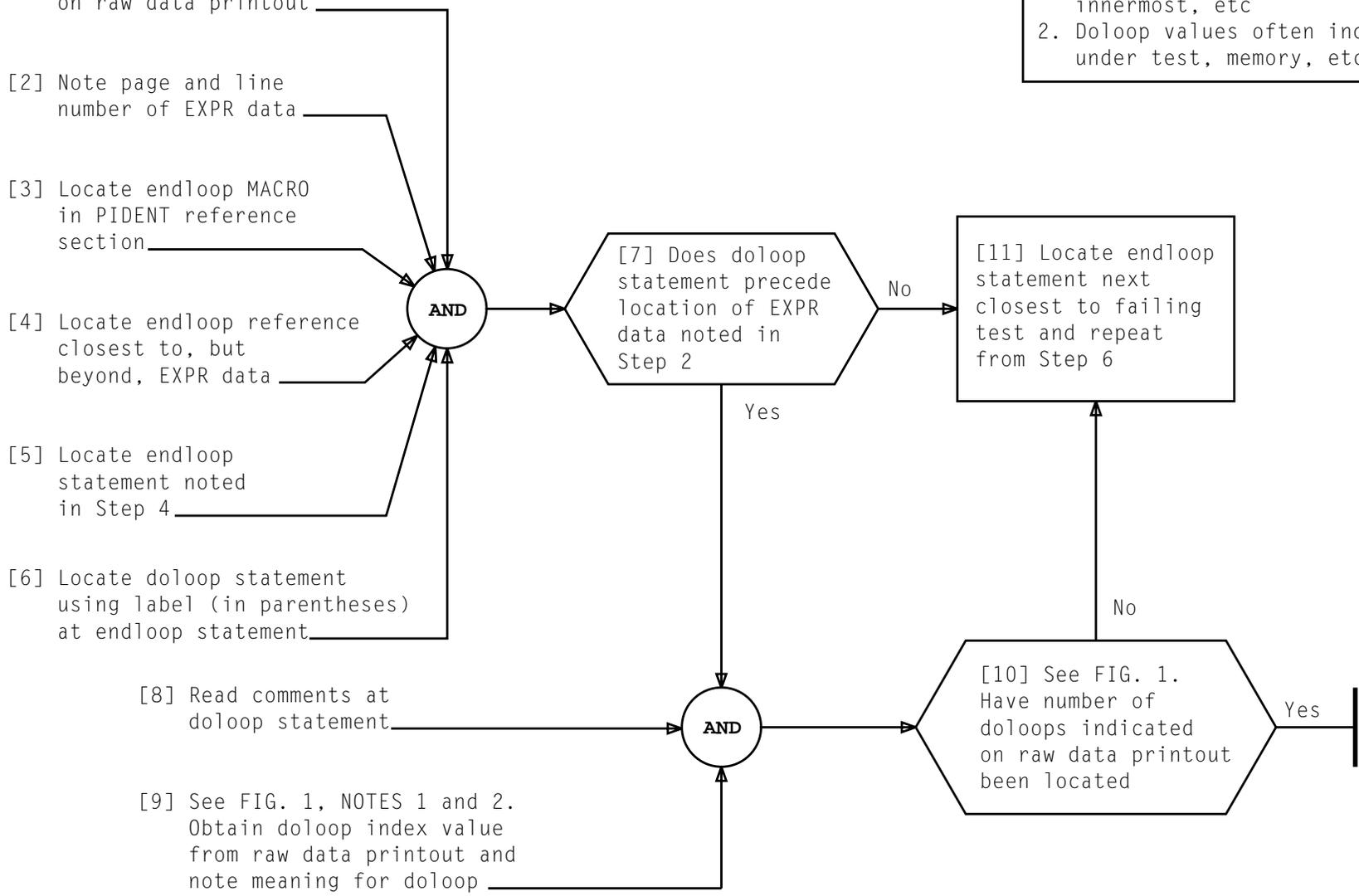
[5] Locate endloop statement noted in Step 4

[6] Locate doloop statement using label (in parentheses) at endloop statement

[8] Read comments at doloop statement

[9] See FIG. 1, NOTES 1 and 2. Obtain doloop index value from raw data printout and note meaning for doloop

NOTES
 1. First doloop located is innermost, next doloop located is next innermost, etc
 2. Doloop values often indicate unit under test, memory, etc



DETERMINE LOCATION AND FUNCTION OF DOLOOPS, NO SUBROUTINES CALLED

Issue 6	JAN 1997
234-151-011	DLP
PAGE 1 of 2	504

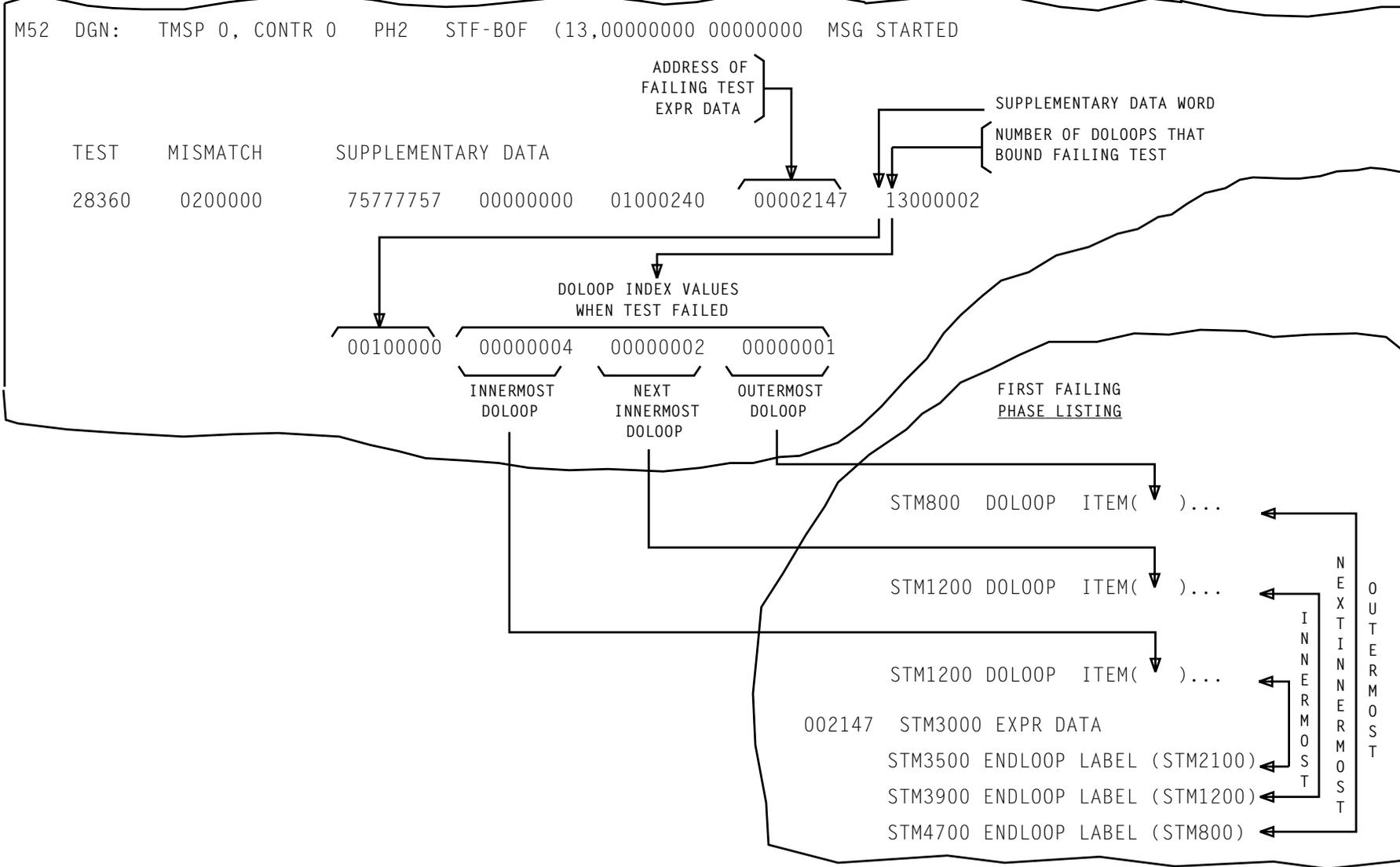
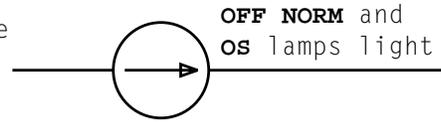


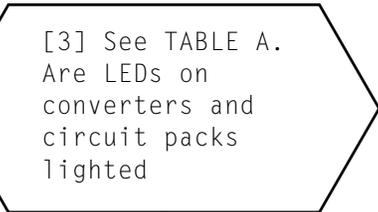
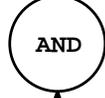
FIG. 1 - Example of Raw Data Doloop Word Relationship to Failing Listing

At frame power switch:

[1] Rotate **ROS/OFF** switch clockwise to **ROS** position



[2] Depress and hold **TEST** pushbutton for 2 seconds

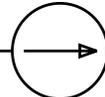


No

[4] Replace defective unit circuit pack [DLP-500] bulk converter [DLP-509] nonbulk converter [DLP-511]. Repeat from Step 1

Yes

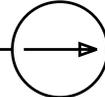
[5] Depress **ON** pushbutton



All LEDs go off



[6] Rotate **ROS/OFF** switch 1/4 turn counterclockwise



OS lamp goes off

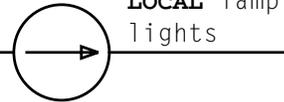


TABLE A - LED LOCATIONS			
TMS FRAME	CONVERTERS		CIRCUIT PACK LOCATIONS
	TYPE	LOCATIONS	
SD-4A012-01	+3V converters	80-26 12-00, 06,12,18,24,30,36,42 017-00,06,12,18,24,30,39,45 117-24,30,36,42	068-40
	-3V converters	17-36,42	
	+9V converters	021-40 121-04,40	
SD-4A012-02	+3V converters	80-26 12-00,06,12,18,24,30,36,42 017-00,06,12,18,24,30 117-24,30,36,42	068-40
	-3V converters	17-36 80-36	
SD-4A087-01	+3V converters	76-36 80-36	64-20,52 60-20,52 52-20,52 48-20,52 44-28 40-20,52 36-20,52 28-20,52 24-20,52
	-3V converters	14-24,30,36,42	
	+3V 245A converters	14-12,60	

At tape transport:

[1] Open interlocked cover door;
at upper right of tape
transport, pull interlock
plunger out

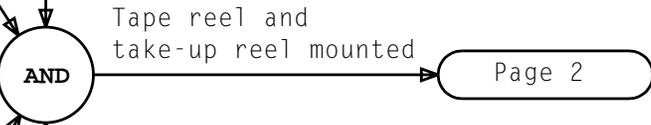
[2] Depress **LOCAL/REMOTE**
pushbutton to obtain **LOCAL**
lighted condition



[3] Verify empty lower (take-up) tape reel is
same size or larger than tape reel to be mounted

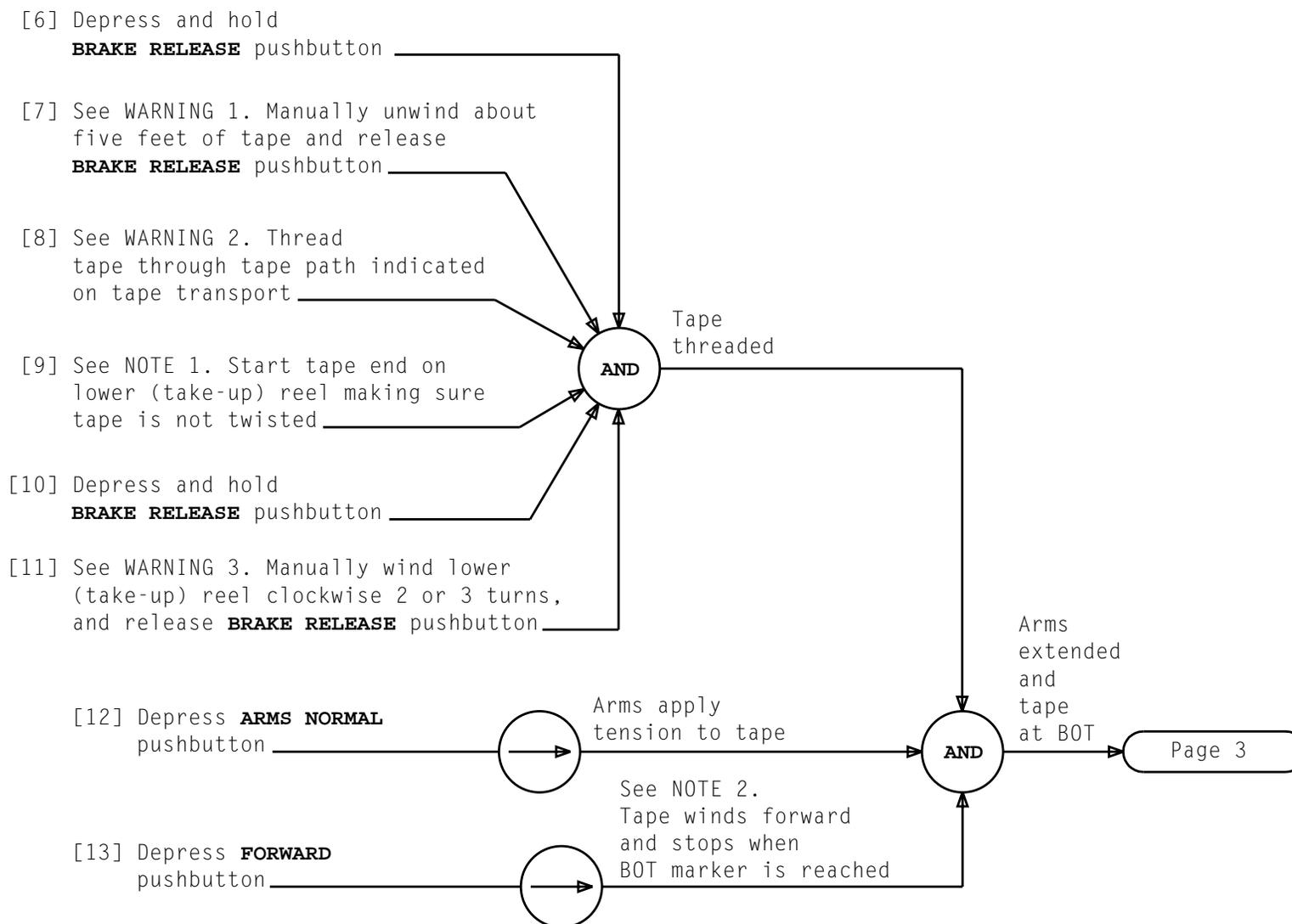
[4] With hub (knob) of upper reel in
counterclockwise position, mount reel
with tape on reel holder

[5] Rotate hub (knob) of upper reel clockwise
to detent to lock tape reel securely



MOUNT TAPE ON TAPE TRANSPORT, TAPE UNIT

Issue 6	JAN 1997
234-151-011	DLP
PAGE 1 of 3	506



NOTES

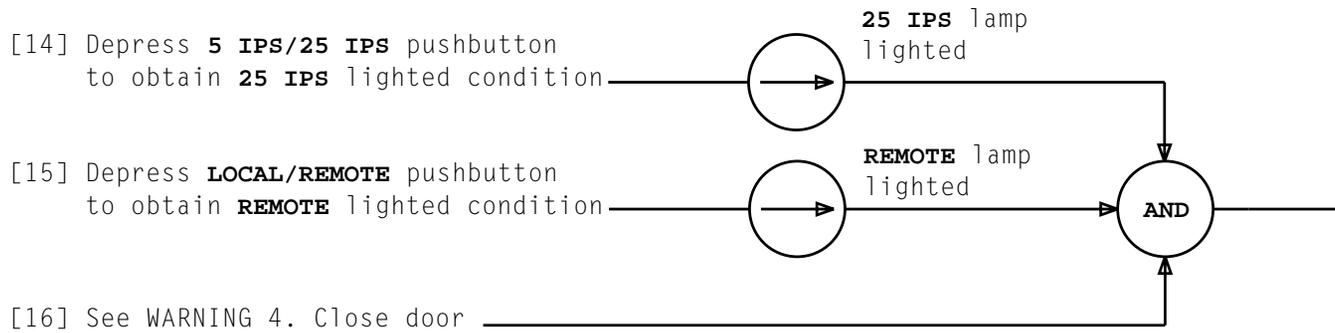
1. To start tape on take-up reel, it may help to moisten the tape end (moistened fingers) and stick it to the reel axle
2. Tape may not stop at BOT marker if fast forward is depressed

WARNINGS

1. Contamination of tape by contact with floor will damage tape heads
2. Do not touch tape head surfaces; body oils will contaminate tape
3. If tape is not properly aligned along rollers and guides, or is too loose, it may be damaged

Issue 6	JAN 1997
234-151-011	DLP
PAGE 2 of 3	506

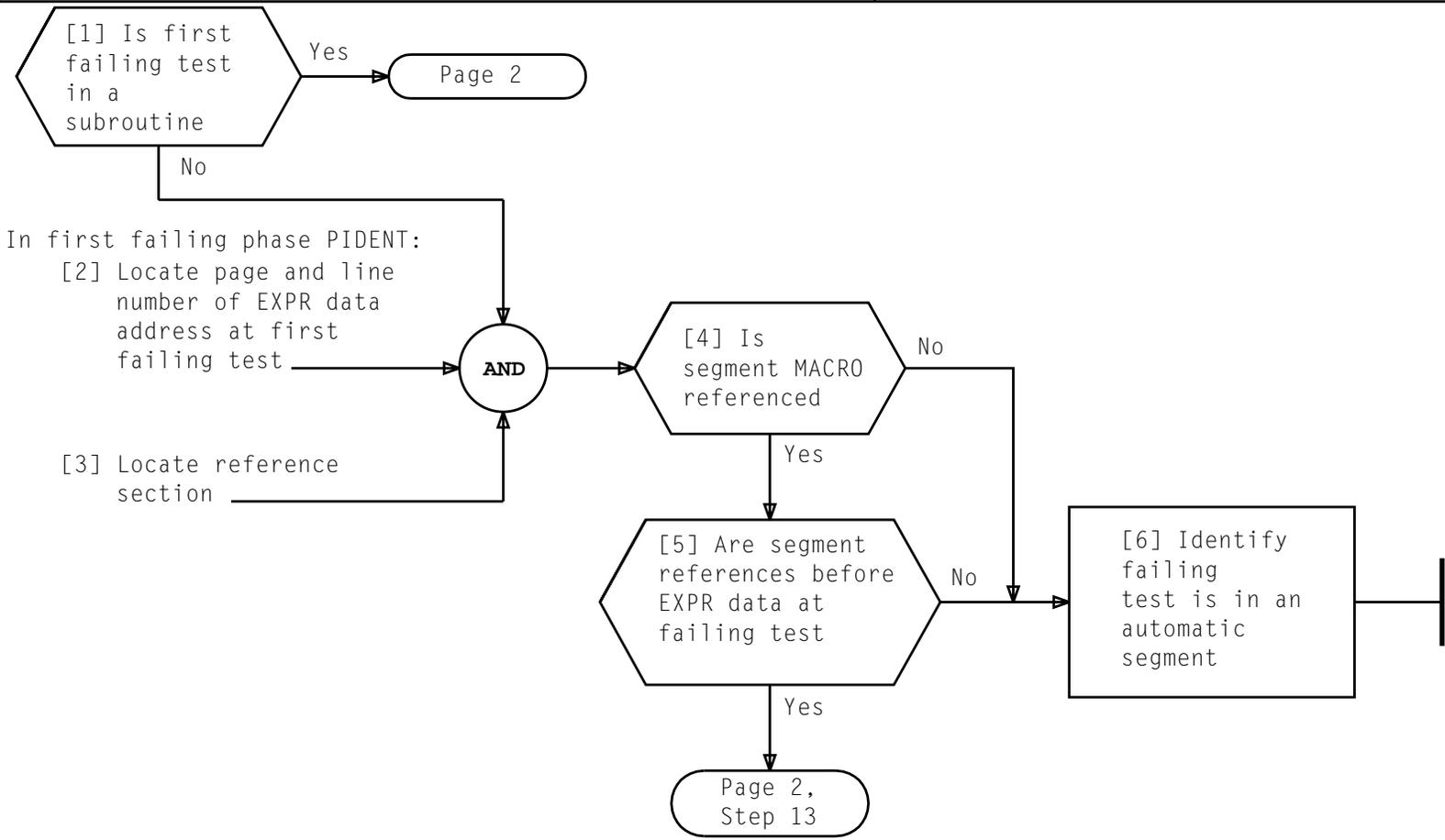
MOUNT TAPE ON TAPE TRANSPORT, TAPE UNIT



<i>WARNING 4</i> <i>Closing tape transport door in a harsh manner may upset alignment</i>	
Issue 6	JAN 1997
234-151-011	DLP
PAGE 3 of 3	506

MOUNT TAPE ON TAPE TRANSPORT, TAPE UNIT

<p style="text-align: center;">SUMMARY</p> <p>Locate first segment statement before first failing test. If segment statement has AUTO (ON) indicated, the failing test is in an automatic segment. If AUTO (ON) is not</p>	<p>indicated, the failing test is not in an automatic segment. If no segment statement is found before the first failing test, the failing test is in an automatic segment.</p>
--	---



DETERMINE IF FAILING TEST IS IN AN AUTOMATIC SEGMENT

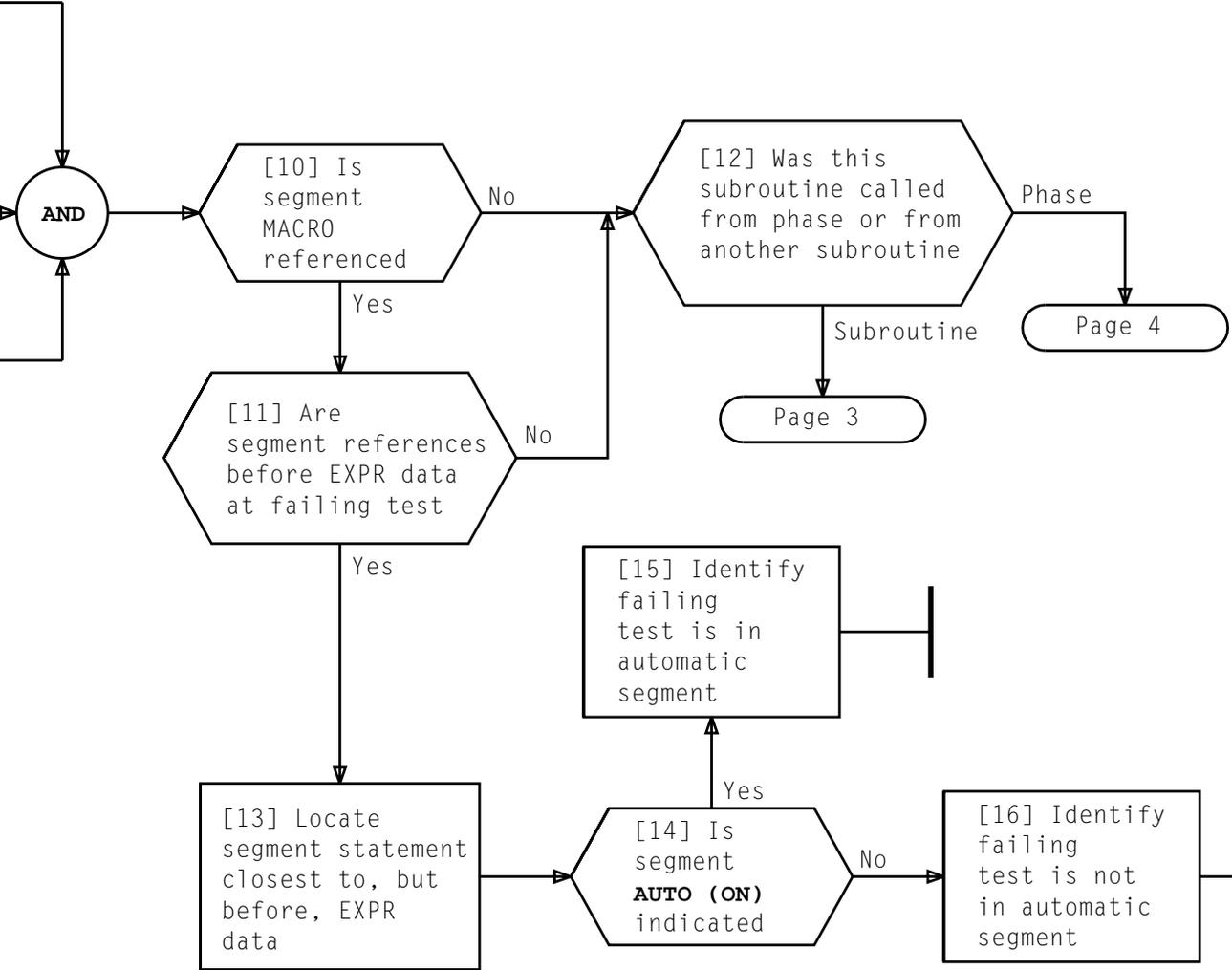
Issue 6	JAN 1997
234-151-011	DLP
PAGE 1 of 4	507

In subroutine where
first failing test
is located:

[7] Locate page and line
number of first address
in subroutine (000000)

[8] Locate page and line
number of first
failing test EXPR
data

[9] Locate PIDENT
reference section



DETERMINE IF FAILING TEST IS IN AN AUTOMATIC SEGMENT

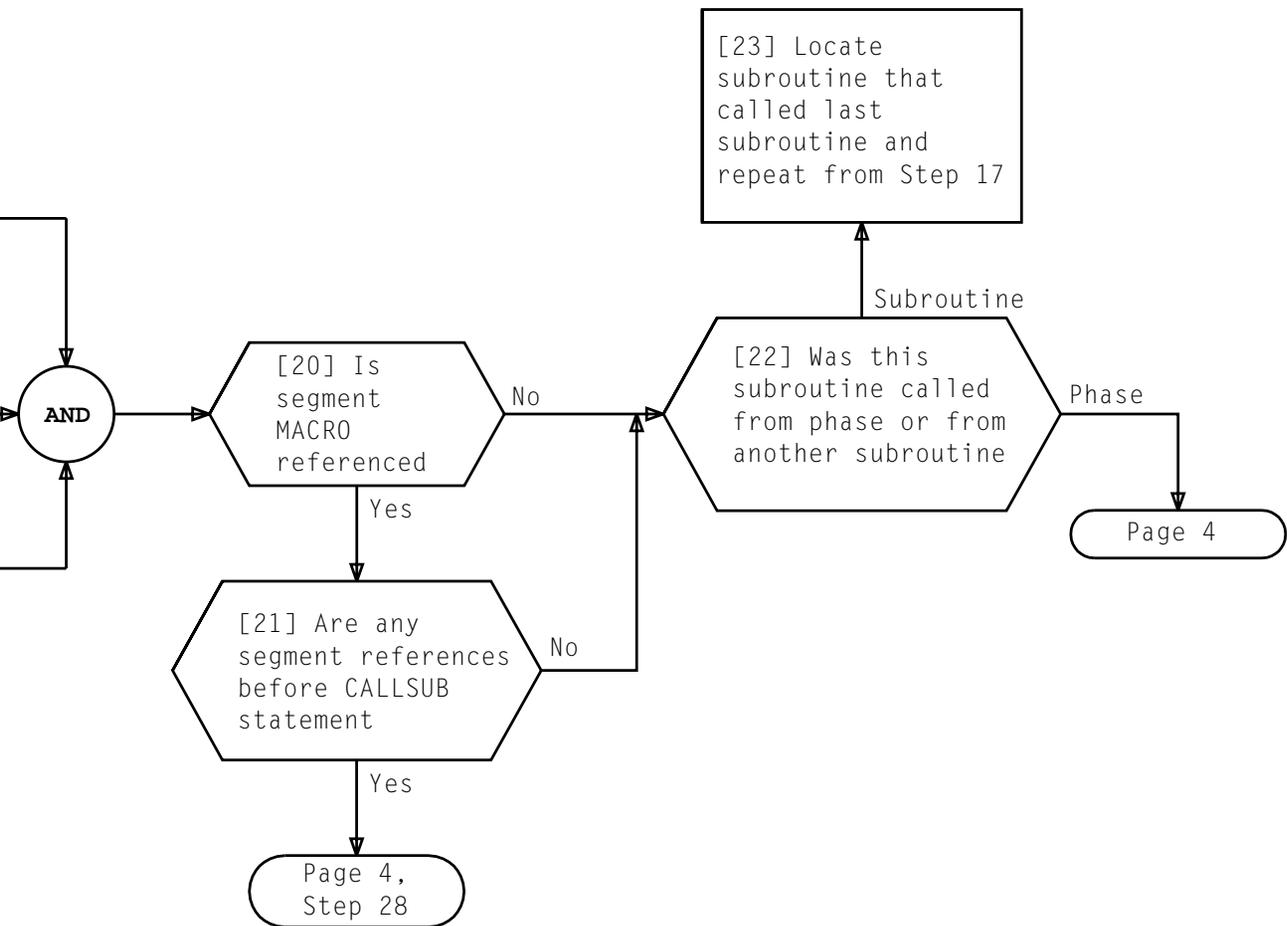
Issue 6	JAN 1997
234-151-011	DLP
PAGE 2 of 4	507

In subroutine that called
last subroutine checked
for segment statement:

[17] Locate page and
line number of
first address in
subroutine (000000)

[18] Locate page and
line number of
CALLSUB statement that
called last subroutine

[19] Locate PIDENT
reference section

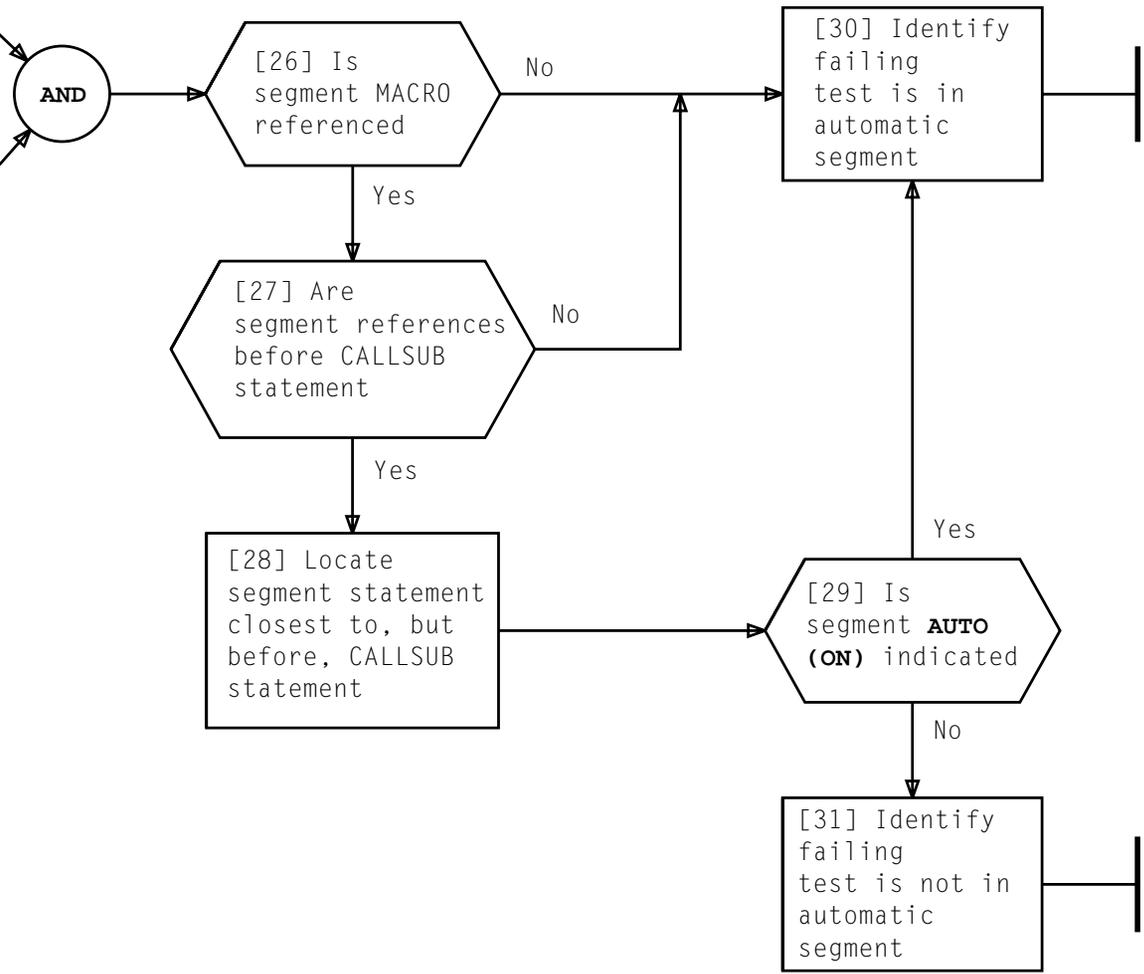


DETERMINE IF FAILING TEST IS IN AN AUTOMATIC SEGMENT

Issue 6	JAN 1997
234-151-011	DLP
PAGE 3 of 4	507

In first failing phase PIDENT:
 [24] Locate page and line
 number of CALLSUB
 statement that called
 last subroutine checked
 for segment statement

[25] Locate reference section



DETERMINE IF FAILING TEST IS IN AN AUTOMATIC SEGMENT

Issue 6	JAN 1997
234-151-011	DLP
PAGE 4 of 4	507

1. Locate segment statement that determined failing test was not in automatic segment
2. Note segment statement index word address for later use (loop start address)
3. Locate first segment statement after first failing test
4. Note index word address of dial statement that follows first segment statement after first failing test (loop end address)
5. Type in EX:TMSP a;RPT 2:PH b,ADR c-d!
a = failing TMSP member number
b = first failing phase
c = loop start address [Step 2]
d = loop end address [Step 4]

End of procedure

**SET UP LOOP OVER FIRST FAILING TEST
WHEN TEST IN A FORCE SEGMENT**

Issue 6	JAN 1997
234-151-011	DLP
PAGE 1 of 1	508

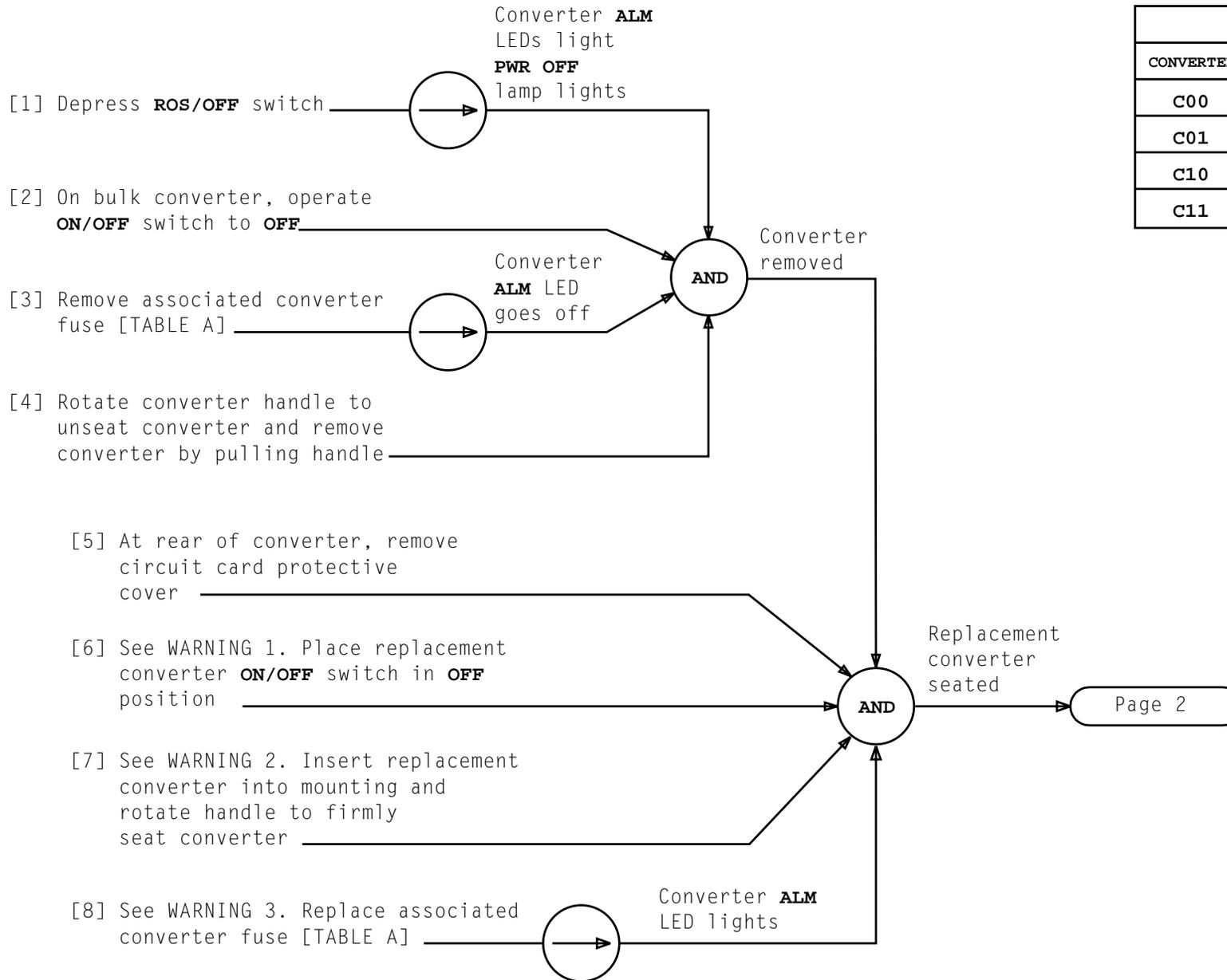


TABLE A			
CONVERTER	LOCATION	FUSE	LOCATION
C00	014-12	A0A	007-13
C01	014-60	A0B	007-13
C10	114-12	A1A	107-13
C11	114-60	A1B	107-13

WARNINGS

1. Failure to have **ON/OFF** switch in **OFF** position could result in damage to unit
2. Improper seating of unit may cause damage to connector
3. Current surge could damage converters if fuses are not replaced before turning converter **ON/OFF** switches to **ON**

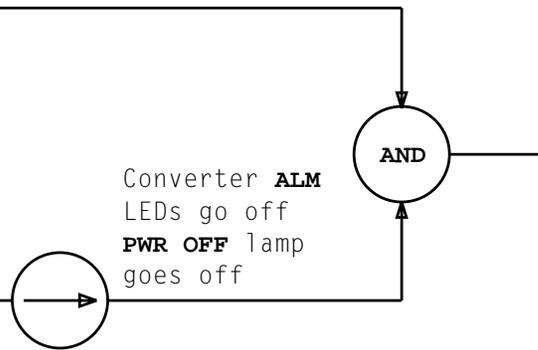
Reissued

Issue 6	JAN 1997
234-151-011	DLP
PAGE 1 of 2	509

REPLACE BULK CONVERTER (245A WITH 245A)

[9] On bulk converter, operate
ON/OFF switch to **ON**

[10] At power switch, depress
and hold **ON** pushbutton
for 2 seconds

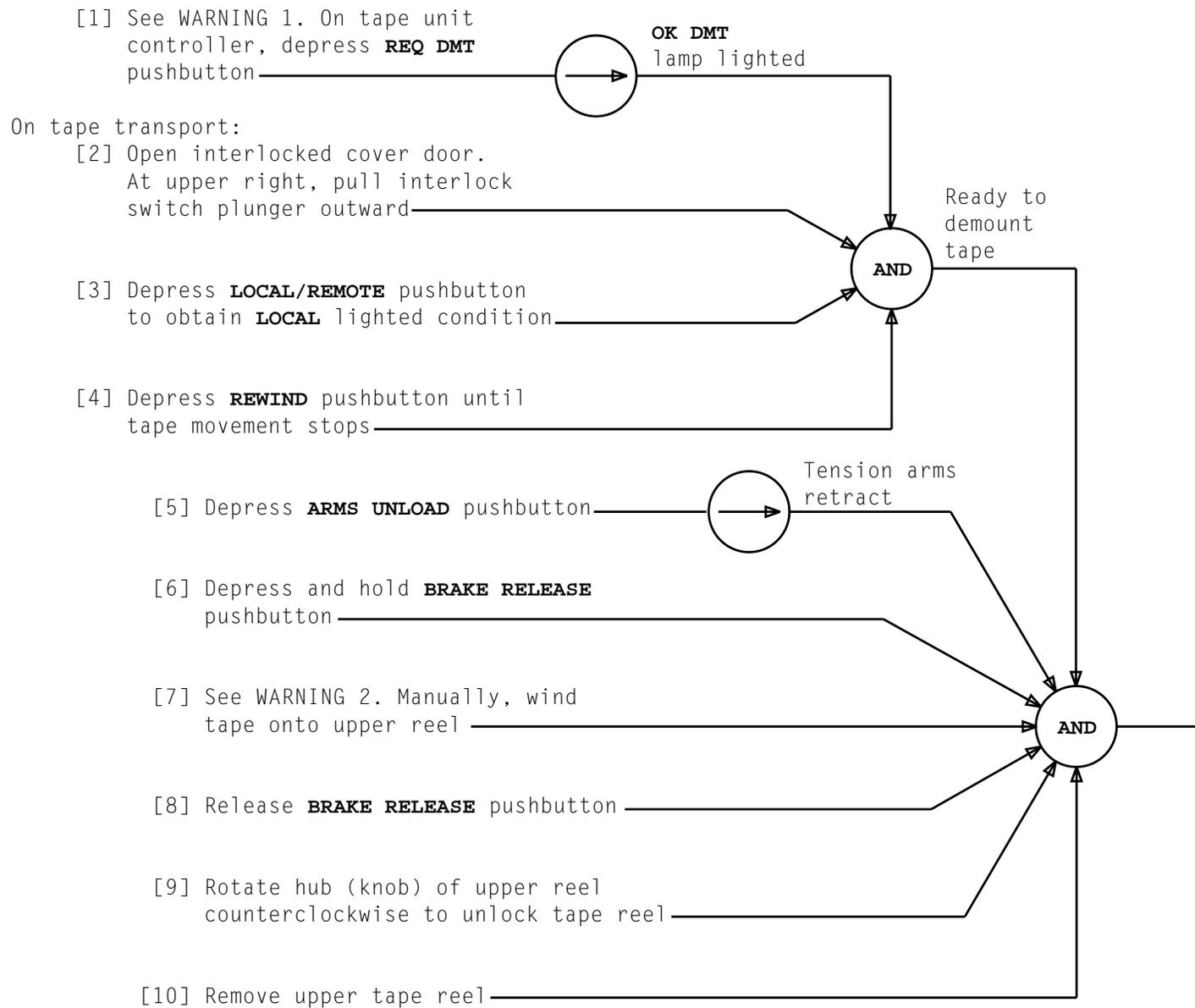


Converter **ALM**
LEDs go off
PWR OFF lamp
goes off

REPLACE BULK CONVERTER (245A WITH 245A)

Reissued

Issue 6	JAN 1997
234-151-011	DLP
PAGE 2 of 2	509

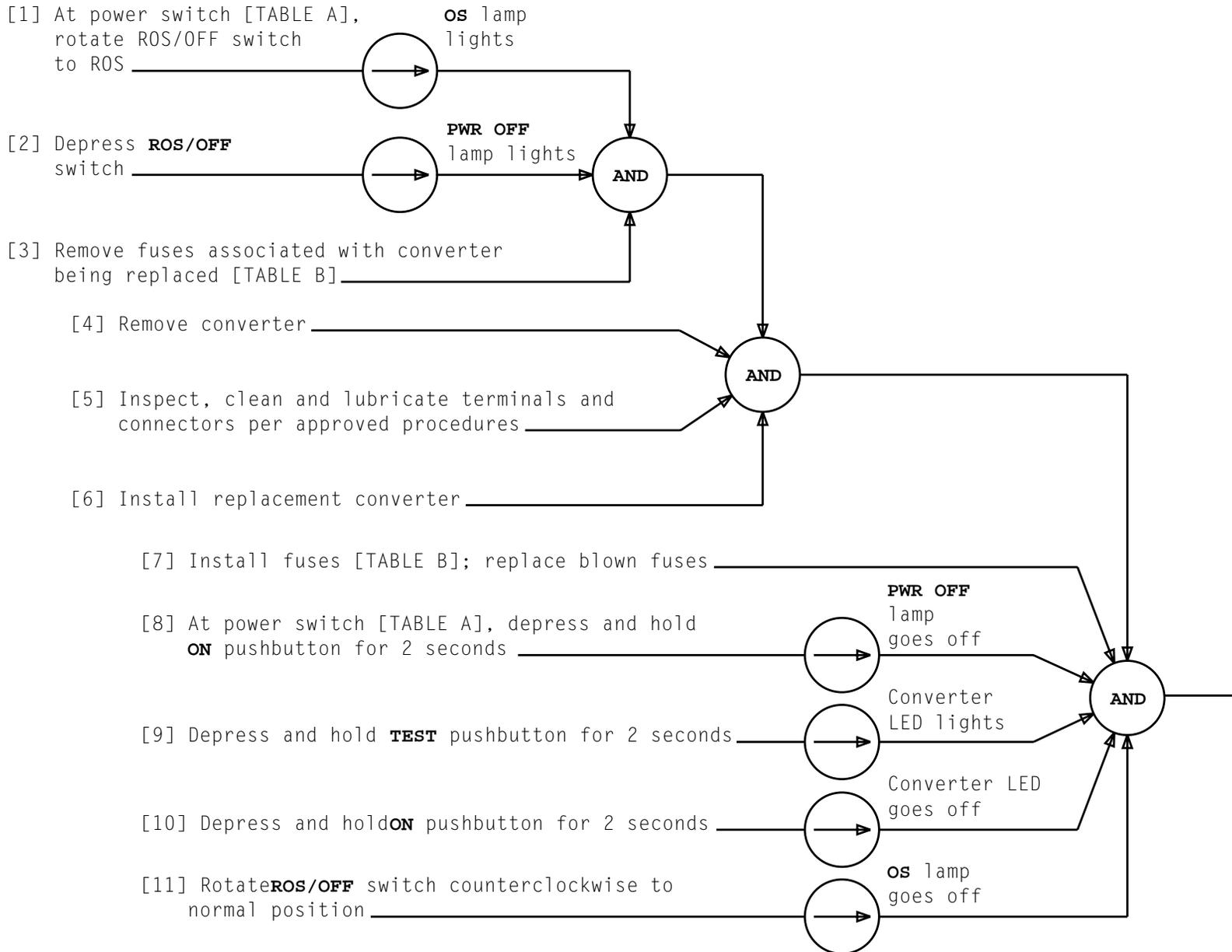


WARNINGS

1. Cycling tape transport or tape unit controller with tape over read/write heads may garbage tapes
2. Pulling or dragging last 2 feet of tape across heads may contaminate heads

Issue 6	JAN 1997
234-151-011	DLP
PAGE 1 of 1	510

DEMOUNT TAPE ON TAPE TRANSPORT, TAPE UNIT



REPLACE NONBULK CONVERTER

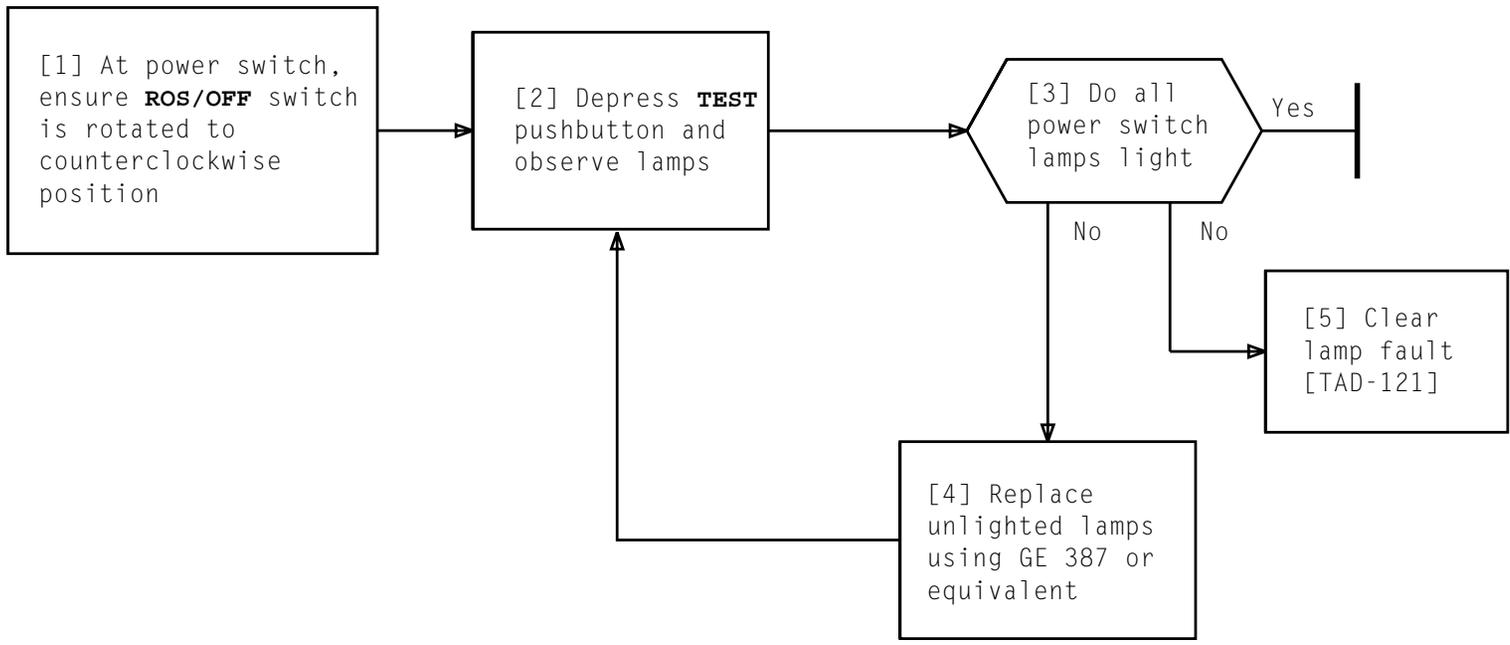
Issue 6	JAN 1997
234-151-011	DLP
PAGE 1 of 2	511

TABLE A			
SD-4A012-01, 02			
CONVERTER LOCATION	POWER SWITCH		
	LOCATION	NAME	
		BAY 0	BAY 1
*-80-26	*-80-29	IPUB0	IPUB1
All others	1-68-09	—	CONTR
4A087-01			
*-80-36	*-80-42	COIPUB1	CIIPUB1
*-76-36	*-76-42	COIPUB0	CIIPUB0
All others	*-44-38	CONTR0	CONTR1
* Converters located in Bay 0 or Bay 1 are controlled, respectively, by switches located in Bay 0 and Bay 1			

TABLE B			
4A012-01,02			
CONVERTER LOCATION	FUSE		
	BLOCK LOCATION	NAME	
		BAY 0	BAY 1
*-80-26	*-07-26	BA	CA
*-12-00,06,12,18	*-07-05	AOA	A1A
	*-07-13	BOA	B1A
	*-07-19	DOA	D1A
*-12-24,30,36,42	*-07-05	AOB	A1B
	*-07-13	BOB	B1B
	*-07-19	DOB	D1B
*-17-24,27,30,33,36,39 42,45	*-07-05	AOC	A1C
	*-07-13	BOC	B1C
	*-07-19	DOC	D1C
*-17-00,06,12,18	*0-07-05	AOD	—
	*0-07-13	BOD	—
	*0-07-19	DOD	—
1-21-04	*1-07-05	—	A1D
	*1-07-13	—	B1D
	*1-07-19	—	D1D
*-21-40	*-07-05	AOE	A1E
	*-07-13	BOE	B1E
	*-07-19	DOE	D1E
4A087-01			
*-80-36	*-07-53	BOB	B1B
*-76-36	*-07-53	BOA	B1A
*-14-24,30,36,42	*-07-13	AOC	A1C
	*-07-46	COC	C1C
	*-07-46	DOC	D1C
* Converters located in Bay 0 or Bay 1 are controlled, respectively, by fuses located in Bay 0 and Bay 1			

Revised

Issue 6	JAN 1997
234-151-011	DLP
PAGE 2 of 2	511



TEST LAMPS ON POWER SWITCH

Issue 6	JAN 1997
234-151-011	DLP
PAGE 1 of 1	512

[1] At TTY, type in
 RMV:TMSP a, { CONTR b|COIPUB c|C1IPUB d }!
 a,b,c,d = member and submember numbers

System responds
 RMV:TMSP a, { CONTR b|
 COIPUB c|C1IPUB d } COMPLETED

[2] At power switch, rotate **ROS/OFF**
 switch to **ROS** position

OFF NORM lamp lights

[3] Depress **ROS/OFF** switch

PWR OFF lamp lights

[4] Remove power switch fuses [TABLE A, B, or C]

[5] Cover apparatus below switch with drop cloth

[6] See NOTE 1. Tag and remove frame wiring
 to switch terminals

[7] Remove four mounting screws and
 withdraw switch from front of frame

[8] Surface wire replacement switch in
 same manner as defective switch

[9] At front of frame, install replacement switch
 using screws removed in Step 7

[10] Reconnect frame leads to switch terminal and
 install any pigtail components as required

Defective
 switch
 removed

Page 2

NOTE 1
 Do not remove
 surface wiring on
 switch terminals.
 It will be used as
 guide to surface
 wire replacement
 switch

Issue 6	JAN 1997
234-151-011	DLP
PAGE 1 of 2	513

REPLACE POWER SWITCH

[11] Replace fuses [TABLE A, B, or C]

[12] Depress and hold **ON** pushbutton for 2 seconds

[13] Rotate **ROS/OFF** switch to normal position

[14] At TTY, type in
 RST:TMSP a, {CONTR b,|COIPUB c|C1IPUB d}!
 a,b,c,d = member and submember numbers

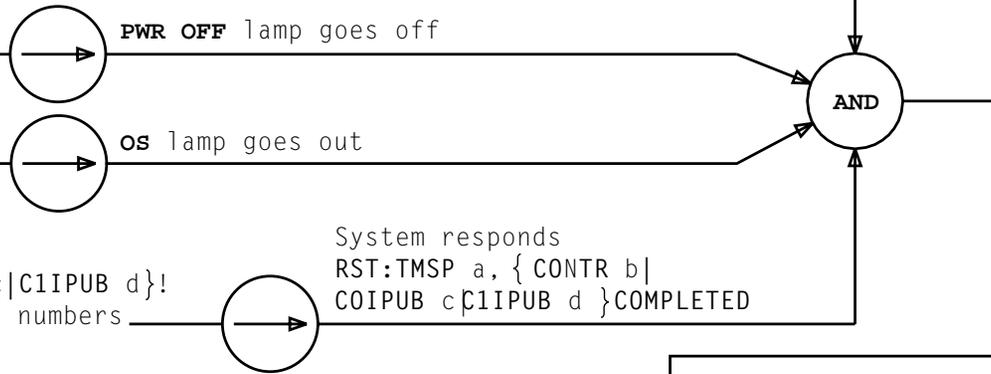


TABLE A - SD-4A012-01 FRAME					
BAY 0			BAY 1		
SWITCH LOCATION	FUSE	FUSE LOCATION	SWITCH LOCATION	FUSE	FUSE LOCATION
80-29	BA LB	07-26 07-19	80-29	CA LC	07-26 07-19
			68-09	SW LA	07-33 07-26

TABLE B - SD-4A012-02 FRAME					
BAY 0			BAY 1		
SWITCH LOCATION	FUSE	FUSE LOCATION	SWITCH LOCATION	FUSE	FUSE LOCATION
80-29	BA LB	07-13 07-19	80-29	CA LC	07-13 07-19
			68-08	SW LA	07-26 07-26

TABLE C - SD-4A087-01 FRAME					
BAY 0			BAY 1		
SWITCH LOCATION	FUSE	FUSE LOCATION	SWITCH LOCATION	FUSE	FUSE LOCATION
80-42	B0B L0C	07-53 07-53	80-42	B1B L1C	07-53 07-53
76-42	B0A L0B	07-53 07-53	76-42	B1A L1B	07-53 07-53
44-38	0SW L0A	07-46 07-53	44-38	1SW L1A	07-46 07-53

Issue 6	JAN 1997
234-151-011	DLP
PAGE 2 of 2	513

REPLACE POWER SWITCH

1. Type in
VER:UTYPE:TSI a!
a = member number

On VER:UTYPE Message output [FIG. 1]:

2. In word 5, if bit 23 is set (1), convert bits 18 through 22 to find EST member number
3. Convert word 16 to binary and determine frame type and member number of frame receiving clock signals from TSI [TABLE A]

End of Procedure

```

VER:UTYPE:TSI 0/2 PF
M 49 VER:UTMN;OPT (), CUR:      FIN 16006.02, // /      UTYN TSI
MEMN 2,      ME OPER,
ENTRY ADDRESS 0/761270/4      ENTRY SIZE 25
CUR
WORD 0/      20637777/ 04014002/ 000011 / 10000007/      0
00000110/00011110/00000130/00000150///// /
WORD 10/      00000000/00000017/00000403/00037777///
00000000/00000000/60416040/ 60436042/ /
WORD 20/      60456044/ 00006046/60616060/ 60636062/ /
60656064 /00006066/60606040/ 60706050 / / /
WORD 30/      00000000/////

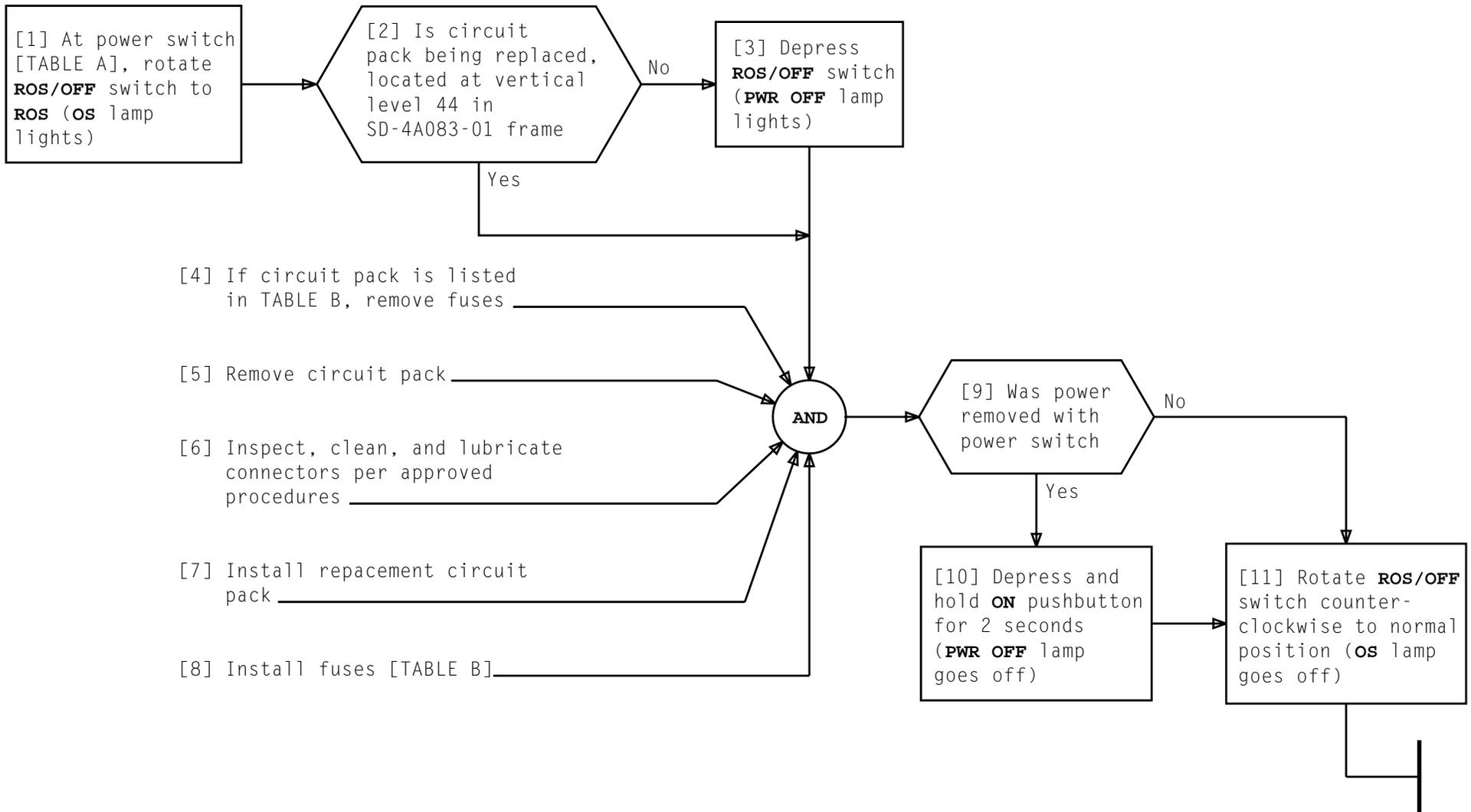
```

FIG. 1 – Typical Example of VER:UTYPE output message

TABLE A		
WORD 16 BIT TRANSLATION		
CLOCK	BITS	DEFINITION
0	0-6	member number
	7-10	frame type*
1	11-17	member number
	18-21	frame type*
* 0001 = DT, 0011 = VIF, 0100 = DIR, 0101 = PUC		

**IDENTIFY UNITS RECEIVING CLOCK SIGNALS FROM TSI FRAME
(SD-4A011-02)**

Issue 6	JAN 1997
234-151-011	DLP
PAGE 1 of 1	514



REPLACE CIRCUIT PACK IN TSI FRAME

Issue 6	JAN 1997
234-151-011	DLP
PAGE 1 of 2	515

TABLE A			
SD-4A011-01			
CIRCUIT PACK LOCATION	POWER SWITCH		
	LOCATION	NAME	
		BAY 0	BAY 1
*-80-All	*-80-63	IPUB0	IPUB1
*-76-03 to *-76-07	*-80-17	ALC0	ALC1
1-56-57,61	0-53-40	CONTR0	—
All others	*-53-40	CONTR0	CONTR1
SD-4A011-02			
CIRCUIT PACK LOCATION	POWER SWITCH		
	LOCATION	NAME	
		BAY 0	BAY 1
*-80-All	*-80-29	IPUB0	IPUB1
*-76-03 to *-76-07	*-80-23	ALC0	ALC 1
1-56-57,61	0-53-43	CONTR0	—
All others	*-53-43	CONTR0	CONTR1
SD-4A083-01			
CIRCUIT PACK LOCATION	POWER SWITCH		
	LOCATION	NAME	
		BAY 0	BAY 1
*-80-All	*-80-65	IPUB0	IPUB1
*-76-06 to *-76-26	*-72-03	ALC0	ALC1
0-64-63-,67	1-44-37	—	CONTR1
0-52-63,67	1-44-37	—	CONTR1
0-40-63,67	1-44-37	—	CONTR1
0-28-63-67	1-44-37	—	CONTR1
All others	*-44-37	CONTR0	CONTR1
* Circuit packs located in Bay 0 or Bay 1 are controlled, respectively, by switches located in Bay 0 and Bay 1			

TABLE B			
SD-4A011-01			
CIRCUIT PACK LOCATION	FUSE		
	BLOCK LOCATION	NAME	
		BAY 0	BAY 1
*-56-42	*-07-30	OAB	1AB
SD-4A011-02			
CIRCUIT PACK LOCATION	FUSE		
	BLOCK LOCATION	NAME	
		BAY 0	BAY 1
*-56-35,38,39	*-07-37	NOA,NOB	NIA,NIB
*-56-40	*-07-30	OAB	1AB
SD-4A083-01			
CIRCUIT PACK LOCATION	FUSE		
	BLOCK LOCATION	NAME	
		BAY 0	BAY 1
*-72-27	*-07-37	OCLFM,OCLS	1CLFM,1CLS
*-44-28,29,31	*-07-53	OVM	1VM
*-44-30	*-07-46	OVIC	1VIC
*-44-33	*-07-46	OVIC	1VIC
	*-07-53	OPC	1PC
* Circuit packs located in Bay 0 or Bay 1 are controlled, respectively, by fuses located in Bay 0 and Bay 1			

REPLACE CIRCUIT PACK IN TSI FRAME

[1] Type in,
 VER:UTYPE:TSI a!
 a = even member number
 having clockpack replaced

[2] Type in,
 VER:UTYPE:TSI b!
 b = odd member number in frame
 with TSI a above

On VER:UTYPE Message output [FIG. 1]:

[3] If either word 5 has bit 23 set (1), convert bits 18 through 22 of that word to find EST member number

[4] Convert word, associated with clock pack being replaced, to binary and determine frame type and member number of frame receiving clock signals [TABLE A]

End of procedure

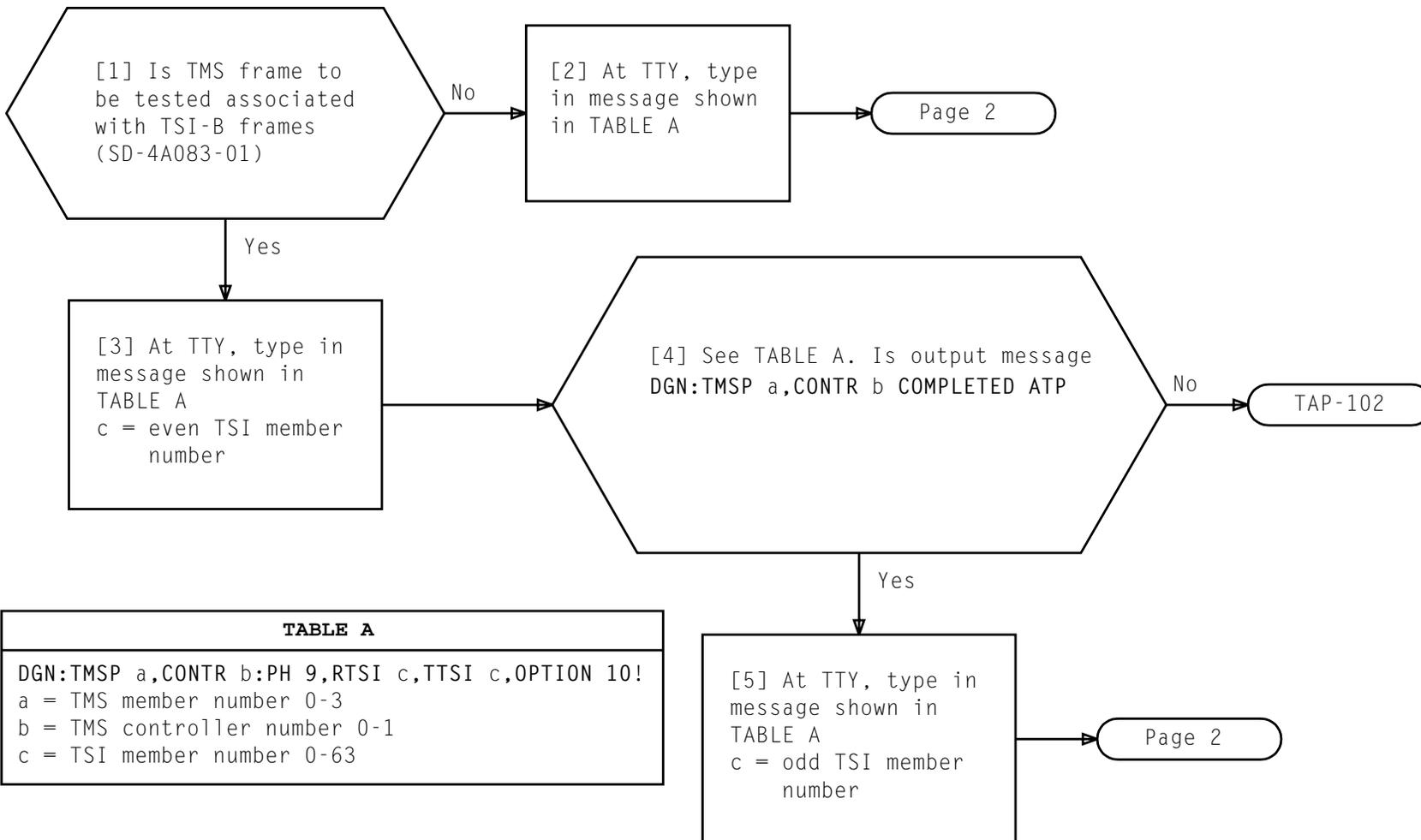
```

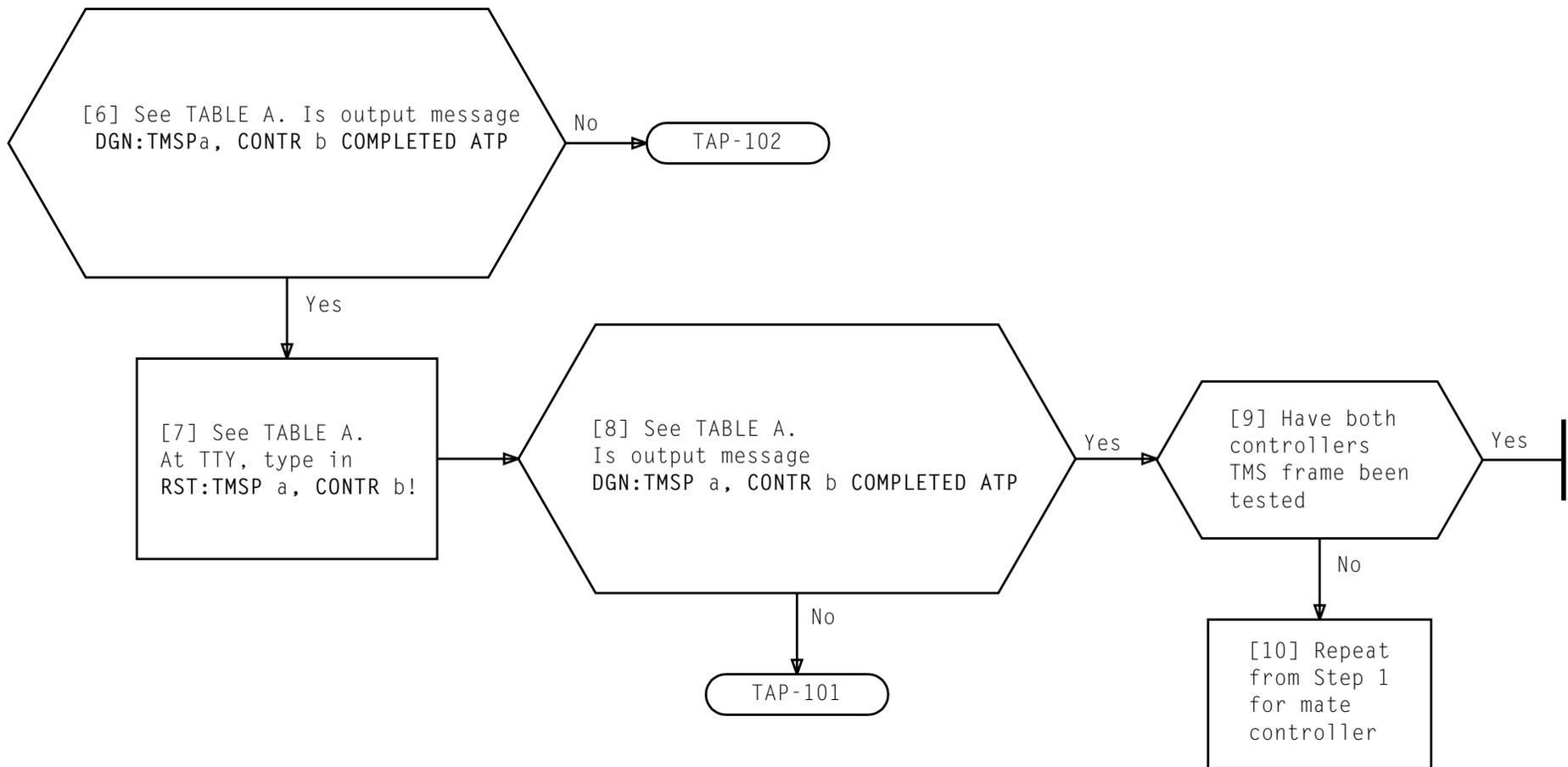
VER:UTYPE:TSI 0/2 PF
M 49 VER:UTMN;OPT (), CUR:      FLN 16006.02, // /      UTYN TSI
MEMN 2,      ME OPER,
ENTRY ADDRESS 0/761270/4      ENTRY SIZE 25
CUR
WORD 0/      20637777/ 04014002/ 000011 / 10000007/      0
00000110/00011110/00000130/00000150///// /
WORD 10/      00000000/00000017/00000403/00037777///
00000000/00000000/60416040/ 60436042/ /
WORD 20/      60456044/ 00006046/60616060/ 60636062/ /
60656064 /00006066/60606040/ 60706050 / / /
WORD 30/      00000000////////
  
```

FIG. 1 – Typical Example of VER:UTYPE output message

TABLE A BIT TRANSLATIONS			
CLOCK	WORD	BITS	DEFINITION
A	16	0-6	member number
		7-10	frame type*
B	16	11-17	member number
		18-21	frame type*
C	17	0-6	member number
		7-10	frame type*
D	17	11-17	member number
		18-21	frame type*
E	20	0-6	member number
		7-10	frame type*
* 0001 = DT, 0011 = VIF, 0100 = DIR, 0101 = PUC			

**IDENTIFY UNITS RECEIVING CLOCK SIGNALS FROM TSI
 FRAME (SD-4A083-01)**





On Summary Data Printout [FIG. 1]:

1. Note monitor point address on first CD line under V1 column
2. Convert to decimal, octal failing bit in leftmost four octal digits of word under adjacent V2 column

In Test Access PK Document:

NOTE: Negative addresses, eg, 77771510 precede positive addresses in PK. If address is not found, other addresses and bits may be investigated using other V column pairs (first CD line or other CD lines). The PK data for these addresses will be further removed from the fault and PR data may be of greater value

3. Find address and failing bit
4. Note pack type and register (gate) name for failing bit

In Circuit Pack Schematic for Pack Type:

5. Locate component list section
- NOTE: If A or B appears after gate name in test access PK, it indicates A or B half of register (gate)
6. Look in each DESIG column for gate name
7. In adjacent SH LOC column use location indicated to find gate in Circuit Pack Schematic
8. At gate, note output lead name and terminal leaving the gate to outside the pack [FIG. 2]

In Test Access PK Document:

9. For failing bit, identify FS, SD, and symbol name

In SD FS indicated:

10. Locate symbol number having same symbol name as identify in Test Access PK for failing bit
11. Find lead interconnection section for this symbol
12. Using terminal and lead name noted in Step 8, find corresponding SD lead name

End of procedure

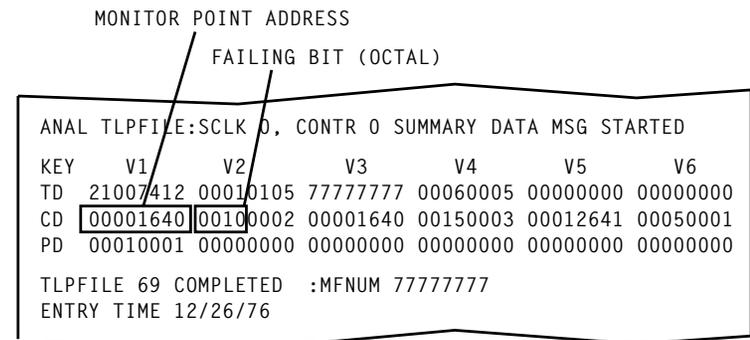


FIG. 1 - Example of Summary Data Printout

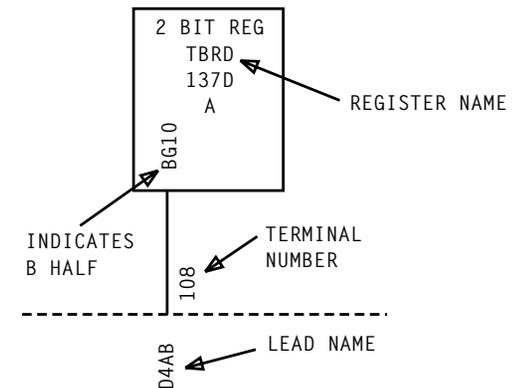


FIG. 2 - Example of lead leaving B half of a CPS register

IDENTIFY LEAD IN PATH OF FAILING BIT USING SUMMARY DATA PRINTOUT AND TEST ACCESS PK DOCUMENT

1. Define error using PMDs [TABLE A]

End of procedure

TABLE A

PMD-006	Fault isolated by TNFRISAD. PMD will indicate that one controller of suspect member failed access test. Controller which failed will be suspect controller	PMD-021	Fault isolated by TNFRTMMN. This is a matched or nonunique type error which occurred in both controllers. Retry was performed and failed; therefore, it is hard nonunique (AINT)
PMD-007	Fault isolated by TNFRISAD. PMD will indicate that both controllers failed access test. Each controller is assigned half weight indicating nonunique failure	PMD-050	Fault isolated by TNFRTMMN. Retry was performed and passed. This is a unique fault which is up in only one controller; therefore, it is transient unique (ASWF)
PMD-010	Fault isolated by TNFRTMMN. Retry was performed and passed. This is a unique fault which is up in only one controller; therefore, it is transient unique (AINT)	PMD-051	Fault isolated by TNFRTMMN. Retry was performed and failed. This is a unique fault which is up in only one controller; therefore, it is hard unique (ASWF)
PMD-011	Fault isolated by TNFRTMMN. Retry was performed and failed. This is a unique fault which is up in only one controller; therefore, it is hard unique (AINT)	PMD-052	Fault isolated by TNFRTMMN. This is a software type fault. This PMD indicates that software has caused a problem. Hardware is not suspected (ASWF)
PMD-012	Fault isolated by TNFRTMMN. Retry was performed and passed. This is a unique fault which is up in one controller only; therefore, it is transient unique (AINT)	PMD-053	Fault isolated by TNFRTMMN. Retry was performed and passed. This is a unique type fault which occurred in both controllers; therefore, it is transient nonunique (ASWF)
PMD-013	Fault isolated by TNFRTMMN. Retry was performed and failed. This is a unique fault which is up in one controller only; therefore, it is hard unique (AINT)	PMD-054	Fault isolated by TNFRTMMN. Retry was performed and failed. This is a unique type fault which occurred in both controllers
PMD-020	Fault isolated by TNFRTMMN. This is a matched or nonunique type error which occurred in both controllers. Retry was performed and passed; therefore, it is transient nonunique (AINT)	PMD-055	Fault isolated by TNFRTMMN. Retry was performed and passed. This is a match type fault which occurred in one controller only; therefore, it is transient unique (ASWF)
		PMD-056	Fault isolated by TNFRTMMN. Retry was performed and failed. This is a match type fault which occurred in one controller only; therefore, it is is hard unique (ASWF)

TABLE A (Contd)

<p>PMD-100 Fault isolated by TNFRTSMN. Fault type is unique class-1 transient (retry passed). Error will be PFE,PFO,MODEF,RTSMPF,TTSMPPF,BIMPPF, or ASWF in only one controller when unit is simplex or duplex; or an RTSMA,TT SMA, or BIMA in only one controller when unit is duplex (ASWF)</p> <p>PMD-101 Fault isolated by TNFRTSMN. Fault type is a unique class-1 hard (retry failed). Error will be PFE,PFO, MODEF,RTSMPF,TTSMPPF, BIMPPF, or ASWF in only one controller when unit is simplex or duplex; or RTSMA, TT SMA,or BIMA in only one controller when unit is duplex (ASWF)</p> <p>PMD-102 Fault isolated by TNFRTSMN. Fault type is unique soft. Error will be MODEF in both controllers or RTSMA,TT SMA, or BIMA in both controllers if unit is duplex; or up in the in-service controller if unit is simplex (ASWF)</p> <p>PMD-103 Fault isolated by TNFRTSMN. Fault type is unique transient (retry passed). Error is AMM,DWMM, or BIMWM in only one controller if unit is duplex; or up in the in-service controller if unit is simplex. BIMWM is not checked for CRTSI (ASWF)</p> <p>PMD-104 Fault isolated by TNFRTSMN. Fault type is unique class-3 hard (retry failed). Error is AMM,DWMM, or BIMWM in only one controller if unit is duplex; or up in the in-service controller if unit is simplex. BIMWM is not checked for CRTS1 (ASWF)</p> <p>PMD-105 Fault isolated by TNFRTSMN. Fault type is nonunique class-4 transient (retry passed). Error will be PFE,PFO,RTSMPF,TTSMPPF,BIMPPF, or ASWF in both controllers (ASWF)</p>	<p>PMD-106 Fault isolated by TNFRTSMN. Fault type is nonunique class-4 hard (retry failed). Error will be PFE, PFO,RTSMPF,TTSMPPF,BIMPPF, or ASWF in both controllers (ASWF)</p> <p>PMD-150 Fault isolated by TNFRTSMN. Fault type is unique class-1 transient (retry passed). Error up in AINT error source register may be AINT only or SSWF or any error which has secondary registers (RTMP,TTMP,BIMP, RSW, or BMAPF) where no errors are up in secondaries</p> <p>PMD-151 Fault isolated by TNFRTSMN. Fault type is unique class-1 hard (retry failed). Error up in AINT error source register may be AINT only or SSWF or any error which has secondary registers (RTMP,TTMP,BIMP,RSW, or BMAPF) where no errors are up in secondaries</p> <p>PMD-152 Fault isolated by TNFRSTMN. Fault type is unique class-2 transient (retry passed). Error in AINT error source register may be CE or TSSC in only one controller with errors up in secondary registers</p> <p>PMD-153 Fault isolated by TNFRTSMN. Fault type is unique class-2 hard (retry failed). Error in AINT error source register may be CE or TSSC in only one controller or RTMP,TTMP,BIMP,RSW,BMAPF, or TSW in only one controller with errors in secondary register</p> <p>PMD-160 Fault isolated by TNFRTSMN. Fault type is nonunique class-4 transient (retry passed – both controllers). Error in AINT error source register or sense and and lock register may be AINT only, CE,SSWF, or TSSC in both controllers or RIMP,TIMP,BIMP, or BMBPF in both controllers with errors up in secondaries</p>
--	--

TABLE A (Contd)

PMD-161 Fault isolated by TNFRTSMN. Fault type is nonunique class-4 hard (retry failed – either controller). Error in AINT error source register or sense and lock register may be AINT only, CE, SSWF, or TSSC in both controllers or RTMP,TTMP,BIMP, or BMBPF in both controllers with errors up in secondaries

PMD-170 Fault isolated by TNFRTSMN. Either a receive or transmit time slot memory parity failure has been detected in the AINT and/or SAL error source registers in only one controller. The error is partitionable and a retry of the failing controller has failed. The AUX data block provides the K-code of the suspect unit and the failing level. This is a class-2 hard fault

PMD-171 Fault isolated by TNFRTSMN. Either a receive or transmit time slot memory parity failure has been detected in the AINT and/or SAL error source registers in only one controller. The error is partitionable and a retry of the failing controller has passed. The AUX data block provides the K-code of the suspect unit and the failing level. This is a class-2 transient fault

PMD-172 Fault isolated by TNFRTSMN. A receive or transmit time slot memory parity failure has been detected in the AINT and/or SAL error source registers in both controllers. One or both of the controllers have failed the retry. The AUX data block provides the K-code of the suspect unit and the failing level. This is a class-4 hard failure

PMD-173 Fault isolated by TNFRTSMN. A receive or transmit time slot memory parity failure has been detected in the AINT and/or SAL error source registers in both controllers. Both of the controllers have passed the retry. The AUX data block provides the K-code of the suspect unit and the failing level. This is a class-4 transient failure

PMD-207 Fault isolated by TNFRTSMN. Fault is either TRPF, TMM, or TSW. The channel is busy to a time slot. In attempting to trace the call through the network, a mismatch in the TSM data was found in the RTSI. An RTMP error was then found in the RTSI AINT ESR. Suspect frame will be changed to RTSI and fault isolation reentered

PMD-210 Fault isolated by TNFRXMIT. Fault type is either TRPF, TMM, or TSW. A path was found back to RTSI. RTSI has some error source bits set. Suspect frame will be changed to RTSI and fault isolation reentered

PMD-211 Fault isolated by TNFRXMIT. Fault type is either TRPF, TMM, or TSW. Channel is busy to a time slot. In attempting to trace call through network, the network routine (NTRO) for one controller is incorrect. Fault is treated as unique error. AUX data block has more information

PMD-212 Fault isolated by TNFRXMIT. Fault type is either TRPF,TMM, or TSW. Channel is busy to a time slot. In attempting to trace call through network, TTSM memory did not have appropriate data. AUX data block has more information. Fault is treated as unique error

TABLE A (Contd)

PMD-213 Fault isolated by TNFRXMIT. Fault type is either TRPF,TMM, or TSW. Channel is busy to a time slot. In attempting to trace call through network, TTSM information from two controllers did not agree. Fault will be treated as nonunique error. AUX data block has more information

PMD-214 Fault isolated by TNFRXMIT. Fault type is either TRPF,TMM, or TSW. Channel is busy to a time slot. In attempting to trace call through network, one TMS controller failed to pass access test. AUX data block has information. This TMS controller will be treated as unique fault

PMD-215 Fault isolated by TNFRXMIT. Fault type is either TRPF,TMM, or TSW. Channel is busy to a time slot. In attempting to trace call through network, both TMS controllers failed to pass access test. Fault will be treated as nonunique TMS fault. AUX data block has more information

PMD-216 Fault isolated by TNFRXMIT. Fault type is either TRPF, TMM, or TSW. Channel is busy to a time slot. In attempting to trace call though network, mismatch in data stored in TSM memory was found. AUX data block has more information. Fault will be treated as TMS nonunique error

PMD-217 Fault isolated by TNFRXMIT. Fault type is either TRPF,TMM, or TSW. Channel is busy to a time slot. In attempting to trace call through network, cutoff or multiple path has been found in TMS. AUX data block has more information. Fault will be treated as software fault

PMD-220 Fault isolated by TNFRXMIT. Fault type is either TRPF,TMM, or TSW. Channel is busy to a time slot. In attempting to trace call through network, it was found RTSI duplex failed. AUX data block has more information. Fault will be treated by letting ERAT attempt to take out RTSI

PMD-221 Fault isolated by TNFRXMIT. Fault type is either TRPF,TMM, or TSW. Channel is busy to a time slot. In attempting to trace call through network, one RTSI controller failed access test. AUX data block has more information. Fault will be treated as unique RTSI fault

PMD-222 Fault isolated by TNFRXMIT. Fault type is either TRPF,TMM, or TSW. Channel is busy to a time slot. In attempting to trace call through network, both RTSI controllers failed access tests. More information in AUX data block. Fault will be treated as nonunique RTSI fault

PMD-223 Fault isolated by TNFRXMIT. Fault type is either TRPF,TMM, or TSW. Channel is busy to a time slot. In attempting to trace call through network, broken or multiple path found in or multiple path found in RTSI. AUX data block has more information. Fault will be treated as RTSI software fault

PMD-224 Fault isolated by TNFRXMIT. Fault type is either TRPF,TMM, or TSW. Channel is busy to time slot. In attempting to trace call through network, mismatch in TMS routing F/F was found. AUX data has more information. Fault will be treated as RTSI nonunique fault

TABLE A (Contd)

<p>PMD-225 Fault isolated by TNFRXMIT. Fault type is either TRPF, TMM, or TSW. Channel is busy to a time slot. In attempting to trace call through network, one TRSI controller has incorrect network routing. AUX data has more information. Fault will be treated as TRSI unique fault</p>	<p>PMD-232 Fault isolated by TNFRXMIT. Fault type is TMM or TSW error in both controllers but channel on which error occurred is not involved in network path. Therefore, fault is in this unit and is hard because retry failed. Fault may be in recorrelator or involve BUFC memory but cannot be isolated to unique controller</p>
<p>PMD-226 Fault isolated by TNFRXMIT. Fault type is either TRPF, TMM, or TSW. Channel is busy to a time slot. In attempting to trace call through network, mismatch in TSM data in RTSI was found. AUX data has more information. Fault will be treated as RTSI nonunique fault</p>	<p>PMD-233 Fault isolated by TNFRXMIT. Fault type is TMM or TSW error occurring in both controllers. Check of busy idle memory map bits against TS memory was run. Check found that suspect controller has mismatch between time slot memory information and BIMM information. Information not found in other controller. Therefore, BIMM or TTSM in suspect controller may be at fault</p>
<p>PMD-227 Fault isolated by TNFRMIT. Fault is either TRPF, TMM, or TSW. The channel is busy to a time slot. In attempting to trace the call through the network, a broken or multiple path was found in the RTSI. An RTMP error was then found in the RTSI AINT ESR. Suspect frame will be changed to the RTSI and fault isolation reentered</p>	<p>PMD-234 Fault isolated by TNFRXMIT. Fault type is TMM or TSW error occurring in both controllers. Check of busy idle memory map bits against TS memory was run. Check found mismatch in data between two controllers which is attributable to controller fault but cannot be further isolated to unique controller. BIMM or TTSM in one of two controllers is suspect</p>
<p>PMD-230 Fault isolated by TNFRXMIT. Fault type is TRPF, TMM, or TSW with no corresponding secondary ESR bits set. Fault is probably in indicated controller ESRS</p>	<p>PMD-235 Fault isolated by TNFRXMIT. Fault type is TMM or TSW error occurring in both controllers. Check of busy idle memory map bits against TS memory was run. Check has found data between controllers to match but BIMM data and TS data does not correlate. Therefore, error is probably result of software error</p>
<p>PMD-231 Fault isolated by TNFRXMIT. Fault type is TMM or TSW error in both controllers but channel on which error occurred is not involved in network path. Therefore, fault is in this unit but is transient because retry passed. Fault may be in recorrelator or involve BUFC memory but cannot be isolated to controller</p>	

TABLE A (Contd)

<p>PMD-236 Fault isolated by TNFRXMIT. Fault type is TMM or TSW error occurring in both controllers. Check of BIMM and TTSM information passed. Recorrelator tested and both controllers failed. Problem may be in cross controller matchers and will be treated as nonunique</p>	<p>PMD-251 Fault isolated by TNFRXMIT. Fault type is transient RSW (retry passed). Fault is probably not in TSI recording error, but in transmission subunit connected to interrupting ports. AUX data block has details of interrupting ports</p>
<p>PMD-237 Fault isolated by TNFRXMIT. Fault type is TMM or TSW error occurring in both controllers. Error of BIMM and TTSM information passed. Recorrelator tested and one controller failed. Fault is in recorrelator or associated circuits and will be treated as unique fault</p>	<p>PMD-300 Fault isolated by TNFRMMRT. Fault type is unique class-3 hard. Attempt to change state of BMA port pest has failed</p>
<p>PMD-240 Fault isolated by TNFRXMIT. Fault type is TMM or TSW error occurring in both controllers. Check of BIMM and TTSM information passed. Recorrelator tested and both controllers passed. Since failing channel is not involved in network path, no more testing can be done and fault must be in failing frame. Fault will be treated as nonunique</p>	<p>PMD-301 Fault isolated by TNFRMMRT. Fault type is unique class-3 hard. Attempt to change state of HFIS bit in hardware status register has failed</p>
<p>PMD-241 Fault isolated by TNFRXMIT. Fault type is either TRPF, TMM, or TSW. Path was found on failing time slot. Attempts made to isolate fault to one of six possible controllers by reconfiguring network routing. AUX data block has more information. Error was not isolated and must be considered nonunique. Final suspect list which is passed on to error analysis is found in AUX data block</p>	<p>PMD-302 Fault isolated by TNFRMMRT. Fault type is unique class-3 hard. Attempt to reset FS and FE bits of hardware status register has failed</p>
<p>PMD-250 Fault isolated by TNFRXMIT. Fault type is hard RSW (retry failed). Fault is probably not in TSI recording error but in transmission subunit connected to interrupting port. AUX data block has details of interrupting ports</p>	<p>PMD-303 Fault isolated by TNFRMMRT. Fault type is unique software error. Mismatch between controllers of data in critical register dump at time of interrupt. Either HFIS bit of hardware status word (for non-CRTSI only) or port pests do not match or software state and CREG value of port pests do not match</p>
	<p>PMD-304 Fault isolated by TNFRMMRT. Fault type is nonunique class-3 transient. RMM, BMAPF, or BMBPF BMBPF error not detected in SAL registers for either controller after both registers were cleared and unit was allowed to autonomously cycle</p>
	<p>PMD-305 Fault isolated by TNFRMMRT. Fault type is nonunique class-3 hard. Network connection from failing channel in BMA to maintenance channel in BMD made. Data received in BMD does not match data sent from BMA for both controllers</p>

TABLE A (Contd)

PMD-306	Fault isolated by TNFRMMRT. Fault type is unique class-3 hard. Network connection from failing channel in BMA to maintenance channel in BMD made. Data received in BMD does not match data sent from BMA for one controller	PMD-362	Fault isolated by TNFRTSMN. Fault type is nonunique class-4 transient (retry passed). Error is AMM in both controllers
PMD-307	Fault isolated by TNFRMMRT. Fault type is nonunique class-3 hard. Attempt to make connection across the network failed.	PMD-363	Fault isolated by TNFRTSMN. Fault type is nonunique class-4 hard (retry failed). Error is AMM in both controllers
PMD-310	Fault isolated by TNFRMMRT. Fault type is nonunique class-3 transient. Loop-around connection of network made. Data received in maintenance channel of BMD matches data sent through failing channel of BMA or both controllers	PMD-364	Fault isolated by TNFRTSMN. Fault type is nonunique class-4 transient (retry passed). Error is DWMM in both controllers
PMD-311	Fault isolated by TNFRMMRT. Fault type is nonunique class-3 transient. Loop-around connection of network made. Data received in maintenance channel of BMD does not match data sent through failing channel of BMA for both controllers	PMD-365	Fault isolated by TNFRTSMN. Fault type is nonunique class-4 hard (retry failed). Error is DWMM in both controllers
PMD-312	Fault isolated by TNFRMMRT. Fault type is unique class-3 hard. Loop-around connection of network has been made. Data received in maintenance channel of BMD does not match data sent through failing channel of BMA for one controller	PMD-366	Fault isolated by TNFRTMMN. Match type error which occurred in both controllers. (MWM) Retry performed and passed; therefore, it is transient nonunique (ASWF)
PMD-313	Fault isolated by TNFRMMRT. Fault type is nonunique class-3 hard. No test made. Attempt to make loop-around connection of network failed	PMD-367	Fault isolated by TNFRTMMN. Match type error which occurred in both controllers; (MWM) therefore, it is hard unique (ASWF)
PMD-360	Fault isolated by TNFRTSMN. Fault type is nonunique class-4 transient (retry passed). Error is BIMWM up in both controllers	PMD-370	Fault isolated by TNFRTMMN. Match type error which occurred in both controllers. (AMM) Retry performed and passed; therefore, it is transient nonunique (ASWF)
PMD-361	Fault isolated by TNFRTSMN. Fault type is nonunique class-4 hard transient (retry passed). Error is AMM in both controllers	PMD-371	Fault isolated by TNFRTMMN. Match type error which occurred in both controllers. (AMM) Retry performed and failed; therefore, it is hard nonunique (ASWF)

1. See FIG. 1 and EXAMPLE 1. Check contents of CREG 3
 2. Convert octal data to binary
 3. Regroup bits 7-13 starting at bit 7 and grouping from right to left
 4. Convert binary bits back to octal. This is the memory number
- End of procedure

TMSP CRITICAL REGISTERS						CREG3 (CONTR 0)
00000034	03011434	00000002	03331420	00076602	00001005	
00000037	55555555	55555555	55555555	55555555	55555555	
00010021	00000000	00000000	<u>00000000</u>	00077177	00000000	
			↑			CREG 3 (CONTR 1)

FIG. 1 - TMS ESR+1 Register

ESR+1 DATA	0			3			3			3			1		4		2		0						
BINARY	23	22	21	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	
	0	0	0	0	1	1	0	1	1	0	1	1	0	0	1	1	0	0	0	0	1	0	0	0	0
	REGROUPED										1	1	0	0	1	1	0								
	RECONVERTED OCTAL VALUE										*														
											1	4			6										

* INDICATES BAY (0 OR 1)

EXAMPLE 1 - Determine Memory Number

IDENTIFY SUSPECT MEMORY AND MEMORY REGISTER CIRCUIT PACKS, TIME MULTIPLEXED SWITCHING

Reissued

Issue 6	JAN 1997
234-151-011	DLP
PAGE 1 of 1	520

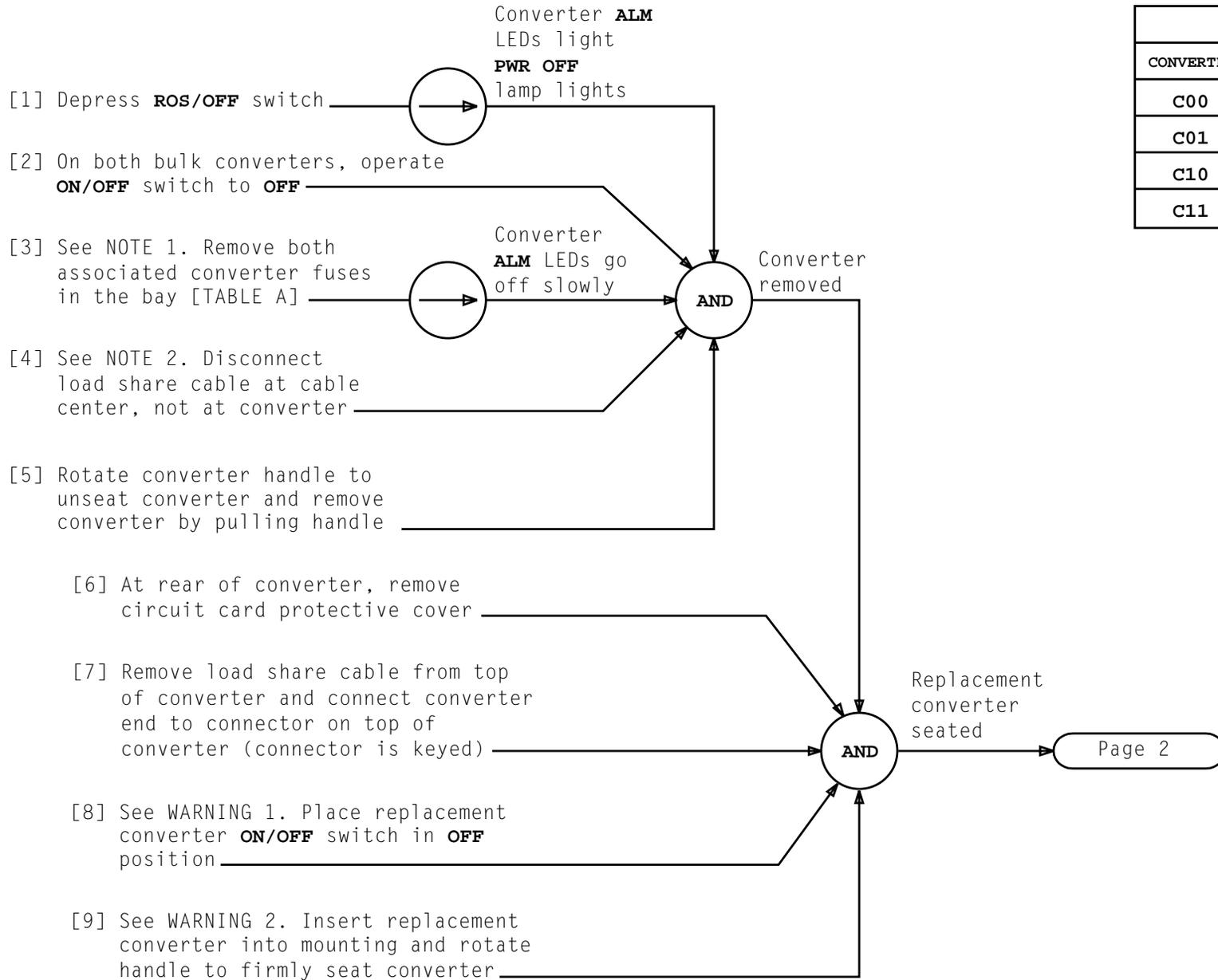


TABLE A			
CONVERTER	LOCATION	FUSE	LOCATION
C00	014-12	A0A	007-13
C01	014-60	A0B	007-13
C10	114-12	A1A	107-13
C11	114-60	A1B	107-13

NOTES

1. Allow converter **ALM** LEDs to go off completely before proceeding
2. Load share cable should be returned with defective converter

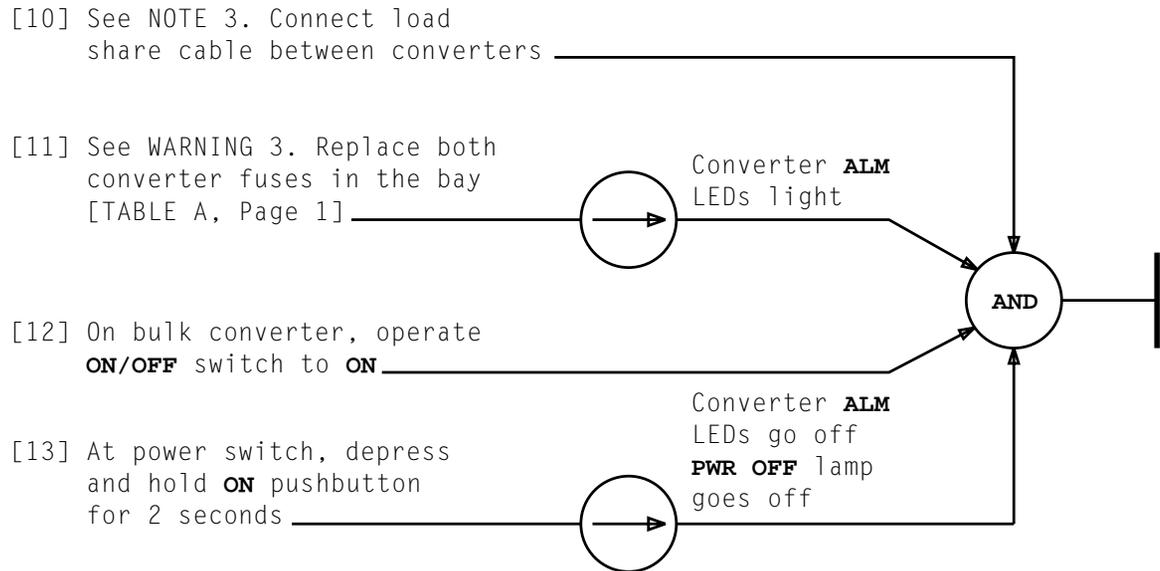
WARNINGS

1. Failure to have **ON/OFF** switch in **OFF** position could result in damage to unit
2. Improper seating of unit may cause damage to connector

Reissued

Issue 6	JAN 1997
234-151-011	DLP
PAGE 1 of 2	521

REPLACE BULK CONVERTER (245C WITH 245C)



NOTE 3
245C converters will not start unless load share cable is connected

*WARNING 3
Current surge could damage converters if fuses are not replaced before turning converter ON/OFF switches to ON*

Reissued

Issue 6	JAN 1997
234-151-011	DLP
PAGE 2 of 2	521

REPLACE BULK CONVERTER (245C WITH 245C)

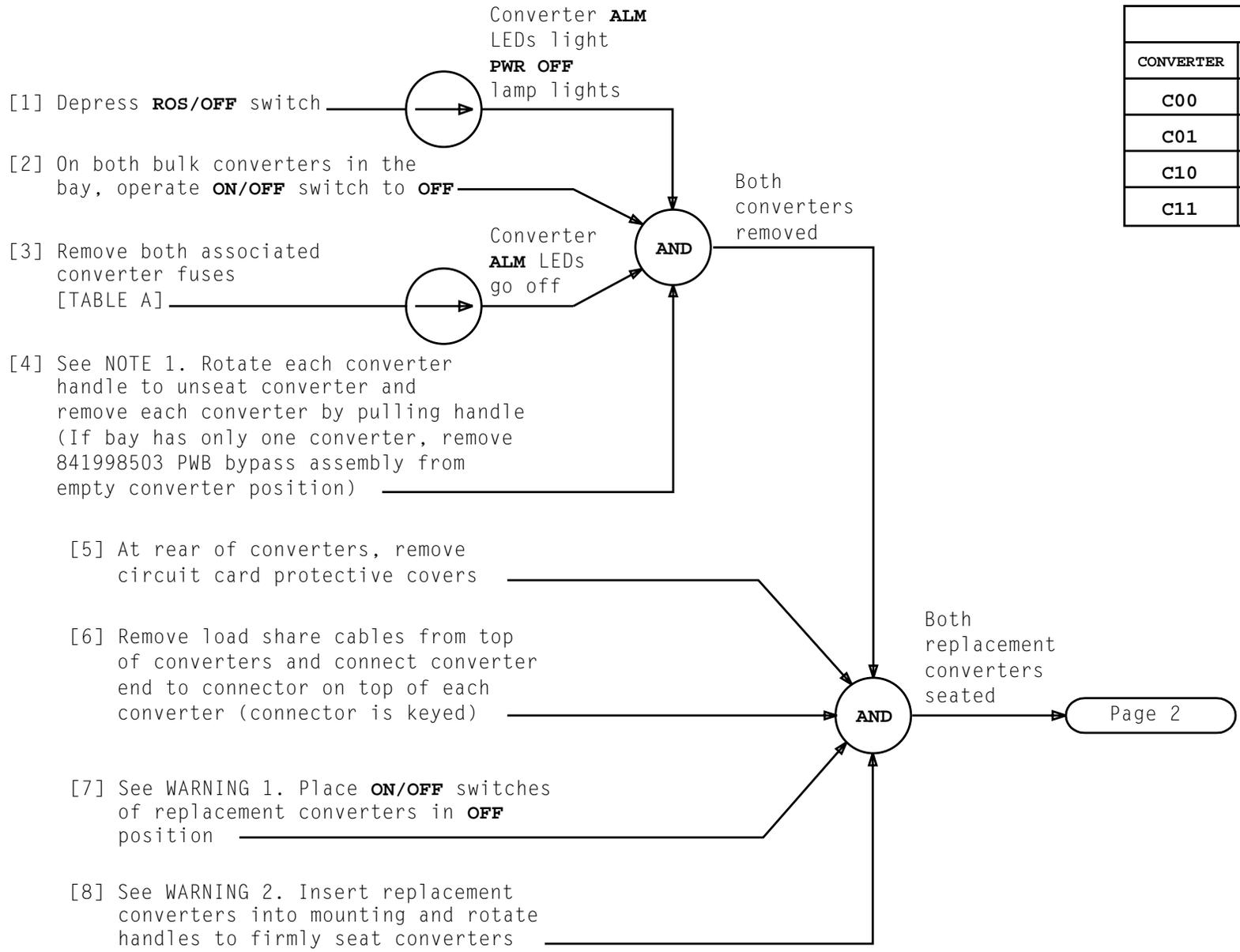


TABLE A			
CONVERTER	LOCATION	FUSE	LOCATION
C00	014-12	A0A	007-13
C01	014-60	A0B	007-13
C10	114-12	A1A	107-13
C11	114-60	A1B	107-13

NOTE 1
245A and 245C converters cannot be mixed in the same bay of a TMS

WARNINGS

1. Failure to have ON/OFF switch in OFF position could result in damage to unit
2. Improper seating of unit may cause damage to connector

Reissued

Issue 6	JAN 1997
234-151-011	DLP
PAGE 1 of 2	522

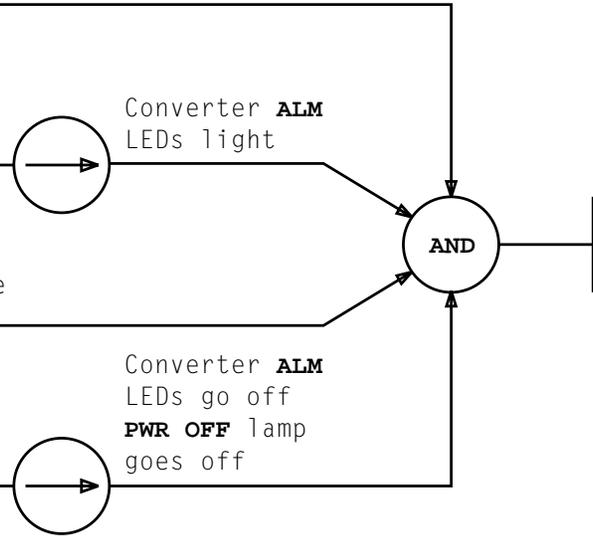
REPLACE BULK CONVERTER (245A WITH 245C)

[9] See NOTE 2. Connect load share cable between converters

[10] See WARNING 3 and NOTE 3.
Replace both converter fuses
[TABLE A, Page 1]

[11] On both bulk converters, operate
ON/OFF switches to **ON**

[12] At power switch, depress
and hold **ON** pushbutton
for 2 seconds



NOTES

- 2. 245C converters will not start unless load share cable is connected
- 3. If bay had only one converter to begin with, one fuse was a "dummy" and must be replaced with a fuse of the same type as the line fuse

WARNING 3

*Current surge could damage converters if fuses are not replaced before turning converter **ON/OFF** switches to **ON***

Reissued

Issue 6	JAN 1997
234-151-011	DLP
PAGE 2 of 2	522

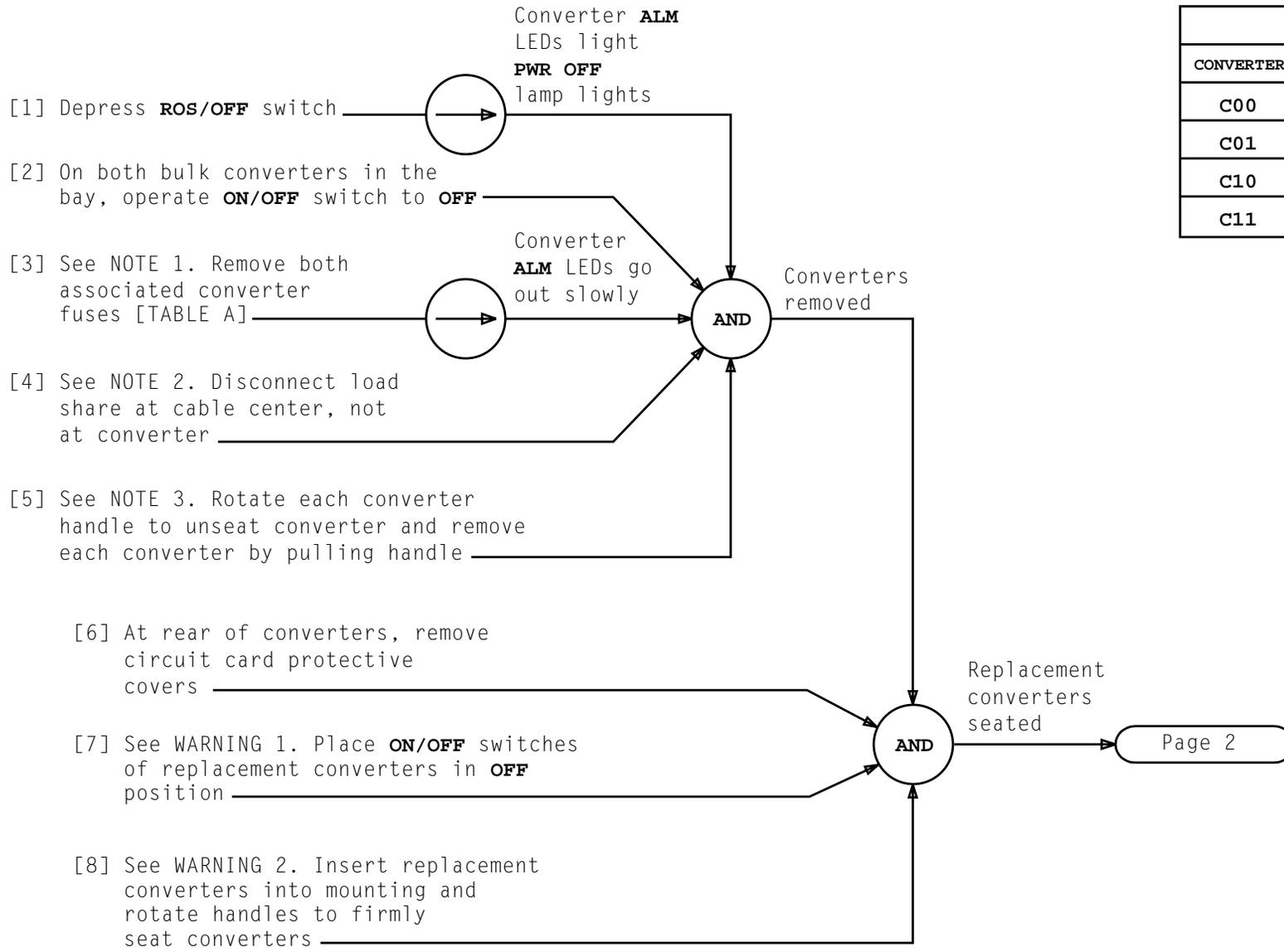


TABLE A			
CONVERTER	LOCATION	FUSE	LOCATION
C00	014-12	A0A	007-13
C01	014-60	A0B	007-13
C10	114-12	A1A	107-13
C11	114-60	A1B	107-13

- NOTES
1. Allow converter **ALM** LEDs to go off completely before proceeding
 2. Load share cable should be returned with defective converter
 3. 245A and 245C converters cannot be mixed in the same bay of a TMS

- WARNINGS
1. Failure to have **ON/OFF** switch in **OFF** position could result in damage to unit
 2. Improper seating of unit may cause damage to connector

Reissued

Issue 6	JAN 1997
234-151-011	DLP
PAGE 1 of 2	523

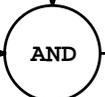
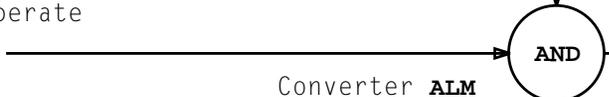
REPLACE BULK CONVERTER (245C WITH 245A)

[9] See WARNING 3. Replace both converter fuses in the bay [TABLE A, Page 1]

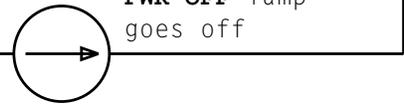


Converter **ALM** LEDs light

[10] On bulk converters, operate **ON/OFF** switches to **ON**



[11] At power switch, depress and hold **ON** pushbutton for 2 seconds



Converter **ALM** LEDs go off
PWR OFF lamp goes off

REPLACE BULK CONVERTER (245C WITH 245A)

*WARNING 3
Current surge could damage converters if fuses are not replaced before turning converter **ON/OFF** switches to ON*

Reissued

Issue 6	JAN 1997
234-151-011	DLP
PAGE 2 of 2	523

SUMMARY

If the office has no spare capacitors or diodes available Do Not execute this procedure, and notify next level of support per local practice. Prior to performing this procedure technician must procure materials to perform

this replacement procedure: stencil kit, digital VOM, plastic/rubber sheets or equivalent insulating material, electrical tape, screwdrivers (standard and *Phillips**), needlenose pliers, trouble light, soldering iron, markers for leads, SD-4A087-01 and solder.

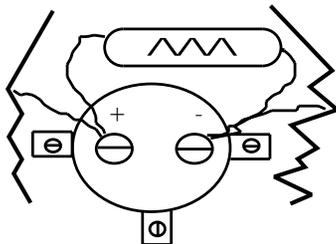
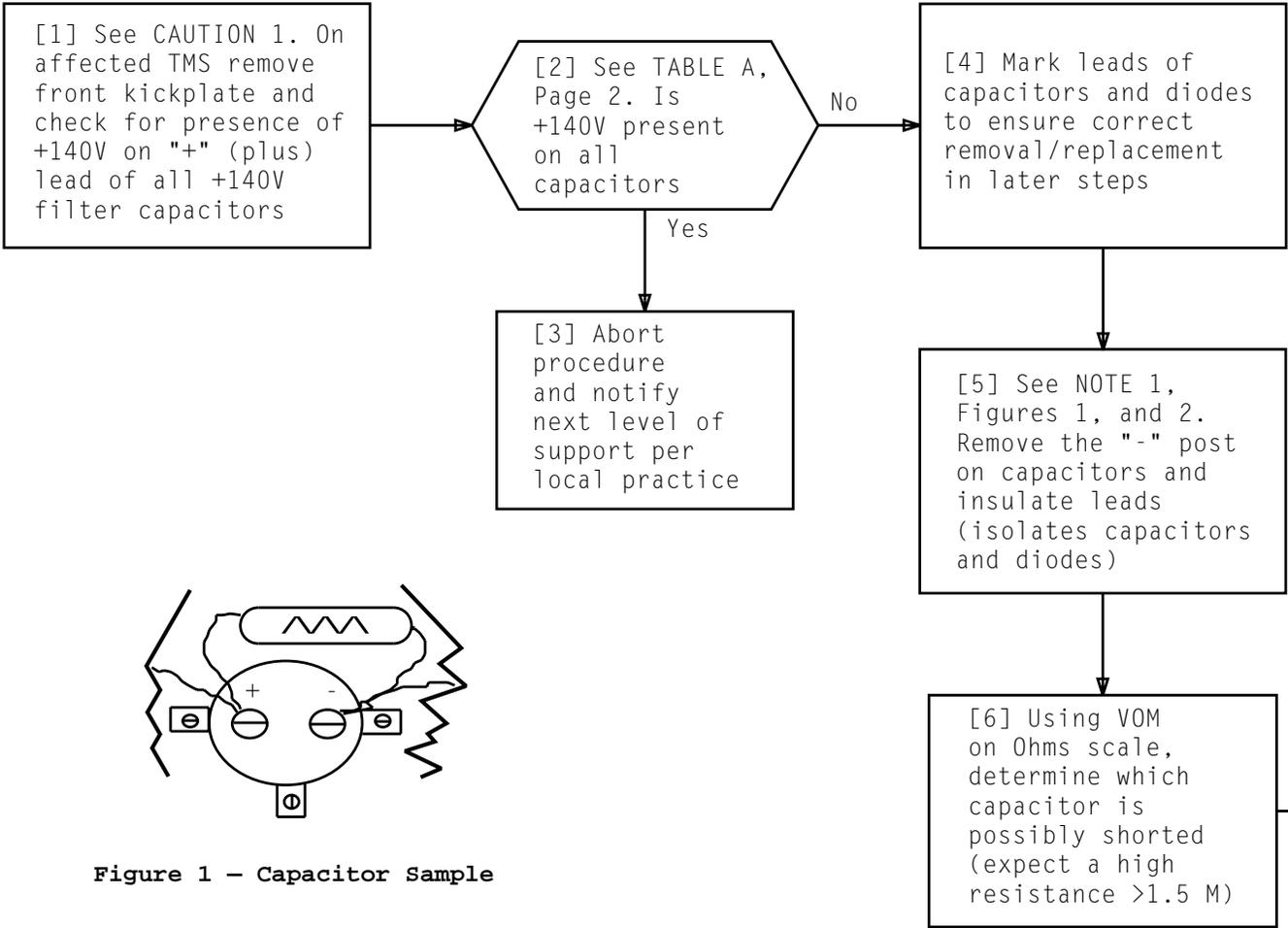


Figure 1 - Capacitor Sample

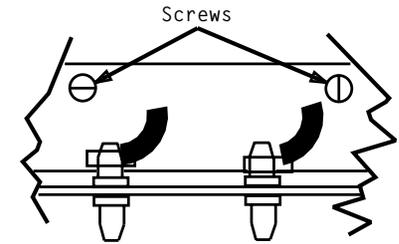


Figure 2 - Diode Sample

NOTE 1
A 12-inch standard screwdriver with insulation from handle to blade should be used to prevent shorting

CAUTION 1
Other components use +24V, caution must be taken to avoid shorting of surrounding circuitry

Issue 6	JAN 1997
234-151-011	DLP
PAGE 1 of 5	524

* Trademark of Phillips Screw Company

Added

REPLACE FILTER CAPACITOR AND DIODE TIME MULTIPLEX SWITCHING (TMS) FRAME

[7] See CAUTION 1. Install insulating material around unit filter capacitor area for protection of components using various voltages

TABLE A			
Capacitor	Location	Diode	Location
C1	x02-17	CR3	x07-17RA
C3	x02-35	CR4	x07-21RA
x = 0 or 1 depending on controller			

[8] See NOTE 2 and TABLE A. Is there a shorted Cap

No

[14] Using VOM, determine which diode is bad (expected ohms, 100K or open, depending on VOM polarity)

No

[16] Abort procedure and notify next level of support per local practice

Yes

[9] Mark polarity of leads to ensure removal or proper replacement

[15] See NOTE 2. Is there a bad diode

Yes

[17] Mark polarity of leads to ensure removal or proper replacement

Page 3, Step 22

[10] See NOTE 1, CAUTION, and Figure 1. Remove "+" lead from Capacitor and insulate

[11] Note orientation of capacitor and remove three screws holding Capacitor mounting ring

[12] Carefully pull Capacitor out to position for taking off unit mounting ring

[13] Remove screw from mounting ring and remove defective capacitor

Page 3

Added

NOTE 2
Regardless of which filter circuit-component is defective, the associated diode or capacitor must be replaced to prevent further circuit damage or failure. Use SD-4A087-01 for component association

CAUTION
Other components use +24V, caution must be taken to avoid shorting of surrounding circuitry

Issue 6	JAN 1997
234-151-011	DLP
PAGE 2 of 5	524

**REPLACE FILTER CAPACITOR AND DIODE
TIME MULTIPLEX SWITCHING (TMS) FRAME**

[18] Stamp proper identification on new capacitor being installed

[19] Properly orient new capacitor and secure in unit mounting ring

[20] Carefully place new capacitor in frame and replace three mounting ring screws

[21] Reconnect leads and resistor to Capacitor and ensure polarity as observed earlier

[22] At rear of TMS frame place insulation material around working area

[23] See Figure 3 and Table A, page 2, remove screws from diode mounting plate and carefully pull plate away from frame

[24] Mark leads of associated or defective diode and note polarities if not done in step 4, page 1

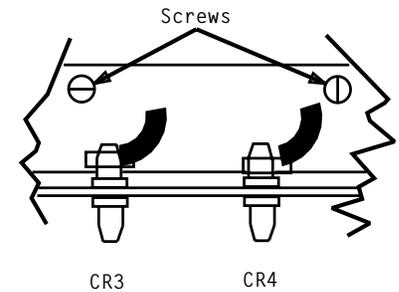
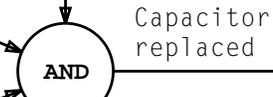
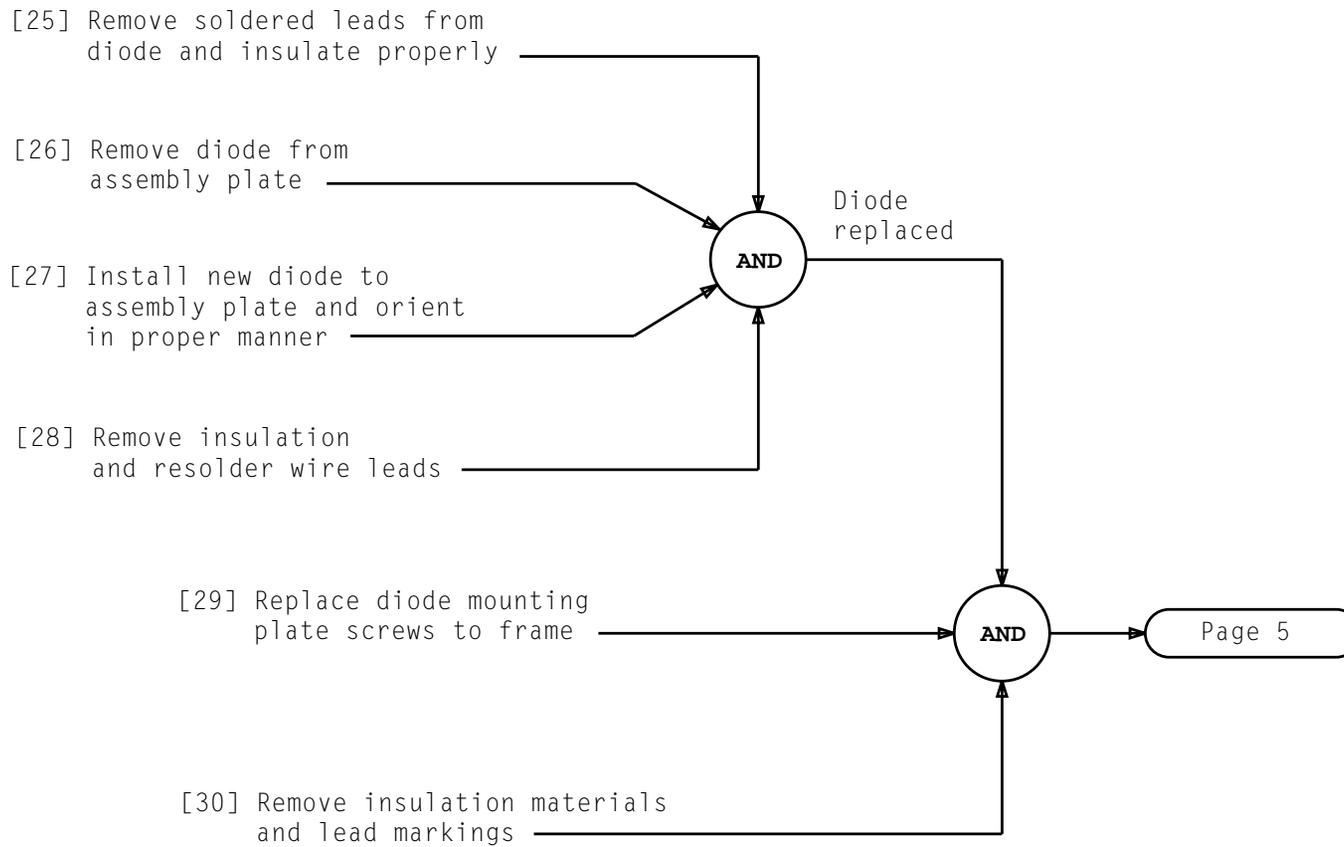


Figure 3 - Diode Sample

REPLACE FILTER CAPACITOR AND DIODE TIME MULTIPLEX SWITCHING (TMS) FRAME

Added

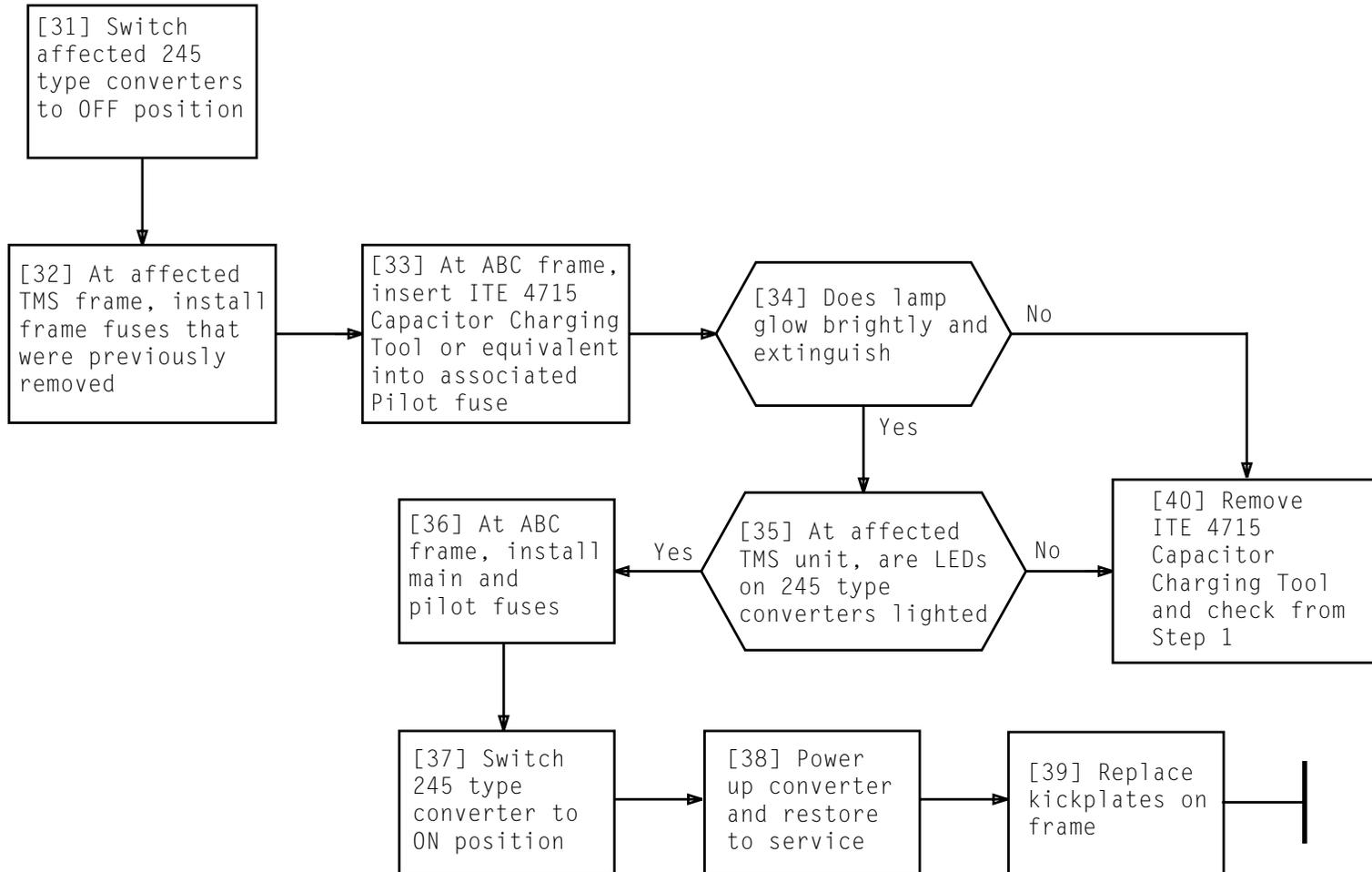
Issue 6	JAN 1997
234-151-011	DLP
PAGE 3 of 5	524



**REPLACE FILTER CAPACITOR AND DIODE
TIME MULTIPLEX SWITCHING (TMS) FRAME**

Added

Issue 6	JAN 1997
234-151-011	DLP
PAGE 4 of 5	524



**REPLACE FILTER CAPACITOR AND DIODE
TIME MULTIPLEX SWITCHING (TMS) FRAME**

Added

Issue 6	JAN 1997
234-151-011	DLP
PAGE 5 of 5	524

ITEM	ISSUE	ITEM	ISSUE	ITEM	ISSUE	ITEM	ISSUE	ITEM	ISSUE	ITEM	ISSUE
TPG-000		TAP-127									
• IXL-001		TAP-128									
NTP-002		TAP-129									
NTP-003		<input type="checkbox"/> TAP-130									
NTP-004		<input type="checkbox"/> TAP-131									
NTP-005		<input type="checkbox"/> TAD-132									
NTP-006		<input type="checkbox"/> TAP-133									
NTP-007		• TAP-134									
• TAD-100		DLP-500									
TAP-101		DLP-501									
TAP-102		DLP-502									
• TAP-103		DLP-503									
ISD-104		DLP-504									
ISD-105		DLP-505									
ISD-106		DLP-506									
TAP-107		DLP-507									
TAP-108		DLP-508									
TAP-109		DLP-509									
TAP-110		DLP-510									
ISD-111		• DLP-511									
TAP-112		DLP-512									
ISD-113		DLP-513									
TAP-114		DLP-514									
ISD-115		DLP-515									
TAP-116		DLP-516									
ISD-117		DLP-517									
TAP-118		DLP-518									
ISD-119		DLP-519									
TAP-120		DLP-520									
TAD-121		DLP-521									
TAP-122		DLP-522									
TAP-123		DLP-523									
TAP-124		• DLP-524									
TAP-125		• CKL-891									
ISD-126		TNG-893									

• REVISED OR ADDED ITEM

CANCELED ITEM

Issue 6 | JAN 1997

Revised

234-151-011

CKL

PAGE 1 of 1

891

CHECKLIST